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Date

DEVELOPMENT OF AN AUTOMATED TESTING AND CALIBRATION  
SOFTWARE PACKAGE FOR THE NIFFTE TPC PROJECT

by

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To the Graduate Faculty:

The members of the committee appointed to examine the thesis of BRYCEN WENDT find it satisfactory and recommend that it be accepted.

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Eric Burgett  
Major Advisor

---

Tony Hill  
Committee Member

---

David Beard  
Graduate Faculty Representative

For Tanya



warm boundless Love  
life, laughter, devotion, tears  
Mother, Wife, my all



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# List of Acronyms

ADC	analog to digital converter	xiii, 4, 5, 15, 82, 107
API	application programming interface	43–46, 58, 64, 73, 109
ASIC	application-specific integrated circuit	4
BNC	Bayonet Neill-Concelman	xiii, 9, 10, 12, 14, 36
CPU	central processing unit	63
CRTP	curiously recurring template pattern	45–47, 62–64
CSV	comma separated value	41, 72
DAQ	digital acquisition	xiii, 2, 11, 24, 90
DBB	digital bus board	11
DOE	Department of Energy	v, 90, 126
EMI	electromagnetic interference	9, 11
FPGA	field-programmable gate array	5, 36
GUI	graphical user interface	13, 19, 24, 43, 44, 48, 73, 94
ID	identification	30, 31, 40
IDE	integrated development environment	18
IP	internet protocol	24, 27, 94
ISU	Idaho State University	i, ii, 10
IUP	Integrated University Program	126
LANL	Los Alamos National Laboratory	13, 16
LED	light-emitting diode	27
LLNL	Lawrence Livermore National Laboratory	9, 18
MAC	media access control	20, 24, 94
NEUP	Nuclear Energy University Program	v

NIFFTE	Neutron Induced Fission Fragment Tracking Experiment	ii, v, xiii, xvi, 3–5, 7, 14, 42, 60, 86, 89, 90
NIST	National Institute of Standards and Technology	90
OOP	object-oriented programming	43–45
PCB	printed circuit board	xiv, 5, 6
POST	power-on self test	20
RC	resistor-capacitor	68, 69, 75–78
RMS	residual mean square	70
SDK	software development kit	27, 28
SN	serial number	30, 31, 40
SQL	structured query language	89
SRS	Stanford Research Systems	10, 13, 27, 103, 104
STL	standard template library	xv
SVN	Apache Subversion	24, 108
TPC	time projection chamber	ii, xiii, xvi, 2–8, 10–12, 14, 20, 65, 86, 87, 89, 90
TTL	transistor-transistor logic	36
URL	uniform resource locator	94
USB	universal serial bus	27

# Glossary

**.dll** a file containing a shared library of compiled functions which can be loaded and used by an external process

**bank** 1 a BNC connector on the front of the test stand box 2 a bar on the distribution board that splits a pulse into eight separate signals

**bit** the smallest unit of information in a computer, represented by either 0 or 1

**C** a general-purpose programming language developed by Dennis Ritchie at AT&T Bell Labs

**channel** 1 a single charge collection unit in the NIFFTE TPC 2 an isolated amplification circuit on a preamp card, usually connected to a NIFFTE TPC channel

**code** (*see* source code)

**const** a C++ keyword that results in unchanging behavior in the context to which it is applied, usually used to declare fixed-value data member; the website <http://duramecho.com/ComputerInformation/WhyHowCppConst.html> extensively documents the multiple meanings and contexts of use

**C++** a derivative language of C that provides object-oriented and generic programming features

**E/p** EtherDAQ/preamp, i.e. a combined unit containing one EtherDAQ card and one preamp

**EtherDAQ** a term, unique to the NIFFTE collaboration, that means Ethernet digital acquisition (*usually* EtherDAQ card)

**Ethernet** a system for connecting a number of computer systems to form a local area network, with protocols to control the passing of information while avoiding simultaneous transmission by two or more systems

**gain** the quotient of a pulse's voltage amplitude under the corresponding waveform's extracted ADC charge parameter

**H(n,n)H** a purely elastic reaction between a hydrogen nucleus (i.e. a proton) and a neutron

**managed** code that contains extended features, such as security and memory management, which are 'managed' by an additional runtime component that runs transparently in the background (*compare* unmanaged)

**mask** an ordered sequence of bits that are used to toggle on or off entities or actions mapped against the individual bit positions

**measurand** a quantity of interest that is not measured directly, but determined from other actually measured quantities

**mezzanine board** a PCB used simply as a bridge or link between two separate electronic components, often PCBs themselves

**NaN** not a number, a floating-point representation of an undefined value

**packet** a segment of data sent from one network device to another

**pedestal** the flat front-half of a waveform that contains the low data points (*compare* plateau)

**phase** a step of the testing procedure characterized by pulses sent to the test stand input banks in a specific temporal order

**plateau** the sloped back-half of a waveform that contains the high data points (*compare* pedestal)

**Pu<sup>239</sup>** Plutonium 239

**pulse** a voltage signal produced by the pulse generator

**rise** (*see* transition)

**signed** a computer variable that allows number representation in both the positive and negative ranges (*compare* unsigned)

**source** (*see* source code)

**source code** human readable instructions that are translated by a compiler, interpreter, or assembler into object code which can be executed on a computer (*also* code, source)

**subphase** a part of a phase, characterized as a unique group of pulses with a consistent voltage amplitude

**thread** a small sequence of programmed instructions that can be managed independently, but shares the resources of the parent process

**transition** the central portion of a waveform that contains the transition from the pedestal to the plateau (*also* rise)

**unmanaged** code that is compiled directly into machine instructions, enabling faster operation but at the expense of extended features such as security and memory management (*compare* managed)

**unsigned** a computer variable that allows only positive number representation (*compare* signed)

**U<sup>235</sup>** Uranium 235

**U<sup>238</sup>** Uranium 238

**vector** a dynamic array class, part of the the C++ STL

**Visual C#** an object-oriented programming language, developed by Microsoft as one of the .NET Framework languages, that aims to combine the computing power of C++ with the programming ease of Visual Basic

**waveform** the digital representation of a pulse

## **Abstract**

The NIFFTE collaboration seeks to make nuclear data measurements with uncertainties below 1.0% using a time projection chamber (TPC). To achieve this goal, each of the 5952 signal collection and processing channels of the TPC must be routinely calibrated. The calibration constants are fundamental to the TPC data collection effort. The TPC channels are distributed amongst 192 32-channel cards specifically designed for the challenges of the project.

A diagnostic platform has been developed to interrogate the 32-channel cards over their full dynamic range by leveraging existing software, originally designed as a testing interface during card development, and enhancing the functionality to provide an appropriate data collection platform.

An independent analysis framework was implemented to provide the infrastructure required to carry out bulk calibration analyses of the vast amount of channel-by-channel calibration data collected.

# Chapter 1

## Introduction

### 1.1 Background [1]

Reactors, weapons, and nucleosynthesis calculations are all dependent on nuclear physics for cross sections and particle kinematics. These applications are very sensitive to the nuclear physics in the fast neutron energy region and, therefore, have overlaps in nuclear data needs. Computer codes interface to nuclear data through nuclear data libraries, which are a culmination of experimental results and nuclear theory and modeling. Uncertainties in the data contained in these libraries propagate into uncertainties in calculated performance parameters.

The impact of nuclear data uncertainties has been studied in detail for reactor and weapon systems, and sensitivity codes have subsequently been developed that provide nuclear data accuracy requirements. Sensitivity studies have provided specific requirements for uncertainties on many fission cross sections, many of which are beyond the reach of current experimental tools.

The proposed method to obtain high-accuracy precision fission measurements is to employ a TPC<sup>1</sup> and perform neutron energy dependent fission cross measurements relative to H(n,n)H elastic scattering. The TPC is the perfect tool for minimizing most of the systematic errors associated with fission measurements—the technology that has been in use in high-energy physics for over two decades—but must be optimized for the task. This includes miniaturization, design for hydrogen gas, and large dynamic range electronics.

The fission TPC is specifically engineered for delivering fission cross section measurements with uncertainties below 1.0%. The result of these new measurements will be a refined understanding of computational results, thus reducing the liability from nuclear data in the overall uncertainties of calculated integral quantities. Measuring fission cross sections relative to H(n,n)H elastic scattering removes the uncertainties associated with using the U<sup>235</sup> fission cross section for normalization; a primary goal is to provide the world’s best differential measurement of the U<sup>235</sup> fission cross section. This will impact nearly all fission library data, since the U<sup>235</sup> fission cross section has been used as a standard in much of the available experimental fission data.

The fission TPC design contains nearly 6000 charge collection pads for recording the events inside the detection volume. The charge signals are individually amplified and converted to a digital waveform representation for later event reconstruction and data analysis. This amplification and digitization is performed by two paired cards, shown in fig. 1.1. The right board serves to amplify the charge signals, while the left digitizes and transmits the signals to the DAQ<sup>2</sup> system. These cards are known respectively as a preamp and EtherDAQ card, and together are

---

<sup>1</sup>time projection chamber

<sup>2</sup>digital acquisition



**Figure 1.1** – EtherDAQ/Preamp Card Pair

referred to as a E/p pair. A fully-instrumented TPC contains 192 E/p card pairs. Each E/p pair is instrumented with 32 channels, with one channel providing the readout for a single charge collection pad. Every channel needs to be individually and repeatedly calibrated in order to achieve the measurement goals.

This work describes the approach at developing a framework for performing the required calibration measurements. Existing equipment and software were modified to create a platform for sending charge signals to an E/p card pair, performing an initial health evaluation, and recording the results. A new framework was developed for performing advanced analyses on the calibration data. The framework was demonstrated to be capable of the detailed analyses required for generating the calibration constants needed for the TPC data reconstruction efforts.

## 1.2 The Fission TPC Project

The effort for ultra-precise nuclear data measurements is coordinated under the NIFFTE<sup>3</sup> collaboration.<sup>4</sup> The immediate objective of this effort is to implement a fission cross section measurement program with the goal of providing the most

---

<sup>3</sup>Neutron Induced Fission Fragment Tracking Experiment

<sup>4</sup>NIFFTE Collaboration homepage: <http://nuclear.calpoly.edu/~niffte/>

needed measurements with unprecedented precision and accuracy using a TPC. The current focus is on generating precision  $\text{Pu}^{239}/\text{U}^{235}$  and  $\text{U}^{238}/\text{U}^{235}$  fission ratio measurements.

The  $\text{U}^{235}/\text{H}(n,n)\text{H}$  measurement will provide the best single measurement of the  $\text{U}^{235}$  fission cross section and will allow the NIFFTE collaboration to convert the initial, and any subsequent, ratio experiments to the world's best absolute measurements. After completion of the  $\text{U}^{235}$  and  $\text{Pu}^{239}$  ratio measurements, the collaboration will move on to other measurements, such as minor actinide cross sections and fission fragment distribution. This information will play a crucial role in current and future nuclear research and development campaigns.

### 1.3 The TPC Signal Processing System [2]

The NIFFTE TPC, shown in fig. 1.2, operates under the same principles as an ionization chamber. It consists of a target placed between two pressure chambers, each known as a volume, resulting in  $4\pi$  detection capabilities.

Each volume is instrumented at the far end by a pad plane that contains 2976 hexagonal charge collection pads. Each charge collection pad is instrumented by an E/p channel. Figure 1.3 shows the pad plane layout; each plane is split into sextants, each sextant into sixteen sectors, and each sector into 32 pads.<sup>5</sup>

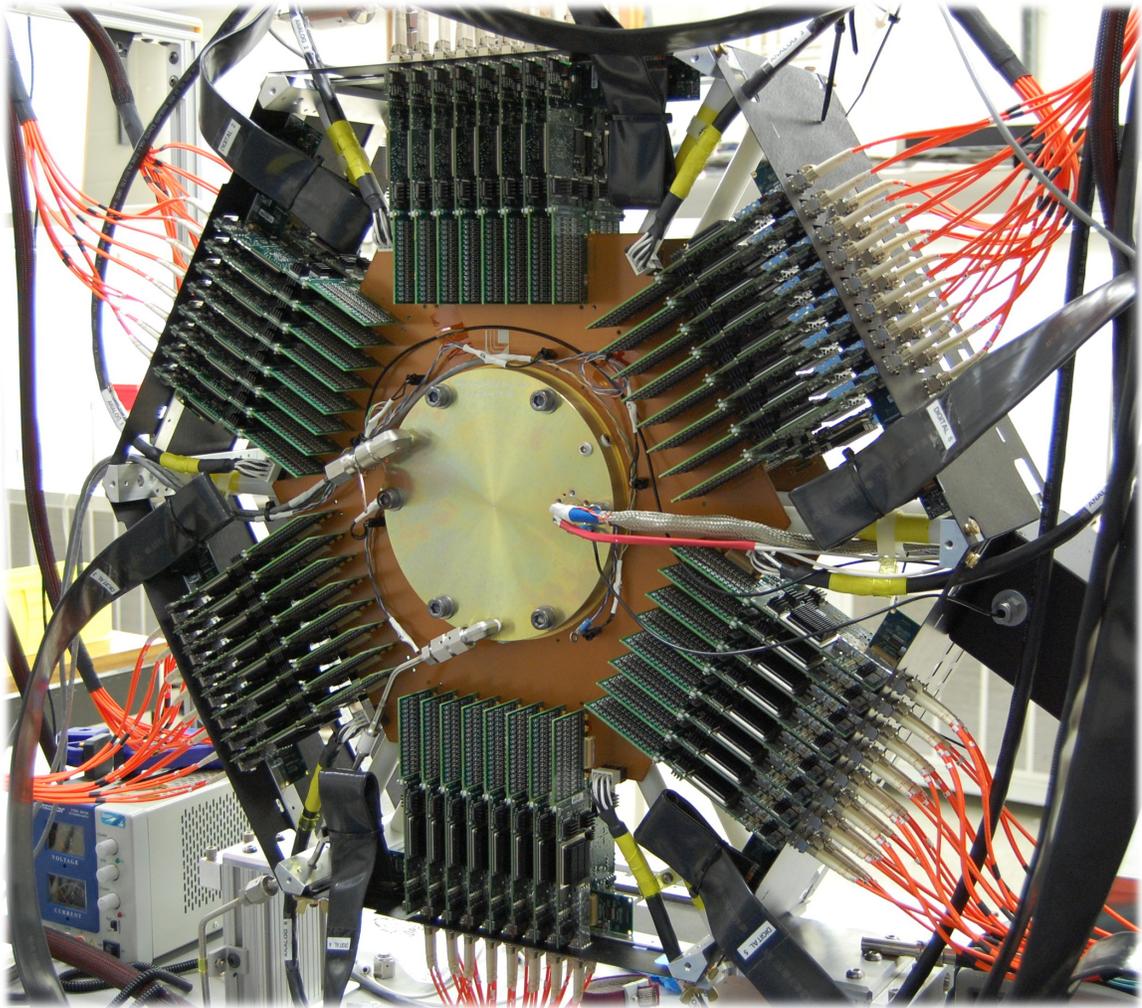
Each channel is instrumented with a preamplifier, an ADC,<sup>6</sup> and a digital readout. The challenge of accommodating a large number of densely packed high-speed channels has been met in the past with relatively expensive custom ASIC<sup>7</sup> chips.

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<sup>5</sup>The four triangular sectors on the outside edge of each sextant are instrumented with only 28 pads, which is why the total number of pads for each side is not 3072

<sup>6</sup>analog to digital converter

<sup>7</sup>application-specific integrated circuit



**Figure 1.2** – The NIFFTE TPC with One Instrumented Volume

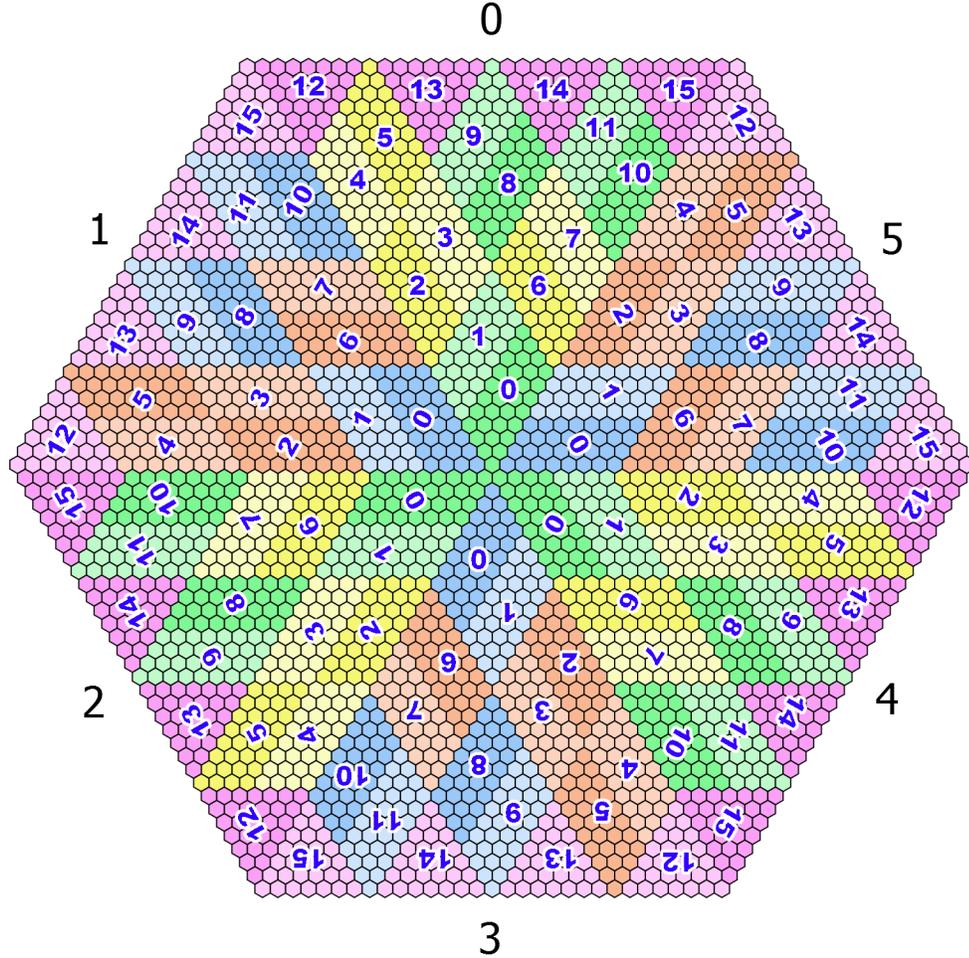
The technology for ADC and FPGA<sup>8</sup> type devices has improved considerably over the last decade. It is now possible to use off-the-shelf components to accomplish the same task for considerably less development cost, less time to working prototypes, and considerably more flexibility in the final design.

This, combined with PCB<sup>9</sup> manufacturing advancements, has made small-budget custom electronics a viable option. The solution for the NIFFTE TPC was to

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<sup>8</sup>field-programmable gate array

<sup>9</sup>printed circuit board



**Figure 1.3** – Pad Plane Layout

create two PCBs intended to be paired together. These are called: 1) the EtherDAQ card, and 2) the preamp card. The actual design and performance of each are detailed elsewhere [3]. The  $E/p$  pairs can be identified in fig. 1.2 as the green PCBs arranged around the outer edge of the TPC. The orange cables contain the fiber optics for data transmission.

The card pairings are intended to be permanent, which insures that valid calibration measurements are maintained even between different TPC configurations. Each TPC contains 192  $E/p$  pairs. The primary goal for low data uncertainties requires a very high measurement fidelity. Each card pairing must be individually

tested to ensure it meets the necessary quality requirements. Acceptance criteria will require information regarding the number of dead or noisy channels, the level of crosstalk and the gain linearity

Additionally, minor variations naturally exist in the electronic components between each channel. Thus, each channel must be individually calibrated—a nontrivial task for such a large number of channels. Routine inspection for time-dependent performance is also required. Furthermore, the card pairs are subject to failure due to experimental conditions and are occasionally replaced with fresh counterparts. The individual testing and calibration of each card pair is ill-suited for a manual process due to large time requirements. A manual process for such a large number of cards is also susceptible to human-based error. An automated system is, therefore, the most desirable solution for testing and calibration [4] and is the focus of the work described herein.

## 1.4 Scope of Work

The capability for testing and calibrating the  $E/p$  card pairs is a fundamental component of the goal for the success of making precision nuclear data measurements using the NIFFTE TPC. This capability requires testing hardware and a companion software interface for rapid testing of the  $E/p$  card pairs, performing initial health checks, and recording data. A robust analysis platform is required to generate the calibration measurements and perform more detailed studies. This work will embody the creation of a comprehensive test stand solution for testing the  $E/p$  card pairs. This will include modifications to a hardware testing solution, a software based system for systematic interrogation of the cards, as well as a software analysis package; these are described next.

An existing test stand setup will be adapted to provide the necessary hardware for performing calibration measurements. A crucial element will be the ability to test all 32 channels in an  $E/p$  pair simultaneously. The input signals must also be completely reproducible over a large time frame, i.e. the pulse generation equipment must have extremely tight performance and repeatability tolerances.

The current interface software will be modified to be more user friendly; in its current state it can communicate with and configure EtherDAQ cards, but lacks an automated and easy-to-use interface. It will also be modified to configure and operate the pulse generation equipment used to provide input signals to the test stand; the parameters controlling the test must be configurable. It must be developed to include basic functions for preliminary analysis, i.e. inspecting the results of a test for a basic health evaluation. Further, provisions must be made for a user to change the test parameters. Lastly, it will be expanded to save the generated waveform data to an external file for subsequent processing on a more robust analysis platform.

An analysis framework will be developed to carry out detailed user-specified analyses that will result in calibration constants for use in the TPC experiment. It must be capable of fitting the waveforms and extracting the characterizing parameters. The parameter of interest is the gain, which is the primary source of information for channel health and calibration. However, the other fit parameters must also be available if extended analysis needs arise. Further, the framework must be designed to be flexible and adaptable to any future needs.

# Chapter 2

## Calibration Hardware

A test stand is required to provide the necessary hardware for performing calibration measurements. A crucial element is the ability to test all 32 channels in an E/p pair simultaneously. The input signals must also be completely reproducible over a large time frame, i.e. the pulse generation equipment must have extremely tight performance and repeatability tolerances. Finally, the calibration hardware needs to be integrated with a single unified user interface to control the various components. The interface software development is detailed in chapter 3.

### 2.1 Basic Setup

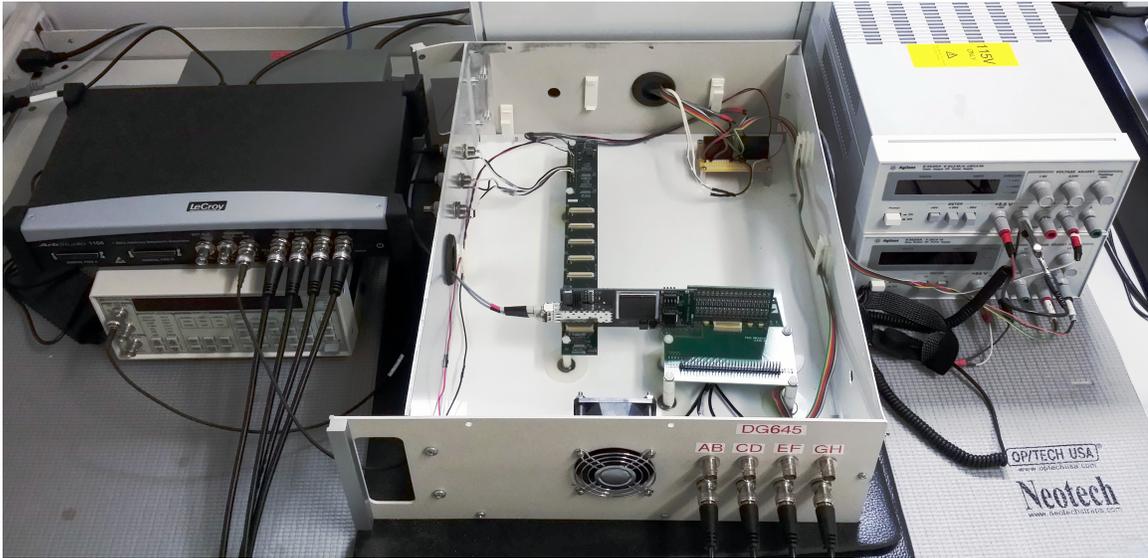
The test stand (see fig. 2.1) was originally designed at LLNL<sup>1</sup> for characterizing and debugging the EtherDAQ and preamp cards. It is constructed of steel paneling so that it functions like a Faraday cage and minimizes EMI.<sup>2</sup> BNC<sup>3</sup> connectors serve to carry signals to the internal components.

---

<sup>1</sup>Lawrence Livermore National Laboratory

<sup>2</sup>electromagnetic interference

<sup>3</sup>Bayonet Neill-Concelman



**Figure 2.1** – Test Stand Setup at ISU

The back of the case contains a pass-through for power cables, and the left side contains a second pass-through for the fiber-optic data cable. Clips for holding wires are mounted internally as a preventative measure against accidental tugging or other damage. A cooling fan is also mounted to the front.

### 2.1.1 Power and Clock

Three BNC connectors on the left-side panel provide ports for an external clock signal, an external trigger, and a timestamp reset. An SRS<sup>4</sup> CG635 is used to generate the clock signal required by the EtherDAQ card.<sup>5</sup> Power is supplied via a set of coupled Agilent E3620A and E3630A DC power supplies. Two power supplies are required because of the unique power requirements—the EtherDAQ card requires +24 V, while the preamp requires -3.0 V, +3.3 V, and +7.0 V. The

<sup>4</sup>Stanford Research Systems

<sup>5</sup>No internal clock is built into the EtherDAQ cards. For the TPC application the EtherDAQ cards must be synchronized, which is accomplished by driving all 192 cards with a single clock source [3]—the TPC reconstruction methods disintegrates if the EtherDAQ clocks are not synchronized. This is not required for the test stand’s purposes, but the external clock signal must still be provided.

+24 V and clock signal leads are soldered to the DBB,<sup>6</sup> and the preamp power leads are connected to the designated power header pins on the breakout board. An AC adapter is used to power a fan for cooling.

Internally, the test stand is designed replicate the seating of an E/p pair onto the TPC. The setup uses the same DBB for the EtherDAQ cards as is used in the actual TPC. The only difference is that just the first EtherDAQ seat is configured and active since the test stand is designed to evaluate E/p pairs one at a time.

### 2.1.2 Protective Measures

Insulation mats were placed under the test stand. The intent was to prevent acoustic interference as well as static-based EMI.

The timestamp reset was disabled by opening the connection with a  $50\ \Omega$  resistive load terminator. It is not currently needed due to the 40 day maximum value of the timestamp value. An accidental timestamp reset in the middle of a card testing procedure could even cause an error in the adapted DAQ system; the timestamp reset is reserved primarily for use between long data runs during actual TPC operation.

A interlock relay system (see fig. 2.2) was installed that closes the power supply circuits only when the cooling fan is on. This precautionary measure was implemented to prevent accidental overheating of the EtherDAQ components.

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<sup>6</sup>digital bus board

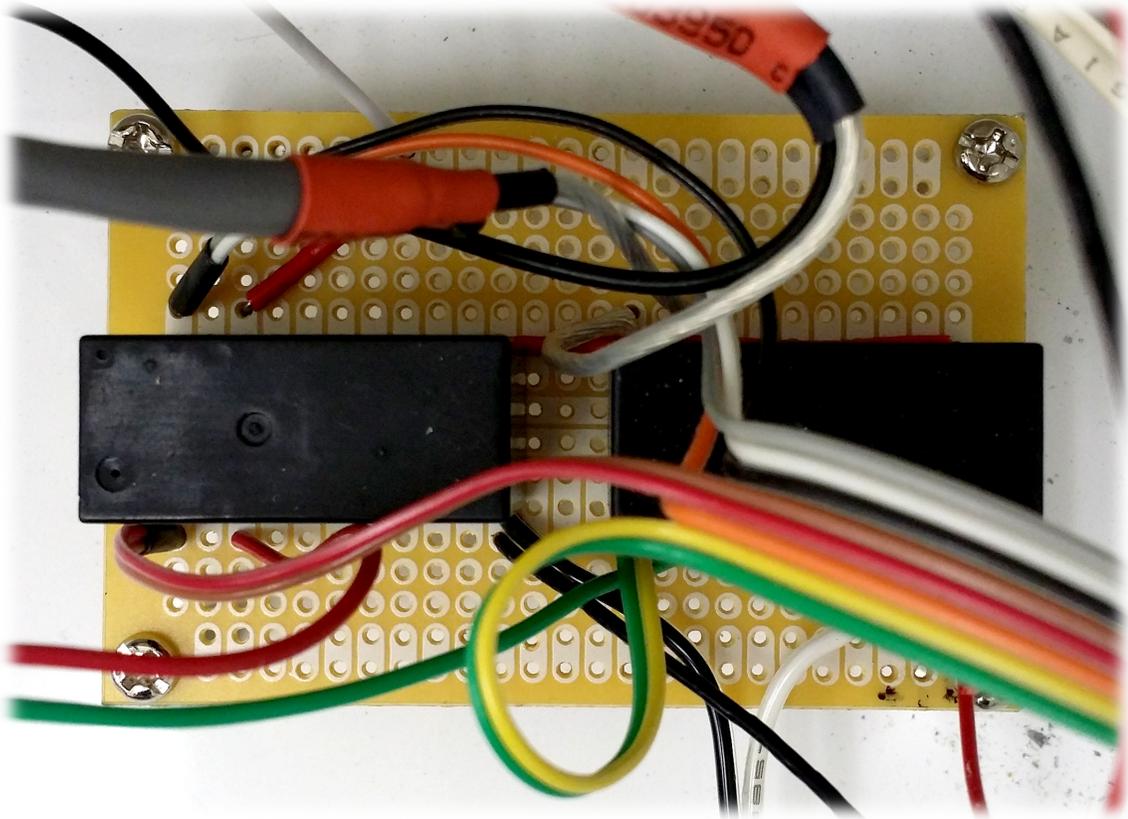


Figure 2.2 – Interlock Relay Modification

## 2.2 Pulse Distribution System

Function generators are used to provide voltage pulses that drive the test stand system. The front of the test stand provides 8 BNC ports for supplying the input voltage pulses internally.

Capacitors are used to convert each pulse's voltage into a charge signal, emulating the charge collection behavior of the TPC detection pads. Mezzanine boards, referred to as breakout boards, are used to deliver the capacitor-generated charge signals to the preamp card through the exact same connector as used on the TPC. The breakout boards are also used to supply power to the preamp card, which is

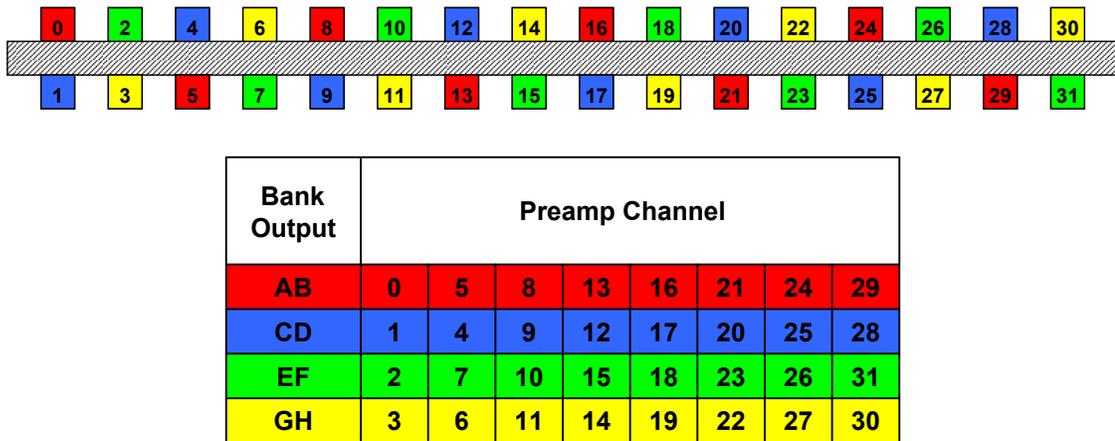


Figure 2.3 – Bank to Channel Correlation

provided through a set of jumper connectors on the bottom. The locations of the channel and power connections are printed on the breakout boards<sup>7</sup> for clarity.

The channels are configured so that sequentially numbered channels do not neighbor each other on the preamp card. The top-half of fig. 2.3 illustrates this configuration.

### 2.2.1 Pulse Generation

An SRS DG645 generator was used initially at LANL<sup>8</sup> for preliminary testing purposes. However, extended testing with the DG645 yielded inconsistent results. After consulting the spec sheets and contacting customer support, it became apparent that the DG645 performance was a poor match for the testing and calibration requirements—it was designed with a focus on precise timing—whereas the listed

<sup>7</sup>The hardware design, source code, and older GUI interfaces generally employ a 0-based indexing scheme, meaning that the channels are numbered 00 through 31. The GUI interfaces designed during this project (see chapters 3 and 4) use a 1-based indexing scheme so that the channel numbering starts with 1 and goes to 32. A 1-based indexing is employed in these situations because a typical user is not familiar with 0-based indexing.

<sup>8</sup>Los Alamos National Laboratory

amplitude uncertainty was  $100\text{ mV} \pm 5\%$ . Evaluation of the DG645 pulses were performed under a variety of environmental conditions, loads, usage duration, and pulse parameters. The observed variations confirmed the documentation specifications.

Consistent pulse amplitude behavior was absolutely necessary for testing and calibrating the preamp cards. The ArbStudio line, manufactured by Teledyne LeCroy, was identified as the best option. The ArbStudio units are arbitrary waveform generators, enabling a wider range of testing conditions than the DG645's square pulse.

A demo ArbStudio 1104 unit was evaluated over the period of a month and compared against the DG645 using the same pulse evaluation tests. Compatibility with the interface software was also verified. NIFFTE project management determined that the ArbStudio 1104 fulfilled project requirements, actually meeting or improving on the information listed in the spec sheets. The demo unit was shipped back and a new unit purchased for use with the test stand.

### 2.2.2 Individual Channel Testing

A special breakout board, shown in fig. 2.4, provided the capability to isolate a single channel and test it independently of the 31 other preamp channels.

Individual testing is accomplished using individual leads, each with an embedded capacitor, soldered to the BNC connector. The embedded capacitors are used to create charge signals from the voltage pulses, which action emulates to the charge collection behavior of a pad on the TPC. The current configurations are summarized in table 2.1. The capacitance affects the formation characteristics of

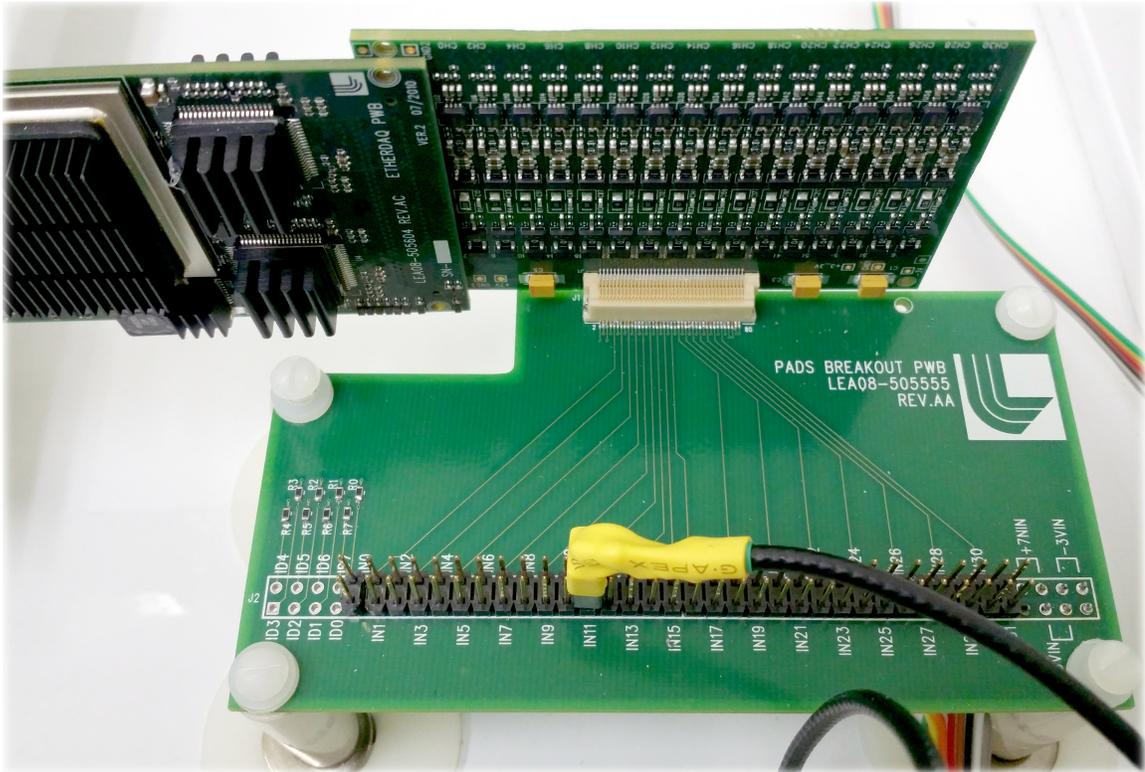


Figure 2.4 – Individual Channel Testing Setup

Table 2.1 – Channel Isolation Capacitance Configuration

Test Stand Connector	AB	CD	EF	GH
Capacitance	0.5 pF	1.0 pF	<i>unused</i>	<i>unused</i>

the charge signal generated from the voltage pulse. Further, the ideal capacitance will generate charge signals within the dynamic range of an E/p pair.

The jumper connector on the end of each lead was given a silver orientation mark on one side. The mark indicates which side must face the channel number printed on the breakout board. Proper orientation is required for the proper charge polarity; an inverted charge signal will not be detected and converted into a waveform by the ADC system.

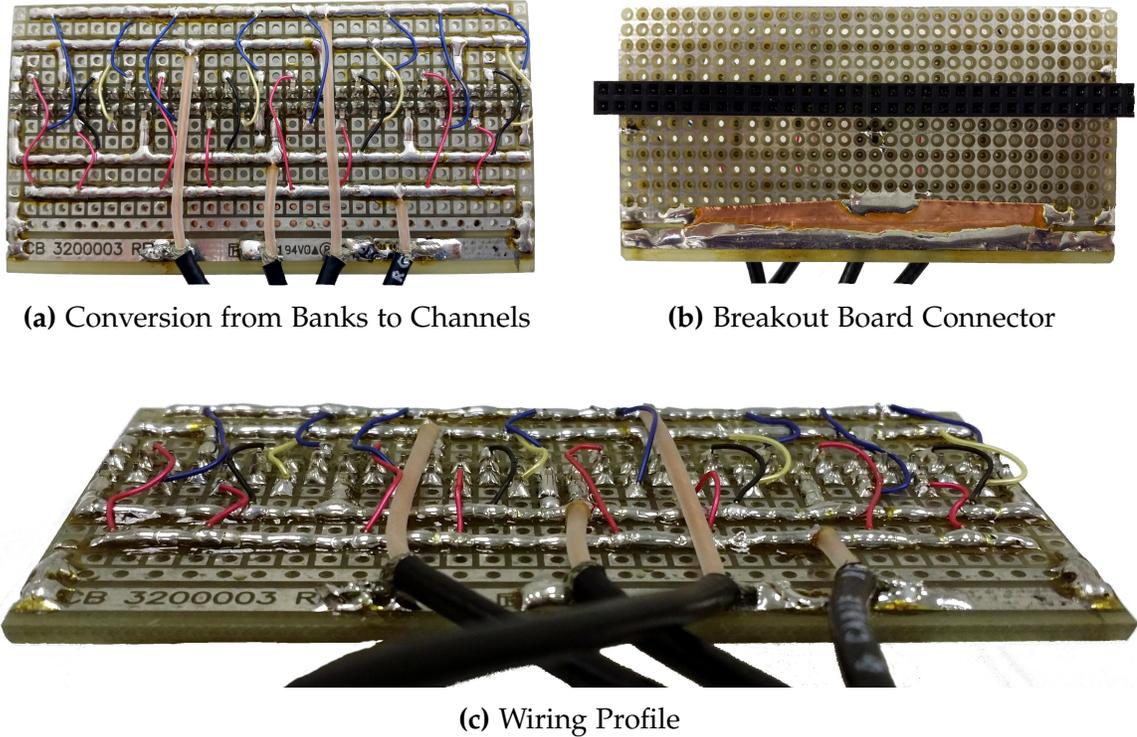


Figure 2.5 – Distribution Board

### 2.2.3 Distribution Board

The distribution board (see fig. 2.5), created at LANL, splits the signals from the four banks into 32 separate pulses. The banks are, ordered from the top/back to the bottom/front: AB, CD, EF, and GH. In figs. 2.5a and 2.5c the channels are numbered 1 to 32 from right to left. The channel ordering is reversed for fig. 2.5b since it shows the flip-side.

Small capacitors,  $\approx 0.5$  pF in size, are soldered between the pulse splitters and the jumper connection to the preamp. These capacitors can be seen between the colored wires and jumper solder points in fig. 2.5a, with local detail on the channel 07 capacitor in fig. 2.6.

A breakout board (detailed in fig. 2.7), conducts the 32 pulses created by the distribution board to the 32 channels on the preamp. The channels are organized

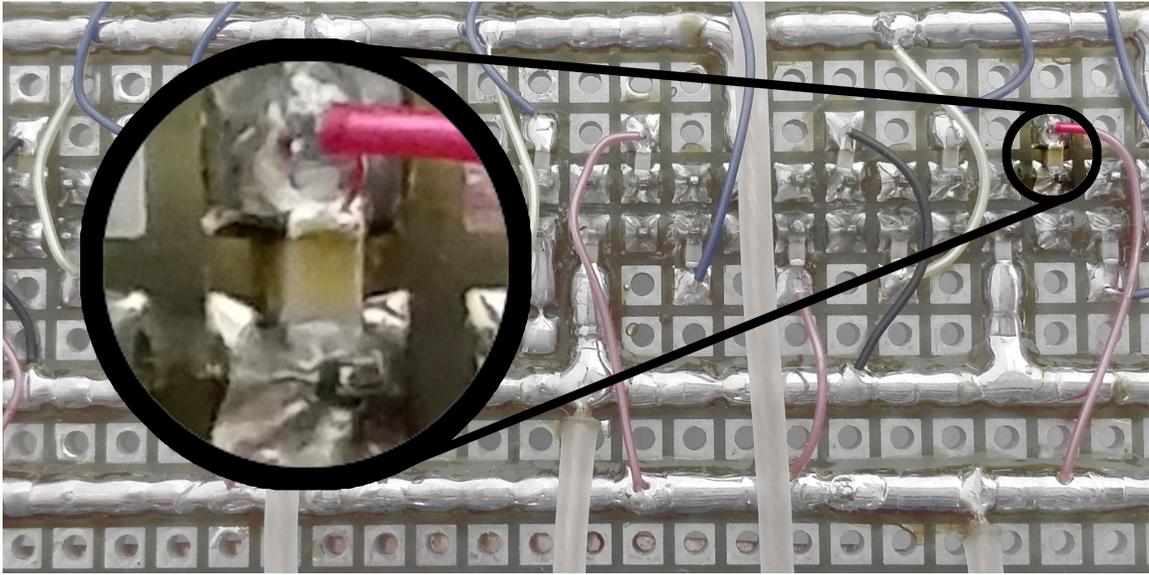
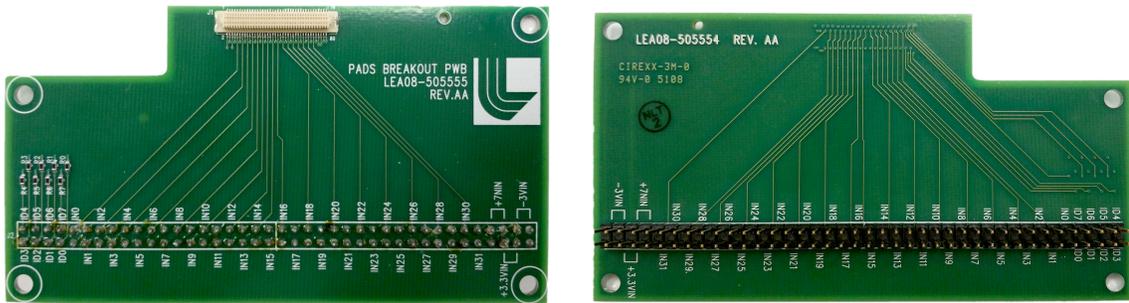


Figure 2.6 – Detail on the Channel 07 Capacitor



(a) Top

(b) Bottom

Figure 2.7 – Breakout Board

such that neighboring and opposite-side channels are all fed by different banks. In other words, a channel’s source bank is different from its neighboring and opposite-side channel’s source banks, which are all themselves different from each other. Figure 2.3 illustrates this separation by using a color-coding scheme to represent the bank to channel correlations.

# Chapter 3

## Interface Software

The name of the interface software for the test stand is EtherDaqGUI, and was developed at LLNL by Dr. Vincet Riot. EtherDaqGUI runs in Windows<sup>1</sup> XP and is coded in C++ using the Visual Studio<sup>2</sup> IDE.<sup>3</sup> Its primary purpose was for the continual testing and debugging of the EtherDAQ and preamp cards throughout the hardware design phase (see chapter 2).

EtherDaqGUI must be modified in order to perform quick, basic health evaluations on the E/p card pairs, provide complete control over the test stand hardware, and save all the hardware configuration and waveform data to a file for subsequent analysis. Specifically, the interface must be modified to be more user friendly; in its original state it could communicate with and configure EtherDAQ cards, but lacked an automated and easy-to-use interface. It must also be modified to configure and operate the pulse generation equipment used to provide input signals to the test stand. The user must be able to modify all the test parameters. EtherDaqGUI must then save the configuration data along with

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<sup>1</sup>Windows® operating system is a registered trademark of Microsoft Corporation

<sup>2</sup>Visual Studio® is a registered trademark of Microsoft Corporation

<sup>3</sup>integrated development environment

the generated waveform data to an external file for subsequent processing on a more robust analysis platform. Finally, a full test suite should last only a few minutes, depending on the test parameters. The resulting data should be studied in much greater detail using a newly developed analysis platform, later discussed in chapter 4.

### 3.1 Conversion from a Debugging Tool

It was decided to adapt the existing EtherDaqGUI code by inserting the additional abilities required for the card testing process. The alternative, redeveloping these capabilities from scratch,<sup>4</sup> was not considered to be a time-effective solution. EtherDaqGUI already contained the following basic features required for the card testing procedure:

- network interface
  - scanning
  - card identification
- initialization
- status interrogation
- data collection

The application GUI<sup>5</sup> is organized by dividing the various functions into tabs. A new tab, <Card Test>, was created for the purpose of automated card testing.

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<sup>4</sup>The resulting interface from re-development would have been purpose-built, potentially increasing the run-time efficiency. This does not mean that the existing interface had poor performance, but that there was potential for improvement by stripping out unneeded functionality. However, the chance for performance gains was not sufficient justification when compared to the estimated development time.

<sup>5</sup>graphical user interface

Figure 3.1 demonstrates the final repurposed version of EtherDAQGUI with the <Card Test> tab in action.

## 3.2 Automated EtherDAQ Configuration

The EtherDAQ cards first perform a `POST`<sup>6</sup> when supplied with power. They do not, however, start sending data upon `POST` completion; the data recording device must first configure the EtherDAQ card(s).

The original framework required the user to perform a multi-step process in order to identify and configure an EtherDAQ card. First, the network must be scanned for `MAC`<sup>7</sup> addresses that are pre-configured to be associated with the EtherDAQ cards. Next, the operational parameters must be set. These are, in no order of importance: 1) destination `MAC` address, 2) lookback duration, 3) high and low trigger thresholds, 4) neighbor triggers, and 5) sampling frequency. Finally, the desired channels must be enabled, as they are all disabled by default. This is done by calling `CMD_SetSetAnalogChannelEnable()`.<sup>89</sup> Enabling and disabling of individual channels is a necessary part of operating the EtherDAQ cards for the TPC application. This way a channel's output can be suppressed if its electronics fail and begin to introduce erroneous waveforms into the data stream.

An automated configuration process was designed that simplifies this process. The user is required only to click on the <Refresh List> button whenever a change is made to the system. The network is then scanned for EtherDAQ cards and

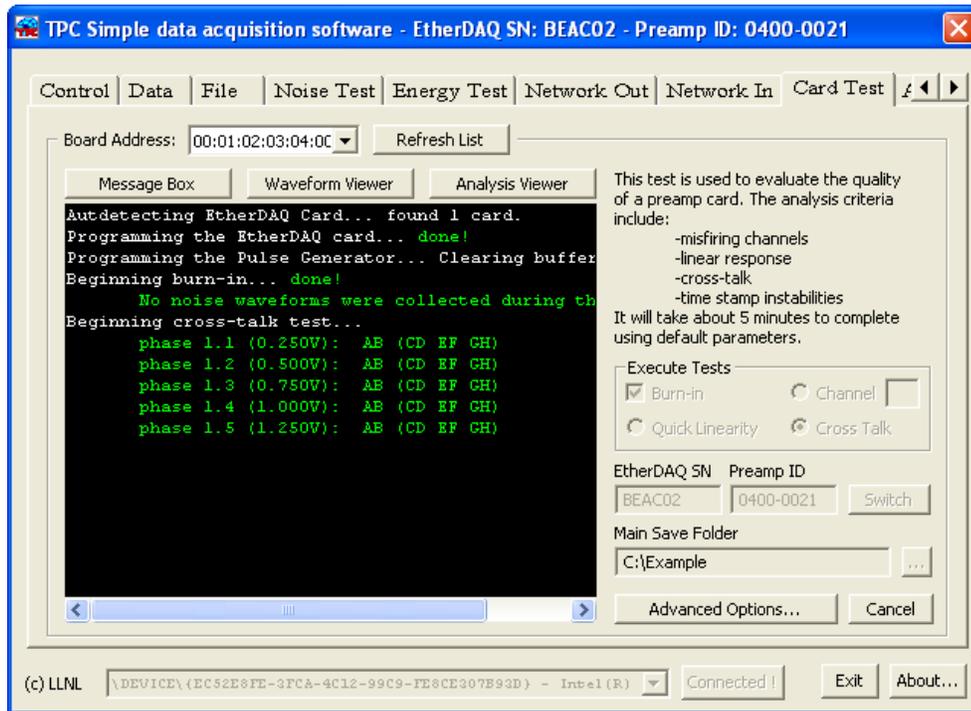
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<sup>6</sup>power-on self test

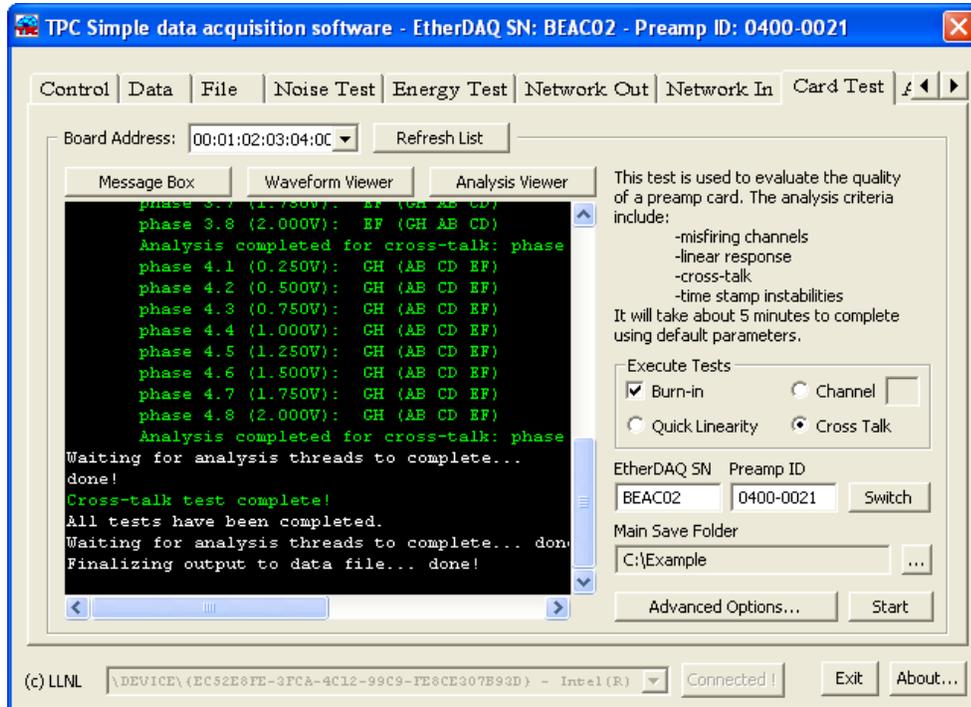
<sup>7</sup>media access control

<sup>8</sup>`TPCPacketParser.cpp:1847-1866`

<sup>9</sup>This sends a packet containing a single 32-bit mask value. The individual bit positions correlate directly to the channel numbering; the 1<sup>st</sup> bit maps to channel 1 and the 32<sup>nd</sup> bit maps to channel 32. A bit value of '1' enables the channel, whereas '0' disables the channel. For example, a '1' for the 1<sup>st</sup> bit causes channel 1 to be enabled; conversely, a '0' in the same position would disable channel 1.

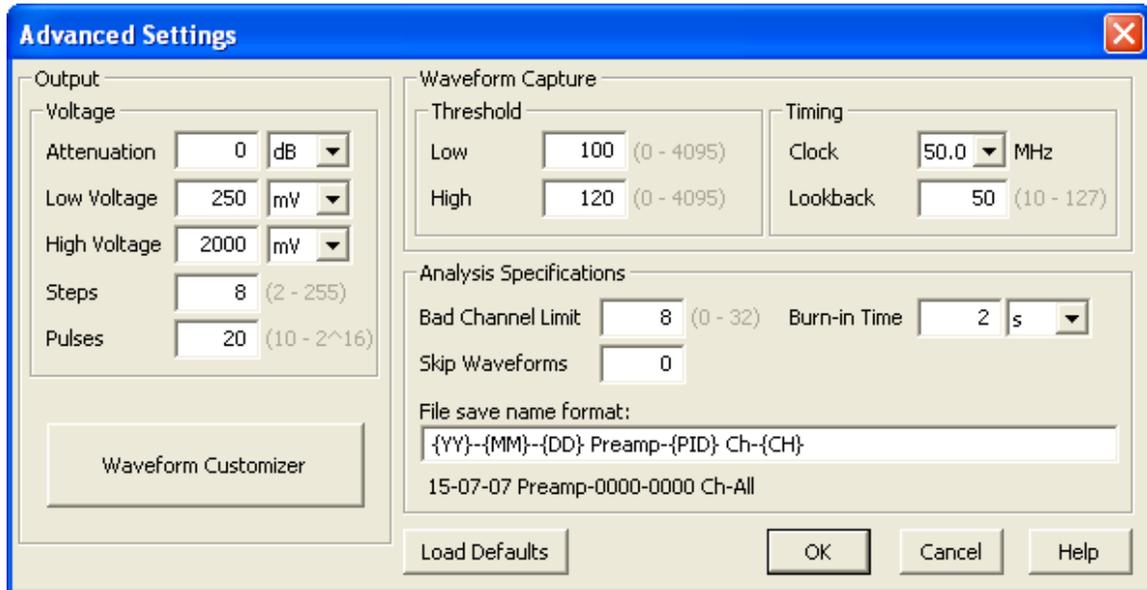


(a) Test Running



(b) Test Completed

Figure 3.1 – EtherDagGUI Card Test Tab In Action



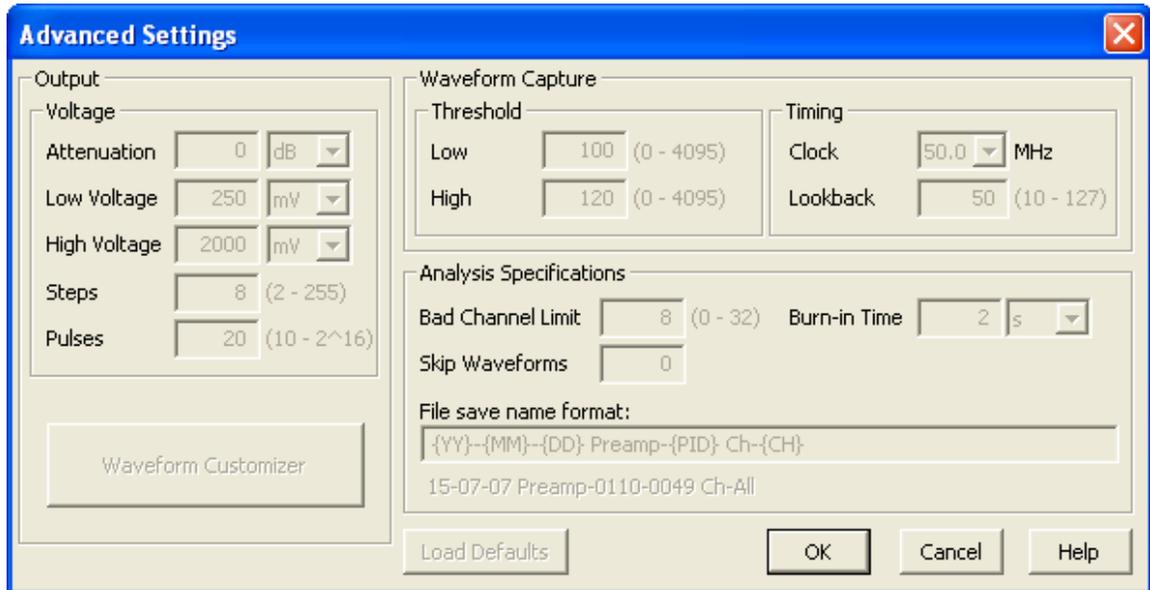
**Figure 3.2** – EtherDaqGUI Advanced Settings Dialog

the configuration steps are performed for each discovered EtherDAQ card. In some cases the changes are not immediately detected. In this instance it may be necessary to click on the <Refresh List> button until the changes are recognized. If nothing is detected after a few refreshes then there is likely an error in the hardware setup; some items to check are: 1) the EtherDAQ card is powered on, 2) the fiber-optic adapter is properly connected, and 3) the optic fibers are seated properly and have no sudden corners.<sup>10</sup>

Default operating parameters are defined in `CTSetDefaults()`.<sup>11</sup> These default parameters are selected from experience to fit most testing needs. The parameters are user-configurable via the <Advanced Settings> dialog, as shown in fig. 3.2. All changes to the operating parameters can be reverted to the default values by clicking on the <Load Defaults> button within the <Advanced Settings> dialog.

<sup>10</sup>If none of these conditions exists the problem may lie in the network communication interface of EtherDaqGUI. The only recourse is to close EtherDaqGUI down, use the Task Manager to ensure the process is closed, then re-open EtherDaqGUI.

<sup>11</sup>CardTest.cpp:1528-1605



**Figure 3.3** – EtherDaqGUI Advanced Settings Dialog in Disabled State

Help is available by clicking on the <Help> button. This opens up a window with descriptions about each of the items and how they influence the testing procedures. The syntax and substitutions of the <File save name format> box are also fully listed and described.

Modifying the parameters is possible only when EtherDaqGUI is idle. The user can always open the advanced setting dialog to view the settings, but the parameters are grayed out and cannot be modified if the pulse generation equipment is being operated. Figure 3.3 shows the appearance of the <Advanced Settings> dialog with the parameters locked.

### 3.3 Driver Compatibility Issues

EtherDaqGUI depends on `ndisprot`, a raw Ethernet communications service library, to communicate with the EtherDAQ cards. This allows the communication based on

MAC addresses instead of IP<sup>12</sup> address, enabling more efficient packet transmission and routing.

It was discovered during development that `ndisprot` was not compatible with Windows 7. Although the computer driving the test stand used Windows XP and suffered no compatibility issues, the development computer ran Windows 7. Different potential solutions were investigated to resolve the Windows 7 compatibility, each without success. It was determined that the lack of compatibility was caused by changes to underlying architectural design differences and driver registration restrictions in Windows 7.

The primary development continued on the Windows 7 system. Final testing and debugging was performed on the test stand system. SVN<sup>13</sup> was used to keep the code between the development and test stand computers synchronized. Two tweaks enabled the necessary debugging on the development system.

First, it was necessary to inspect the GUI as the <Card Test> tab and associated items were designed and laid out. Originally, `EtherDaqGUI` exited automatically if `ndisprot` was not detected. This behavior was replaced by a message box warning of the situation. Once the warning was acknowledged the main `EtherDaqGUI` window opened up.

Second, the validity of the waveform analysis routines needed to be checked. The `PseudoPulseGenerator` class was created which emulated the acquisition of waveforms from the EtherDAQ card. These simulated results were feed directly into the `Card Test` class's DAQ component. This class was configured to be used automatically if no pulse generator was detected upon starting a card test. Again, the user was notified via a warning message.

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<sup>12</sup>internet protocol

<sup>13</sup>Apache Subversion

## 3.4 Pulse Generator Operation

A detailed understanding of the inputs to the system is a critical component of performing calibration measurements. This is best achieved if the test system itself specifies the input signal characteristics. Thus, controls for operating the pulse generating equipment were added to EtherDaqGUI. A standard pulse configuration defines the following items:

- voltage amplitude & offset
- frequency
- duty cycle
- number of pulses

Nothing should be assumed about previous operational states—the entire pulse definition sequence should be transmitted to reprogram the generator when a test is begun, with any previous settings or changes overwritten. EtherDaqGUI must completely also maintain control the pulse generating equipment throughout the entire card testing procedure.

### 3.4.1 Remote Programming

The remote programming of the DG645 is achieved via its Ethernet port. Originally, the DG645 was controlled with hand-modified script written in C. An executable program was produced by compiling the script in a Cygwin environment<sup>14</sup> and linking it against the Windows WinSock32 libraries.<sup>15</sup> Running this program opened a connection to the DG645, sent all the commands, then closed the connection once all the commands were executed.

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<sup>14</sup>Refer to the Cygwin website for more information: <https://www.cygwin.com/>

<sup>15</sup>The WinSock32 libraries provide the framework for communicating over Ethernet

A template file was been created to simplify this process based on an example script found in the manual [5, pp. 70–72]. Still, compilation or run-time errors often occurred after modifying the template from minor mistakes, e.g. mistyping a single character. Often these were challenging to locate and resolve. The need for frequent modifications due to changing testing requirements compounded the inefficiency of this approach.

Ultimately, the communications protocols were embedded into EtherDaqGUI, which provided the necessary dynamic communication interface. This mirrored much of the work required by the external template file modification, while reducing the potential points of failure. This also enabled near-instantaneous programming of the DG645, limited only by the response time of the generator.

### 3.4.2 Common Control Features

Throughout testing the pulse generator is sent more commands to change the pulse parameters as needed. Trigger events are also sent by EtherDaqGUI to initiate the next burst of pulses. The controls are implemented such that each of the four outputs can be independently defined.

It was determined that compatibility with the DG645 would be retained when support was added for ArbStudio devices (see section 3.4.4). To accomplish this the complementary macros `USEARBSTUDIO`<sup>16</sup> and `USESRS`<sup>17</sup> were created. The interface for the ArbStudio devices is used if `USEARBSTUDIO` is defined at compile time. Otherwise, the preprocessor defines `USESRS` and the DG645 interface is used. This provides support for both generators with only a slight decrease in source code legibility.

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<sup>16</sup>CardTest.cpp:8

<sup>17</sup>CardTest.cpp:19-21

### 3.4.3 SRS DG645 Interface

The controls for DG645 were implemented in the `PulseGeneratorEthernetInterface`<sup>18</sup> class. The class handles the initialization procedures, status interrogation, and setting the pulse parameters. `EtherDaqGUI` constructs an instance of the `PulseGeneratorEthernetInterface` class when launched. Commands are immediately sent to open the connection and give control to the computer. This places the DG645 into remote lock out mode. The LED<sup>19</sup> labeled 'REM' is lit to indicate when the remote lock out mode is active.

For the current setup the DG645 was assigned 192.168.1.6 as its static IP address. This value was manually keyed into the DG645 using the front panel and hard coded into the `PulseGeneratorEthernetInterface` class initializer.<sup>20</sup>

### 3.4.4 ArbStudio 1104 Interface

The ArbStudio line of devices communicate using USB.<sup>21</sup> An SDK<sup>22</sup> for integrating device control was provided by Teledyne LeCroy. The SDK was built and compiled using Visual C# from the Microsoft<sup>23</sup> .NET Framework.

#### 3.4.4.1 License Issue Resolution

Forcing the ArbStudio SDK to function properly was a complicated process; the SDK depended on an NI<sup>24</sup> .dll that failed when verifying licensure. The .dll was

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<sup>18</sup>`SRSGeneratorInterface.(h/cpp)`

<sup>19</sup>light-emitting diode

<sup>20</sup>`SRSGeneratorInterface.cpp:16`

<sup>21</sup>universal serial bus

<sup>22</sup>software development kit

<sup>23</sup>Microsoft® is a registered trademark of Microsoft Corporation

<sup>24</sup>NI is a trademark of National Instruments. This publication is independent of National Instruments, which is not affiliated with the publisher or the author, and does not authorize, sponsor, endorse or otherwise approve this publication.

critical to device control and utilized to generate Fourier series from arbitrary pulse shape descriptions. The Fourier series coefficients, not the potentially millions of individual discrete data steps, are transmitted to the pulse generator to define the pulse characteristics.

The ArbStudio software engineers were unable to resolve the issue; this issue was completely unknown since the same .dll was successfully used in their own software package. A back-door solution was discovered that required modifying the code of the failing .dll. This was possible only because of the partially-compiled nature of .NET Framework executables and libraries. Using a decompiler, the offending code was commented out and then the .dll regenerated.

#### **3.4.4.2 Implementation**

EtherDaqGUI was originally written using unmanaged C code, while the ArbStudio SDK was written using managed Visual C# code. Because of the complexities relating to interfacing these two different programming languages and design paradigms, it was necessary to create an separate ArbStudio project within the EtherDaqGUI solution. The new project was written in Visual C# and linked against the ArbStudio SDK. The unmanaged to managed code connection was implemented in the EtherDaqGUI project as the `ArbStudioGeneratorInterface`<sup>25</sup> class, and includes the necessary functions for mapping the unmanaged function calls to a managed scope.

In addition to the capabilities of the DG645 interface, the ArbStudio project included the ability to customize the shape of the pulse. Although any arbitrary cyclic function is possible, only a few standard options are currently available. These are square, triangular, sinusoidal, and Erf. The default shape is square,

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<sup>25</sup>`ArbStudioGeneratorInterface.(h/cpp)`

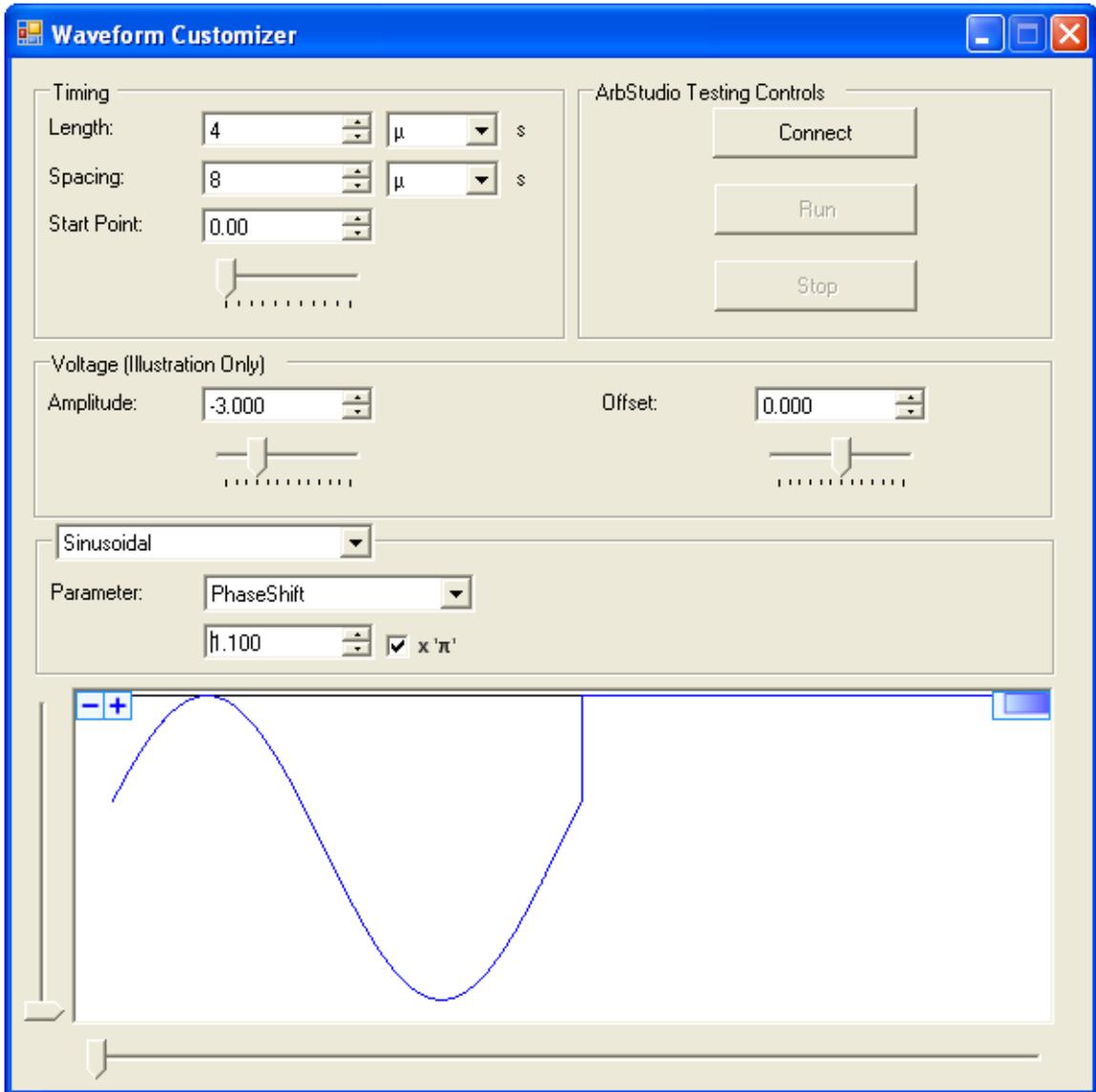


Figure 3.4 – Waveform Customizer Dialog

which is the most similar to the output of the DG645. The <Waveform Customizer> dialog, shown in fig. 3.4 with parameters selected purely for demonstration, was created to support this functionality. It is accessed through the <Waveform Customizer> button in the <Advanced Settings> dialog.

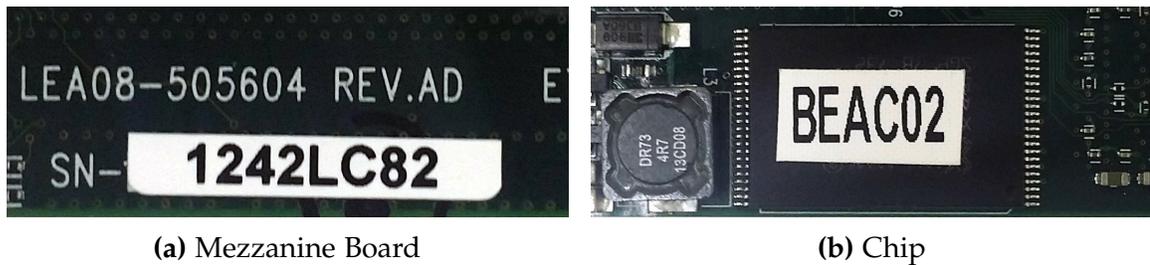


Figure 3.5 – EtherDAQ SN Placement

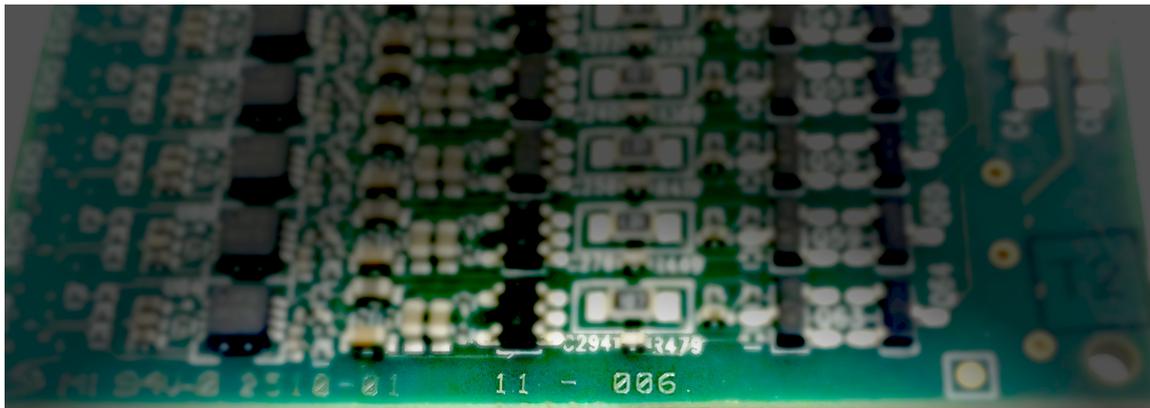


Figure 3.6 – Preamp ID Location

### 3.5 Card Testing

Card testing can be performed using a few different procedures, depending on the analysis needs. Each test is associated with the date and unique E/p card identifiers. The E/p pair is identified using both the EtherDAQ SN<sup>26</sup> and the preamp ID,<sup>27</sup> which must be entered by the user. The EtherDAQ SN can usually be found on a printed label affixed to the mezzanine board (fig. 3.5a) or a chip (fig. 3.5b). The preamp ID can be found on the backside of the preamp card, as shown in fig. 3.6. It is of the form XXXX-XXXX, where ‘X’ represents a digit. Occasionally a blank space is used instead of a digit; this is replaced by ‘0’ for consistency. For example, the preamp ID shown in fig. 3.6 should be read as ‘0110-0006.’

<sup>26</sup>serial number

<sup>27</sup>identification

The <Start> button is enabled when all the parameters are set and an EtherDAQ card has been found. Once the testing is started the <Start> button is replaced by a <Cancel> button. When the <Cancel> button is clicked 1) the current testing operation will terminate, and 2) the equipment will be returned to an idle state.

### **3.5.1 Sanity Test**

A sanity test is performed once card testing has been initiated and before any actual testing begins. First, the output path for the data is checked to ensure validity. Second, the EtherDAQ SN and preamp ID are checked against an internal history. If the same pair has already been tested then the user notified and asked if they wish to stop or continue. Third, the connection to the pulse generator is tested and verified. If no pulse generator is found then the user is warned and the testing proceeds using an internal waveform simulation framework. Fourth, the network conditions are checked as described in section 3.5.1.1. Fifth, the (user-defined) test parameters are examined. Any errors are corrected with valid values and the user is notified of the changes. Finally, the internal data buffers are reset and prepared for the new data.

#### **3.5.1.1 Network Conditions**

The network is sniffed briefly to verify that the packet transmission rate is zero. If network activity is detected then a soft reset of the EtherDAQ card is attempted.

This check is performed to counter the behavior of the EtherDAQ card under certain situations. Fundamentally, packets are stored in the buffer before being transmitted over the network. When a data packet is transmitted an acknowledgement from EtherDaqGUI is expected in return. If no acknowledgement is received

then the data packet is retransmitted at a regular interval until an acknowledgment is received. This behavior was implemented to prevent any data loss and performs admirably under most conditions.<sup>28</sup>

Occasionally and for reasons still unknown, the EtherDAQ card and EtherDaqGUI fall out of sync with each other: the EtherDAQ card fails to recognize the acknowledgements sent from EtherDaqGUI. As a result the network becomes saturated as each tries unsuccessfully to communicate with the other. This condition is colloquially known as a “10 to the 4th” error, taken from the magnitude of the number of packets being transmitted every second.

### 3.5.1.2 Soft EtherDAQ Reset

All the channels are disabled, the configurations settings are retransmitted, the internal buffer is flushed with six housekeeping<sup>29</sup> requests, and then the desired channels are re-enabled. Receipt of all six housekeeping packets is checked once the network returns to a silent state. If any packets are found missing then the system is still out of sync and the process is repeated.

The card testing is terminated if too many sequential re-sync attempts fail. At this point the only current recourse is to power-cycle the EtherDAQ card and restart EtherDaqGUI. Restarting the computer is not necessary.

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<sup>28</sup>This does not guarantee data preservation—if a packet sits in the EtherDAQ buffer too long it may be overwritten by newer data

<sup>29</sup>“Housekeeping” is another term for using the `GetAnalogChannelStatus()` function. This request causes a large packet, with information for each of the requested channels (supplied by a 32-bit argument bit-mask), to be placed into the buffer. Six of these requests for all 32 channels will fill two buffer blocks, hopefully precipitating a complete buffer flush.

### 3.5.2 Preliminary Analysis

EtherDaqGUI contains preliminary analysis capabilities to check the health of an E/p card pair. The <Advanced Settings> dialog can be used to change the sensitivity of the preliminary analysis to bad channels or waveforms.

Capabilities for both automated and manual preliminary analysis are available. Fundamentally, both depend on the estimated pedestal and plateau values for each waveform. The pedestal is the average of the first ten data points; similarly the plateau is the average of the last ten data points. Finally, the waveform amplitude is the difference between the pedestal and plateau.

#### 3.5.2.1 Automated Preliminary Analysis

The automated preliminary analysis was designed to provide a quick method of evaluating the performance of an E/p based on the pulse amplitude. Two different health metrics are used: channel response and linearity.

##### **Channel Response**

The channel response analysis requires a simple check of the amplitude. A channel passes if the response is above the given threshold. If the amplitude is below the threshold the channel is flagged for closer investigation. A channel that fails the response test is likely dead and will not be able to collect data at any pulse voltage.

##### **Linearity**

Linearity is an analysis performed using the combined results of the waveform amplitude at each voltage set during a phase. Simple linear regression is used to analyze the amplitude as a function of the voltage. The 'R' value is used to

determine the statistical quality of the fit. A bad statistical fit is indicative of a channel that is not linear over the range of input voltages. Manual analysis should be done to determine the cause and decide whether the channel is usable.

### 3.5.2.2 Manual Preliminary Analysis

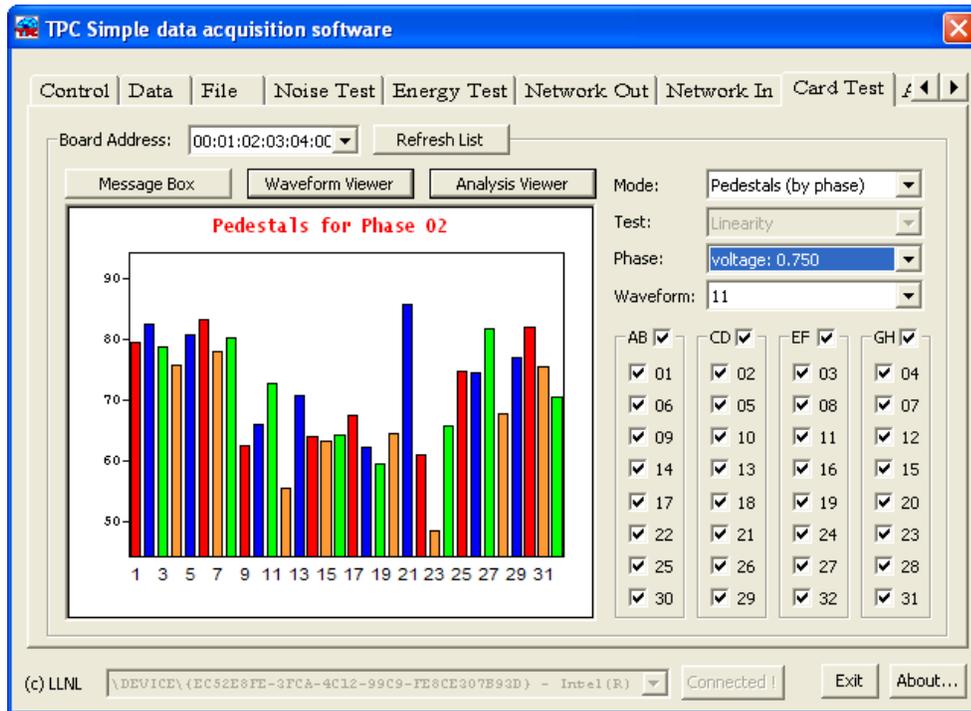
The manual analysis tool collection is designed to aid in further investigating the health of a card. The tools are activated by clicking on the <Analysis Viewer> button under the <Card Test> tab. The resulting perspective is shown in fig. 3.7. On the right are the controls for selecting the analysis tools and data ranges; on the left is the <display pane> which shows the output.

Two sets of controls are used to operate the manual analysis. The first is the <Mode> drop-down menu. The second set are the bank and channel selection controls. The mode controls 1) how the analysis results are displayed in the <display pane>, and 2) the available bank and channel selection controls. Each mode is described in appendix C.

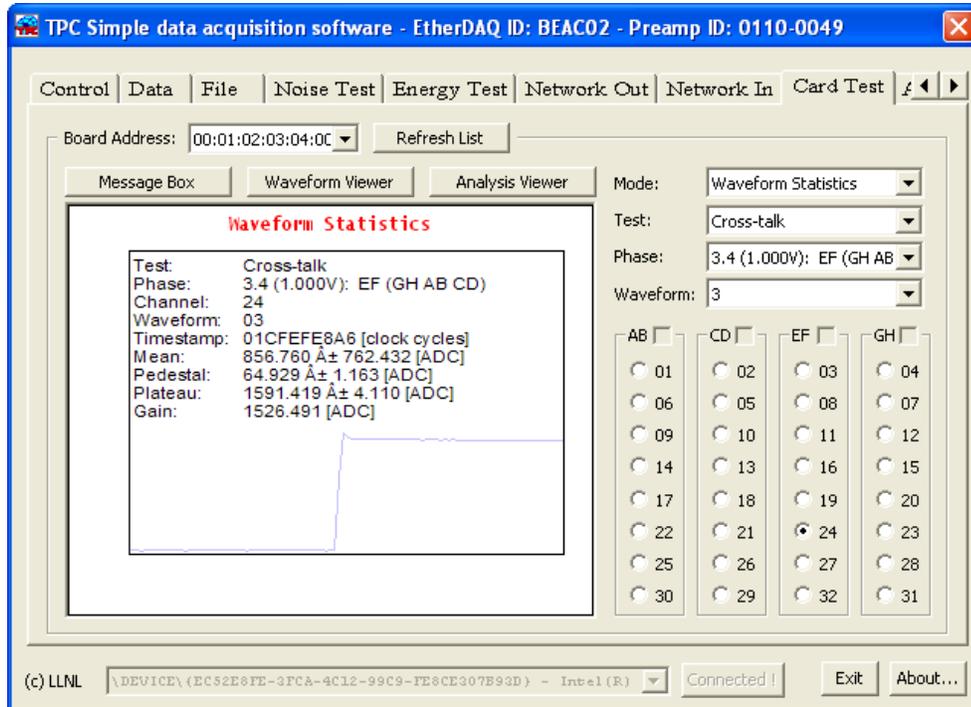
### 3.5.3 Card Testing Procedures

One and only one of the three primary procedures must be selected: 1) Quick Linearity, 2) Single Channel, and 3) Cross Talk. Burn-in, the fourth selection, is optional and can be selected along with with one of the primary procedures.

These procedures determine the how the pulse generator is configured, which data are recorded, and if a preliminary analysis method is performed.



(a) Pedestals Histogram



(b) Waveform Statistics

Figure 3.7 – Waveform Analysis Tools Perspective

### 3.5.3.1 Single Channel

EtherDaqGUI is set to test only one channel. This is used in conjunction with the single channel testing equipment described in section 2.2.2. EtherDaqGUI configures the first output on the pulse generator as the pulse source.

The desired dynamic range determines which bank on the test stand to use; refer to table 2.1 for the available capacitances and connecting banks. The number of the channel being tested<sup>30</sup> must be entered into the edit box located to the right of the <Single Channel> radio button.

### 3.5.3.2 Cross Talk

The cross talk procedure fulfills the primary role of the automated card testing—it is the most definitive and comprehensive test performed. The data generated from the cross talk test is used extensively by the analysis framework (see chapter 4). The distribution board is used for this test.

The test name comes from the focus of the test parameters to investigate the system for cross talk. Voltage pulses are sent to only one bank (and its 8 corresponding channels) at a time—the other three banks and 24 corresponding channels are idle. The sync output of the pulse generator is connected to the force trigger BNC connector on the test stand. A TTL<sup>31</sup> pulse is sent to the sync output coincident with the leading edge of the voltage pulse. This forced trigger causes the EtherDAQ FPGA to record data for all 32 channels, regardless of whether the filtering algorithms detect a signal or not. Any cross talk existing in the system can then be detected and/or recorded by the idle channels.

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<sup>30</sup>1-based

<sup>31</sup>transistor-transistor logic

The procedure is divided up into four phases. Each phase pulses only one bank, and the phases each pulse a different bank. Each phase contains a number of subphases equal to the number of voltage steps. The first subphase sends pulses at the minimum voltage. Amplitudes for the subsequent subphases increase linearly, with the final subphase voltage at the maximum voltage. Separately pulsing each bank fulfills the cross talk measurement requirements.

Performing each phase with a number of subphases provides data for two additional quality checks. First, it allows a linearity test to be performed on each of the channels. As described previously, linearity is a required characteristic for the intended use of the preamp cards. Second, it allows for the discovery of non-linear cross talk. The calibration and analysis is based on the assumption of linear cross talk. The presence of non-linearity would indicate either a flaw in the analysis assumptions or a bad channel; either would require further detailed interrogation.

### 3.5.3.3 Quick Linearity

Quick linearity was designed to be a fast test that can be used to verify that each preamp channel exhibits a linear response. It consists of only a single phase with all four banks pulsed simultaneously. Cross talk cannot be evaluated using this test data, although the distribution board is used.<sup>32</sup> The linearity test results can be viewed with the <Linearity> analysis tool described in table C.1.

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<sup>32</sup>It is assumed that the cross talk scales linearly with the pulse amplitude, and thus can be overlooked in this context

#### 3.5.3.4 Burn-in

This test is optional, and can be enabled by selecting the <Burn-in> check-box on the main <Card Test> tab. The burn-in can be used with any of the primary tests, and is always the first operation when enabled.

The pulse generator is idle for a specified time, which allows the electronics to reach a steady-state condition. Additionally, EtherDaqGUI does not send any communications to any device. It has been observed that altering settings on both the pulse generator and EtherDAQ will occasionally cause an unexpected waveform event, especially with the DG645 pulse generator.

This idle time is also used to identify poor or noisy channels on the preamp card. Since no pulses are being introduced into system, the system logs any spurious waveforms that may be generated by the preamp card. A channel is flagged if the count exceeds the given threshold parameter.<sup>33</sup> The entire card is considered faulty if a preamp card has too many flagged channels; the testing is terminated and the user notified.

#### 3.5.4 Data Export Files

EtherDaqGUI generates all output in text form. All output files are saved into the directory displayed in edit box below the Main Save Folder label. The path is selected using a folder browser which is opened by clicking on the <...> button.

The generated output depends on the testing procedure. All of the test procedures record data to the Waveform Data and Analysis Information files. The single channel test generates an additional Single Channel file.

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<sup>33</sup>Waveforms collected from flagged channels are ignored during the primary test

All files are written in text-based output and formatted so that they are human-readable. Only the layout of the Waveform Data is explicitly defined below; it is designed to be parsed by the analysis framework (see chapter 4) and must follow a strict formatting structure. The contents of the two other file types are self-explanatory. The headers and footers of the files all contain the same information.

#### 3.5.4.1 Waveform Data

**Naming:**     \*.txt

**Purpose:**     Stores the measurement values of the collected waveforms

The Waveform Data file is the primary method of transferring the data collected by EtherDaqGUI to the analysis framework. The file format, shown in Table 3.1, is well defined so that the analysis framework can parse it correctly. Any changes to the format made in EtherDaqGUI will need to be also implemented in analysis framework—no time was invested into maintaining an option for backwards-compatibility with different formats since the additions to EtherDaqGUI were essentially finalized when development on the analysis framework was begun.

Lines containing waveform data begin with ‘Sample.’ All other lines are either empty or begin with a ‘#’ symbol. This syntax removes the need to specify the number of waveform data entries in each data block; parsing of the waveform data ‘Sample’ lines continues until the ‘#’ character is encountered. The remainder of that line is then parsed to determine whether to read another data block or the file footer.

#### 3.5.4.2 Analysis Information

**Naming:**     \*.ana

**Purpose:**     Contains a quick overview of the analysis parameters and results

The first data block contains all the test parameters from the <Advanced Settings> dialog, which govern the data collection and preliminary analysis behaviors. This

**Table 3.1** – Waveform Data File Contents

Line	Description	Format
<i>Header</i>		
B1	comment	# <S purpose of file >
B2	EtherDAQ serial number	# EtherDAQ ID: <S>
B3	preamp identification	# Preamp ID: <NNNN>-<NNNN>
B4	original save directory	# File save directory: <S path >
B5	save name	# File save name: <S name >
B6	test start date	# Start Date: <X month >-<X day >-<X year >
B7	test start time	# Start Time: <X 24hour >:<X min >:<X sec >
<i>Data blocks, repeated, one per subphase</i>		
R1	phase voltage	#### voltage: <F> ####
R2	initial temperature	#### Temperature: <F> ####
R3	waveform data	Sample Time:<H> Ch<NN channel > <X values >...
...		
R<X>	waveform data	Sample Time:<H> Ch<NN channel > <X values >...
<i>Footer</i>		
E2	test end date	# End Date: <X month >-<X day >-<X year >
E1	test end time	# End Time: <X 24hour >:<X min >:<X sec >

This table uses substitutions; see table A.2 for more information

'B' represents a line relative to the beginning of the file

'E' represents a line relative to the end of the file

'R' represents a line relative to the beginning of a repeated block

information is available be parsed by the analysis framework in addition to the Waveform Data file.

If the optional Burn-in procedure was selected then a Burn-in section is included in the output. The Burn-in section contains a list of all the spurious waveforms detected during the Burn-in for each channel.

A Waveforms block follows, with sections for each of the selected test procedures. This block contains tabulated data of the average waveform amplitude in each subphase for each channel. The total number of waveforms collected is then

reported. Lastly, the configuration details of each subphase are reported, as well as the EtherDAQ temperature at the beginning of that subphase.

### 3.5.4.3 Single Channel

**Naming:** \*.csv

**Purpose:** Reports the statistics for the channel over all the voltage phases

The Single Channel file is designed to provide more in-depth analysis information than the Analysis Information file, but is generated only by the Single Channel test procedure. Further, it's structure is somewhat different from the other two files. It is written as a csv<sup>34</sup> file, which eases importing the data into a spreadsheet application when quick-turnaround analysis is required—most spreadsheet applications have the functionality for quickly importing and plotting csv-formatted data. An additional advantage is that no further development was required, in either the analysis framework or in creating a new program, to work with this new data type.

The main focus of the file is tabulated analysis data for each of the pulses in each subphase. The gains are reported, as well as the pedestal and plateau values and uncertainties.

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<sup>34</sup>comma separated value

# Chapter 4

## Analysis Framework

An analysis framework is needed to perform the data analyses required for the routine calibration of the E/p card pairs. The primary requirement is a flexible design that allows for a variety of analysis methods and tools, adaptable for future needs and developments. The framework must also be able to load data generated by the test stand and provide powerful tools for visualization and interrogation. Finally, it must be capable of generating the calibration constants for use in the NIFFTE reconstruction software.

The name of the analysis framework is Preana, for preamp analysis. Preana is an extensible, intuitive platform for interfacing with the test stand data to perform calibration analysis. Preana loads the Waveform Data files generated by EtherDaqGUI, which data are then fully available to the user for plotting and analysis. The Minuit2 minimization library is built into Preana, and provides an extensive suite of tools for fitting the test stand generated waveforms, extracting fitted parameters, and performing statistical analyses. The framework provides users with an initial example set of fit functions that can be easily modified or

replaced for more exacting analyses. These analyses are required to obtain the parameters used for the calibration measurements.

Preana also contains a dynamic and resizable interface. The capability for a larger window size is especially useful when dealing large analyses or multiple data sets. Another feature is that Preana is task-specific, which allows for optimization of the analysis speed and efficiency. The code framework is designed to enable development of the required tasks while allowing for flexibility in future developments.

## 4.1 Design

Preana is written in C++, compiled using Microsoft Visual Studio against the Windows native API<sup>1</sup>, and contains extensive application of oop<sup>2</sup> concepts and meta-programming techniques.

The GUI is designed to be clean and intuitive. A main menu provides access to all the functionality. A group of panes across the top, collectively known as the <Data Browser>, is used to navigate the data sets currently loaded into memory. <Progress Manager> windows display the progress to completion for all running jobs, and automatically hide themselves when no jobs are left. The remaining space is reserved for the <Analysis Display>, which is used to display the <Waveform Display> and <Histogram Display> windows. The <Analysis Display> always contains a <Preview Pane> window, which is identified by the light gray 'WAVEFORM PREVIEW' text. It is used to quickly preview a waveform selected in the <Waveforms> pane.

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<sup>1</sup>application programming interface

<sup>2</sup>object-oriented programming

Internally, the test data are stored hierarchically. This provides intuitive access for the user and simpler storage controls for the programmer. This also reduces the amount of redundant information involved in uniquely identifying or categorizing a waveform during analysis.

A few external packages are incorporated into Preana to support its work. The primary external package is Minuit2, a package for performing minimization. Minuit2 is used to fit representative functions to the waveform data and extract the best-fit function parameters and fit uncertainties. Preana also has the ability to export the results and statistics of these fitting analyses for external validation and verification by the ROOT Data Analysis Framework.<sup>3</sup> The other packages, libpng and libjpeg,<sup>4</sup> provide the ability to save any visualizations as images.

Preana also contains a detailed job-scheduling system—many of the analysis tasks can be run in parallel. Modern computing systems often contain multiple processing units, whether logical or physical. Scheduling multiple jobs harnesses this available computing power to speed up the analysis process. Included with the job scheduling system is an event-based signaling interface.

### 4.1.1 GUI Framework

Although the extensively documented Windows API is modernized for use with C++, its design is not inherently oop-friendly. The Windows API is based on a message-passing system to function. These messages are used to control and interact with the GUI elements. GUI elements are entities such as windows, dialog boxes, menus, and buttons.

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<sup>3</sup>More information on ROOT can be found at the project website: <https://root.cern.ch/>

<sup>4</sup>libpng depends on the package zlib, which is also included but not used directly by Preana.

A specialized function, called a message handler, is used to process the messages and perform the required action.<sup>5</sup> All of these message handlers must exist as static functions. Otherwise, the compiler is unable to match the function signature to the form required by the Windows API. This process is fairly simple as long as there is only one window per message handler. The process becomes more complicated if multiple elements based on the same message handler are required. The process becomes even more complicated when developing in a pure oop fashion.

#### 4.1.1.1 Base Window Class

The template `WinProcClass`<sup>6</sup> leverages `CRTP`<sup>7</sup> capabilities to overcome the difficulty of meshing the Windows API requirements with oop design ideals. It is used to pair a window to a controlling singleton class. An example is the `AboutWindow`<sup>8</sup> class.

`WinProcClass` contains the necessary static function, `WinProcClassStatic()`,<sup>9</sup> to be compiled properly against the Windows API. The `CRTP` is what allows a unique static function to be created for each derived class. There are also two pure virtual function that must be implemented by any derived class: `MessageHandler()`<sup>10</sup> and `OpenWindowSpecific()`.<sup>11</sup> These two functions are declared as protected so that only a derived class has access.

---

<sup>5</sup>Behaviors are usually well-defined and understood for elements such as buttons. A defined message handler is not required—the Windows API uses an internally-defined message handler to provide the default behavior.

<sup>6</sup>`WinProc Class.h`

<sup>7</sup>curiously recurring template pattern

<sup>8</sup>`About Window. (h/cpp)`

<sup>9</sup>`WinProc Class.h:28-31`

<sup>10</sup>`WinProc Class.h:49-52`

<sup>11</sup>`WinProc Class.h:53`

MessageHandler() is a non-static member function that processes the messages as desired. One of three values must be returned back to WinProcClass, depending on the result of the processing. These are: 1) WINPROC\_MESSAGE\_COMPLETED, 2) WINPROC\_MESSAGE\_NEEDS\_MORE, or 3) WINPROC\_MESSAGE\_NOT\_PROCESSED.

OpenWindowSpecific() must actually create the window. This is typically performed with the Windows API CreateWindowEx() function. The derived class can perform any necessary initializations for its child windows in this step. The handle to the newly created window must be returned.

Three other virtual functions are optional and needed only if the window processes commands in a non-default manner: CommandAccelerator(),<sup>12</sup> CommandControl(),<sup>13</sup> and CommandMenu().<sup>14</sup> Any implementation of these functions must also return one of three values back to WinProcClass. These are: 1) WINPROC\_COMMAND\_PROCESSED, 2) WINPROC\_COMMAND\_TERMINATE, or 3) WINPROC\_COMMAND\_NOT\_PROCESSED.

#### 4.1.1.2 Dynamic Sizing

WinProcClassDynamicSizing<sup>15</sup> builds on the foundation of WinProcClass to add dynamic resizing capabilities. It is itself another CRTP. A class derived from WinProcClassDynamicSizing automatically contains built-in functionality to react to size changes in the parent window. Additionally, it contains itself to a designated area within the parent window. Examples of derived classes are DataBrowser<sup>16</sup> and ProgressManagerCRTP.<sup>17,18</sup>

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<sup>12</sup>WinProc Class.h:42

<sup>13</sup>WinProc Class.h:44-46

<sup>14</sup>WinProc Class.h:47-48

<sup>15</sup>WinProc Class Dynamic Sizing.h

<sup>16</sup>Data Browser.(h/cpp)

<sup>17</sup>Progress Manager CRTP.h

<sup>18</sup>The ProgressManagerCRTP class is discussed further in section 4.1.4.

This capability requires the use of the `CM_WINDOW_PARENT_RESIZED` notification message. A dynamic resizing window will only query the status of its parent window, and resize if needed, upon receipt of this message. A window containing dynamically-sizing child windows must send this message only after it has completed resizing. Otherwise the information a child window retrieves about its parent window may be outdated and incorrect. The result of a mistimed notification will cause undefined behavior.

The `MessageHandler()` interface is changed by `WinProcClassDynamicSizing`—it is replaced with `DynamicWindowMessageHandler()`,<sup>19</sup> another pure virtual function. The expected return values are identical.

Finally, an additional virtual function `ResizeAndRelocateWindow()`<sup>20</sup> is available. It provides default behavior for resizing upon receipt of the `CM_WINDOW_PARENT_RESIZED` message. It can be overridden if further actions are required. In some situations it is desirable to both maintain default behaviors as well as provide specific functionality; the preferred solution is to use scoping<sup>21</sup> instead of copying and pasting code.

#### 4.1.1.3 Managing Multiple Windows

Support for multiple windows is implemented with two layers of abstraction. The first, `DisplayBase`,<sup>22</sup> is a standard C++ abstract class. The second, `DisplayCRTP`,<sup>23</sup> is essentially a CRTP wrapper around `DisplayBase`. The CRTP usage causes the compiler

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<sup>19</sup>`WinProc Class Dynamic Sizing.h:42-45`

<sup>20</sup>`WinProc Class Dynamic Sizing.h:39-41`

<sup>21</sup>For an example of usage, see the overriding function `ResizeAndRelocateWindow()`, `Analysis Display Organizer.cpp:468-504`

<sup>22</sup>`Display Base.(h/cpp)`

<sup>23</sup>`Display CRTP.h`

to create a unique static message handler for each derived class. Thus, classes that are designed to support multiple windows must inherit directly from `DisplayCRTP`.

Multiple windows are managed by storing each class instance pointer as a value in the user data<sup>24</sup> of the associated window. The static message handler retrieves the user data using the window handle accompanying a message. The result is cast to a `DisplayBase`<sup>25</sup> pointer, which is then used to call the class-specific message handler. `DisplayProc()`<sup>26</sup> provides the required static message handler, and `MessageHandler()`<sup>27</sup> is the pure virtual message handler that must be implemented in the derived classes.

All derived classes are responsible for painting both the background and foreground of the window. This mandate is enforced by the pure virtual function `PaintForeground()`<sup>28</sup> and `PaintBackground()`.<sup>29</sup> An additional pure virtual function, `PostPaint()`,<sup>30</sup> provides a hook for performing operations after the painting process is completed.

#### 4.1.1.4 Main Window

The `MainWindow`<sup>31</sup> class is the core of Preana. It inherits directly from `WinProcClass`, contains Preana's main message handler, controls the GUI, and is responsible for the management of the top-level data. It also is responsible for controlling data access permissions between other objects.

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<sup>24</sup>The user data can be retrieved and set using `GetWindowLongPtr()` and `SetWindowLongPtr()`, with `GWLP_USERDATA` as the parameter name.

<sup>25</sup>`Display Base.cpp:123`

<sup>26</sup>`Display Base.h:48-51`

<sup>27</sup>`Display Base.h:53-56`

<sup>28</sup>`Display Base.h:62-63`

<sup>29</sup>`Display Base.h:57-58`

<sup>30</sup>`Display Base.h:69-70`

<sup>31</sup>`Main Window.(h/cpp)`

The main window, operated by `MainWindow`, contains a number of child windows. These are the `<Data Browser>`, the `<Analysis Display>`, and a few progress managers. Each of the child windows are based on `WinProcClassDynamicSizing` so that they can react to resizing events.

`MainWindow` also manages the data analysis. Analyses are requested by the user through either the main menu or the `<Data Browser>`. A message with the necessary information is dispatched to `MainWindow`, which then creates the operation and queues it with the appropriate progress manager.

### 4.1.2 Data Storage

Tests are loaded into `Preana` using the main menu, and are expected to include data from all 32 channels. The menu navigation for loading test data is: `<File>` `▷ Load Preamp Card ▷ (Select test type)`. A `<File Preview>` pane is displayed at the bottom of the dialog box when selecting files. This makes it easy to visually verify the file contents that are being loaded.

The internal data are frozen once they have been imported by declaring them as `const` data types, i.e. the values cannot be changed. The test data are organized in a hierarchical tree-like structure. Each instance of a data storage class uses a vector to stores instances of the next-level-down data class.

#### 4.1.2.1 Loading Data Sets

A cross talk procedure data set is assumed to have a complete set contained in one file, while a single channel test is inherently split up over 32 files. Loading data from a single channel procedure requires the selection of the corresponding file for each channel. Two methods, manual or automatic (see fig. 4.1a), are available

for the single channel file selection. The automatic mode allows the user to select a directory (see fig. 4.1b) to scan for matching files.<sup>32</sup> The directory scan results are transferred into the file selection dialog (see fig. 4.1c). The user can then add or correct the results of the scan.

The file selection dialog is also used for the manual mode. However, it is not pre-filled with any file names. It is highly recommended that the single channel test files be appropriately named and grouped in directories sorted by E/P pairing to take advantage of the time-saving automatic mode. Manually selecting all 32 files should be done only in dire circumstances.

#### 4.1.2.2 Classes

##### Test

The test type is based on the origin of the data. Three test types are currently implemented, and are listed in table 4.1. All test types derive from the `TestBase`<sup>33</sup> class, which contains the top-level functions for loading data sets, analysis, and exporting results. It also declares three pure virtual methods, which must be implemented by derived classes. These are `Analyze()`,<sup>34</sup> `CalculateDiagonal()`,<sup>35</sup> and `FillExportData()`.<sup>36</sup>

`Test Base` contains `LoadFile()`,<sup>37</sup> a universal function for opening data files. A derived class is responsible for calling `LoadFile()` for each file that needs processed. `LoadFile()` first prepares the class instance for receiving the data and then queues

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<sup>32</sup>The directory scan examines the file names for a pattern matching 'Ch<XX>'

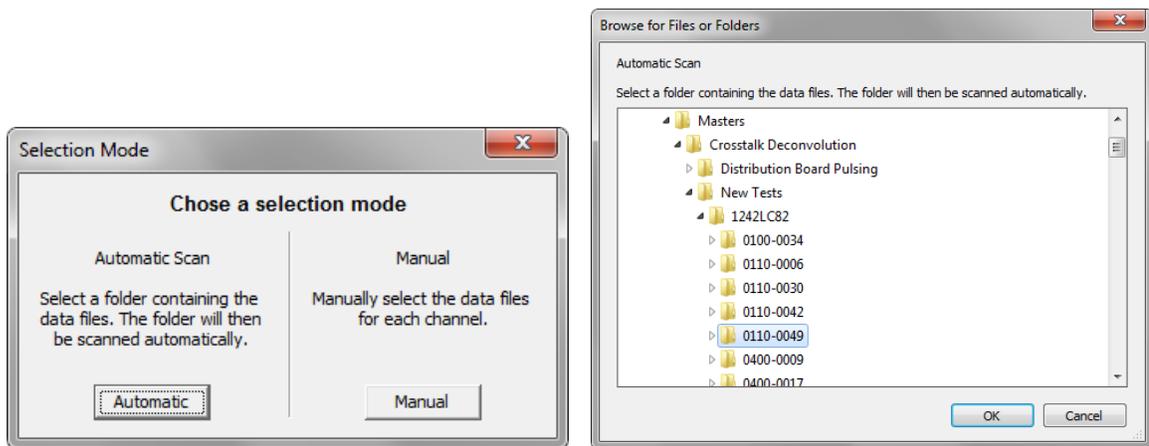
<sup>33</sup>`Test Base.(h/cpp)`

<sup>34</sup>`Test Base.h:58`

<sup>35</sup>`Test Base.h:59`

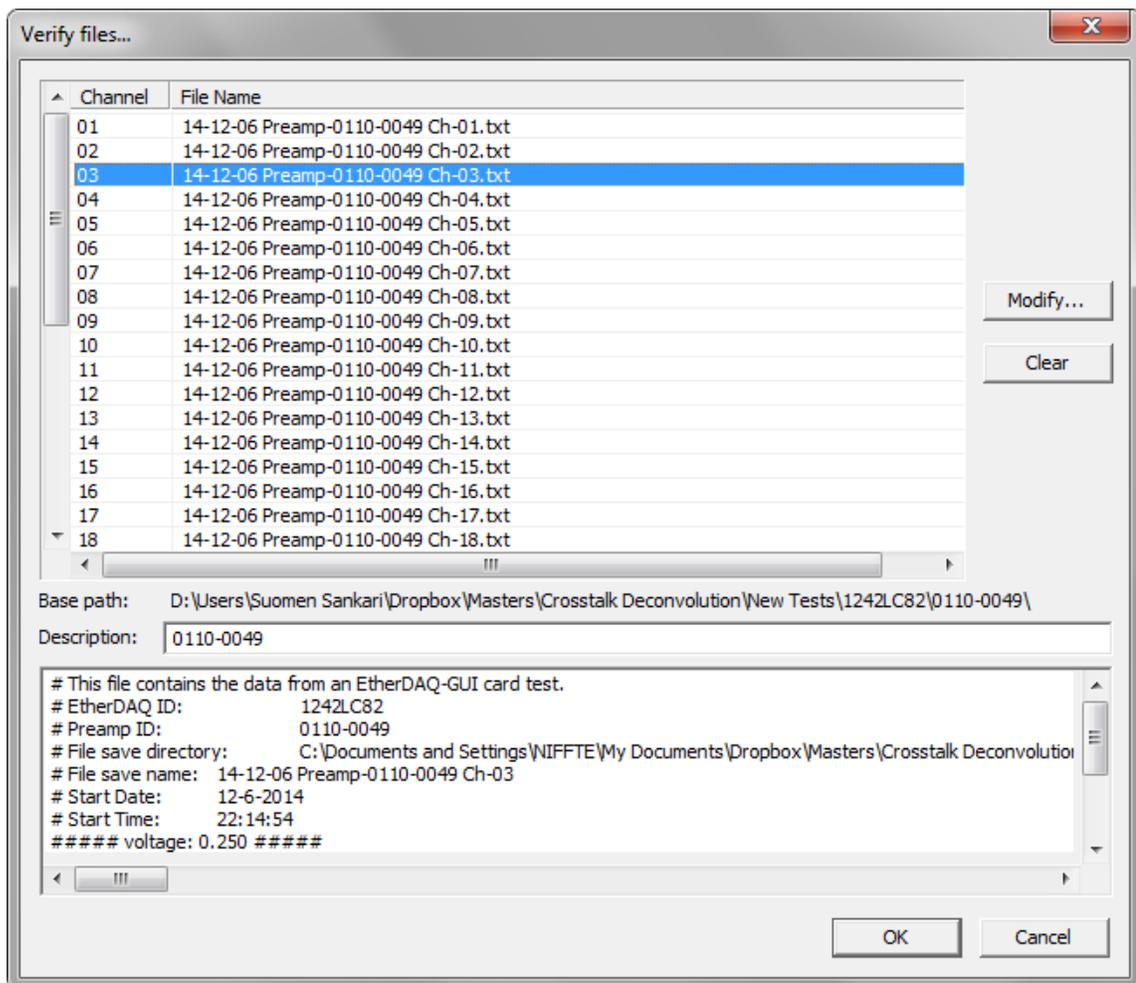
<sup>36</sup>`Test Base.h:63-64`

<sup>37</sup>`Test Base.h:66-67`



(a) Selection Mode

(b) Folder Browser



(c) File Selection

Figure 4.2 – Single Channel File Selection

**Table 4.1** – Test Types

<b>Name</b>	<b>Contents</b>
<b>Distribution</b>	Cross talk test data, performed using the breakout board to simultaneously pulse all 32 channels.
<b>Single Channel</b>	Single channel test data, performed using the single channel approach to individually test each channel.
<b>Comparison</b>	Results of an analytical comparison results between two or more tests of any test type.

the process with `FileLoadingProgressManager`.<sup>38</sup> Another function, `QueueAnalysis()`,<sup>39</sup> queues the analysis for a channel with `AnalysisProgressManager`.<sup>40</sup> Derived classes use this function to perform the actual analyses when implementing `Analyze()`.

Both `...ProgressManager` classes are job schedulers, and described in further detail in section 4.1.4.

### Card Pair

`CardPair`<sup>41</sup> exists primarily because of the data set segmentation—splitting over multiple files—of the single channel test type. An instance of `CardPair` stores the extracted data from just one file. Thus, a distribution-type test will store only one `CardPair` instance, while a single channel-type test will store thirty-two.

Although `TestBase` is responsible for adding tasks to the queue, `CardPair` is the class that actually contains the functions for performing the data parsing and analysis tasks. These are, respectively, `LoadData()`<sup>42</sup> and `RunAnalysis()`.<sup>43</sup> Both

<sup>38</sup>File Loading Progress Manager.h

<sup>39</sup>Test Base.h:70-72

<sup>40</sup>Analysis Progress Manager.h

<sup>41</sup>CardPair.(h/cpp)

<sup>42</sup>Card Pair.h:44

<sup>43</sup>Card Pair.h:53

functions are written for use in a threading context, which is the core of the parallelization capabilities of Preana.

Thread-contextual functions must be static and can have only one argument to match the required function signature. `CardPair` is equipped to work with this restriction. Two functions, `MakeLoadingProgressBarParameters()`<sup>44</sup> and `MakeAnalysisProgressBarParameters()`,<sup>45</sup> each create a structure that contains all the necessary parameters. The pointer to a structure is passed in as the single argument. The function is then able to extract the information inside the structure and perform the job correctly.

### **Channel**

The `Channel`<sup>46</sup> class is very simple. It exists primarily to provide a logical structure to the data.

### **Phase Set**

Much like `Channel`, the `PhaseSet`<sup>47</sup> class is primarily an organizational entity. However, it does have a unique identifying function: `IsPulsedPhase()`.<sup>48</sup> This function returns true if its class's data correspond to a primary pulse generated during a test procedure.

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<sup>44</sup>`Card Pair.h:48-50`

<sup>45</sup>`Card Pair.h:45-47`

<sup>46</sup>`Channel.(h/cpp)`

<sup>47</sup>`Phase Set.(h/cpp)`

<sup>48</sup>`Phase Set.h:38`

## Voltage Set

The data stored by the VoltageSet<sup>49</sup> class maps to the data collected during a subphase. A subphase is identified by the voltage of the driving pulses, hence the class name.

VoltageSet, in addition to its organizational role in the data hierarchy, is responsible for aggregating the analysis results from the waveforms it contains.

## Waveform

Waveform<sup>50</sup> is the foundation of the data storage and analysis for Preana. Each instance holds the data values and analysis results for a single waveform.

The waveform values are stored in a const vector. The dynamic array capabilities of the vector avoids restrictions or requirements on the length of the waveform, i.e. how many data values it contains. The const qualifier prevents any future modification of the values. This allows a reference or pointer to the vector to be passed around without fear of accidental or intentional modification.

### 4.1.3 Data Exploration and Interrogation

The <Data Browser> is designed to provide intuitive access to the data, from picking a test for analysis to selecting a waveform to view. The <Data Browser> contains five panes for browsing the data. The order of the panes is nearly identical to the internal data hierarchy (see section 4.1.2.2).

The <Data Browser> is linked closely to the <Analysis Display> area, where all the display windows are shown. Together, the two provide the primary interface of Preana (shown in fig. 4.3).

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<sup>49</sup>Voltage Set(.h/cpp)

<sup>50</sup>WaveForm.(h/cpp)

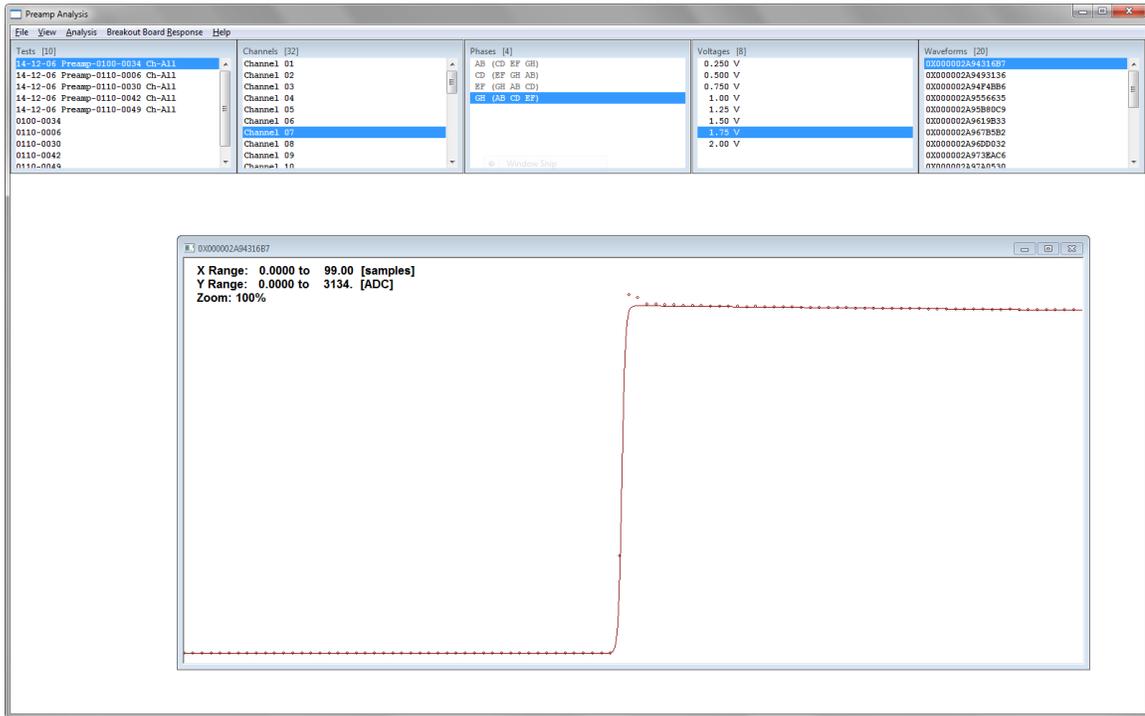


Figure 4.3 – Data Browser and Analysis Display

#### 4.1.3.1 Data Browser

##### Tests

First, the <Tests> pane lists the loaded test data sets. Only Distribution and Single Channel tests (see section 4.1.2.2) are listed. Left-clicking on a test will highlight it and permit the selection of an item in the <Channels> pane. A right-click displays a pop-up menu with analysis options. The pop-up menu also contains a <Delete test> item, the only current mechanism for deleting a loaded test from memory.

Text and highlighting colors are used to represent the current status of a test. A selected test will be highlighted using the system-defined color, typically blue. A test with an error will be highlighted with orange.<sup>51</sup> Normal text is displayed

<sup>51</sup>RGB value of 0xFF9900

using the system-defined color, typically black. Gray text indicates that the test is currently being loaded from data files. Blue text means the test is currently being analyzed. Green text means that the analysis results are being exported. Red text means the test is being deleted from memory.

### **Channels**

Next is the <Channels> pane, which always displays items for all 32 channels. However, the list items are displayed in black and selectable only when a valid test is selected. Otherwise, the items are displayed in a gray text and cannot be selected.

### **Phases**

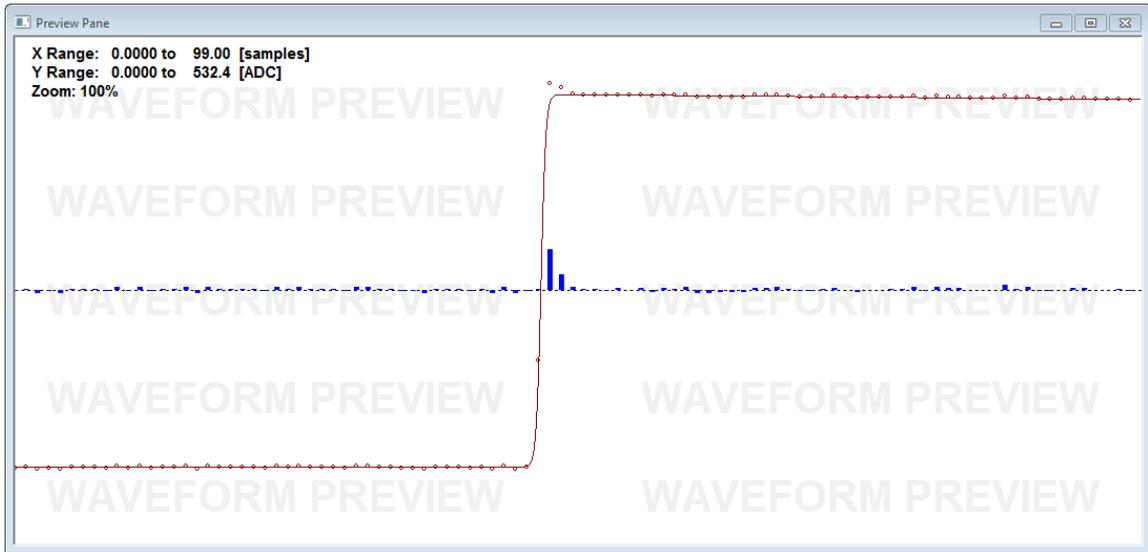
The third pane, <Phases>, lists all the recorded phases for the selected channel. In the event of a single channel test only one phase is listed. A cross talk test will have four, with the primary phase in black and the three secondary phases in gray—all the phases are selectable, the coloration is provided only for identification purposes. A right-click on an item displays a pop-up menu with analysis and plotting options.

### **Voltages**

Fourth, the <Voltages> pane list the subphases. A right-click on an item displays a menu with analysis and plotting options.

### **Waveforms**

Fifth, the <Waveforms> lists all the waveforms in the selected subphase. Special mouse actions are available in this pane. A single left-click displays the waveform



**Figure 4.4** – Preview Pane

automatically in the <Preview Pane>, shown in fig. 4.4. A double left-click opens the waveform up in a new <Waveform Display> window. A Ctrl+left-click adds the waveform to the top-most <Waveform Display> window. A right-click displays a pop-up menu with extended options for analysis or plotting.

#### 4.1.3.2 Analysis Display

The <Analysis Display> window is managed by the `AnalysisDisplayOrganizer`<sup>52</sup> class, and covers roughly 80% of the main window. Initially <Analysis Display> contains only an empty <Preview Pane>. It can support child windows that inherit from `DisplayCRTP` (see section 4.1.1.3); currently only `WaveformDisplay`<sup>53</sup> and `HistogramDisplay`<sup>54</sup> are implemented.

All classes that inherit from `DisplayBase` have a built-in pop-up window. The option to export the contents of the window to an image file is usually available.

<sup>52</sup>`Analysis Display Organizer.(h/cpp)`

<sup>53</sup>`Waveform Display.(h/cpp)`

<sup>54</sup>`Histogram Display.(h/cpp)`

A derived class can add more options by overriding `ProcessContextMenu()`.<sup>55</sup> An example is shown in `WaveformDisplay::ProcessContextMenu()`.<sup>56</sup>

`AnalysisDisplayOrganizer` is derived from `WinProcClassDynamicSizing`, although the child windows it contains do not. As such, `AnalysisDisplayOrganizer` dynamically resizes any child windows as its size changes. This prevents a child window from becoming lost in the virtual coordinate space that exists beyond the window viewport.<sup>57</sup>

## Waveform Display

`WaveformDisplay` is designed around the need to display one or more waveforms in an accessible manner. Each waveform is drawn as a line with a unique color and pattern. Eight colors and four patterns are available, which allows up to 32 waveforms to be simultaneously and uniquely displayed. Figure 4.5 shows a `WaveformDisplay` plotting together one waveform from each subphase of a phase. Note that the window title includes the number of waveforms it contains.

A number of navigation controls assist in inspecting the waveforms, and are summarized in table 4.2.

The Preview Pane is a specialized application of `WaveformDisplay`. It has a permanent watermark in the background and can only display one waveform at a time. If a fit has been performed on the displayed waveform then residual bars are drawn, showing the difference between the fit and the actual values at three times the waveform scale. Blue bars are normal, while red bars indicate that the scaled value

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<sup>55</sup>`Display Base.h:64-65`

<sup>56</sup>`Waveform Display.cpp:786-815`

<sup>57</sup>The Windows API uses the top-left had corner the origin, with positive directions being down and left. However, nothing prevents any part or all of a child window from moving outside of the edges that define the parent window's borders. As such, anything that causes a child window to exist beyond these edges would effectively hide it from the user—it would become lost and unusable—all the while continuing to exist in memory and consuming processing resources.

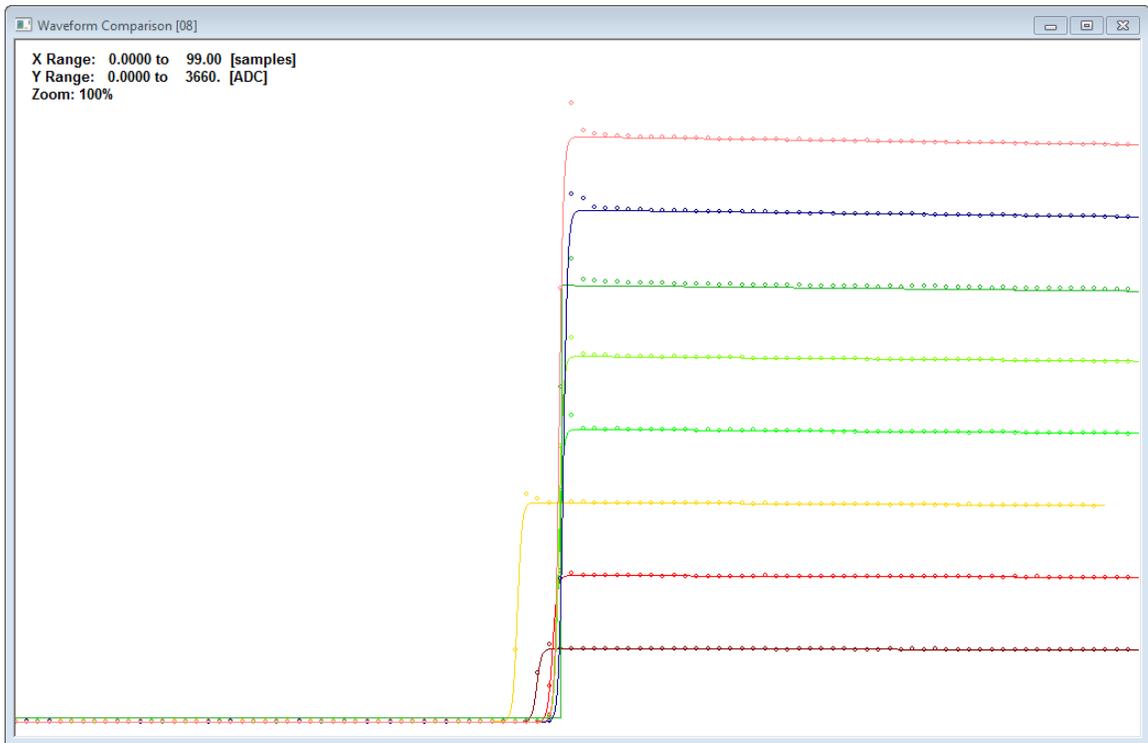


Figure 4.5 – Display of Multiple Waveforms

Table 4.2 – Waveform Display Controls

Mouse Event	Action
Double Left-click	Zooms in on the location of the cursor using the current aspect ratio
Left-click + Drag	Moves the view with the mouse cursor
Right-click	Opens a pop-up menu with options for saving the current view as an image or changing the zoom level
Right-click + Drag	Draws a zoom box, which becomes the new view when the button is released
Scroll Wheel	Zooms in or out using predefined increments centered on the mouse cursor; resets the aspect ratio

exceeds the view. Finally, the right-click pop-up menu contains only an option for exporting the contents to an image file.

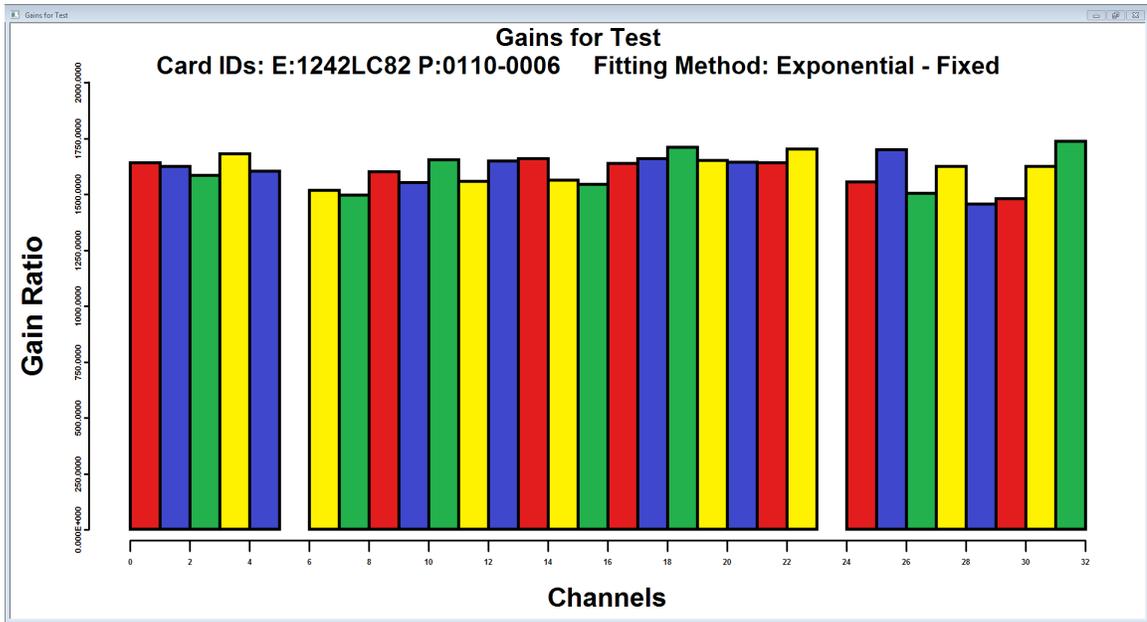
### **Histogram Display**

`HistogramDisplay` is a custom-built 1D histogram viewer. Its behavior is customizable, and can include any of the following items:

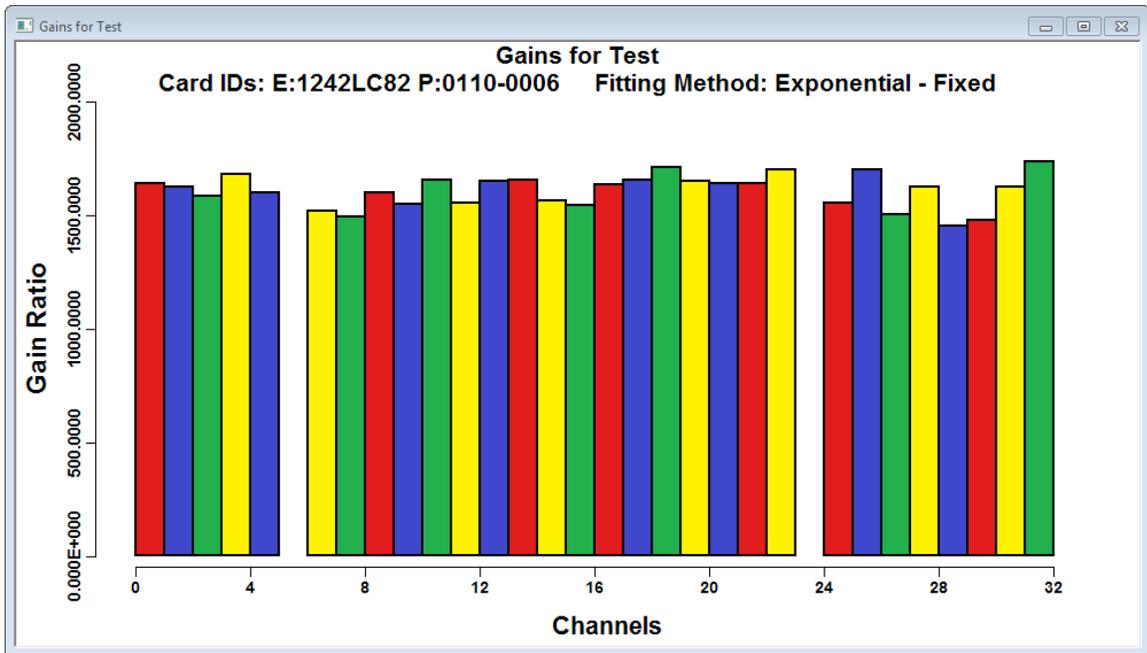
- displaying different data sources
  - dynamically generated bin edges and values from a vector of data
  - pre-calculated bin edges and values
- auto-sizing text labels based on window size (title, axes, bins)
- error bins on either side for out-of-range values
- support for programmer-defined bin colors

An example is shown in fig. 4.6, which exhibits the text auto-sizing and bin color features. Both subplots display the same histogram. Only the window size is different. Figure 4.6a is maximized to fill the entire `<Analysis Display>`, and fig. 4.6b is 75% smaller. The relative sizes of the text are essentially equivalent, while the number of axis tick marks are different. Differences are also seen in the size of the windows' title bars. The colors correspond to the bank colors established within the NIFFTE collaboration (see fig. 2.3).

Typically the histograms are used to plot aggregated results from analyses. However, the `HistogramDisplay` is also used to display the results of a comparison test.



(a) Full Window Size



(b) 25% Full Window Size

Figure 4.6 – Text Auto-sizing

### 4.1.4 Job Scheduling

Threading and job scheduling are necessary components of any heavy-duty analysis system. Any long or resource-intensive tasks should be performed on a thread separate from the message queue, especially because of the way Windows interacts with programs—performing a long operation within the message queue causes the application to appear unresponsive or frozen.

Threading is a powerful tool for performing parallelizable tasks. In Preana, the tasks for the loading and the analysis of tests are both extremely parallelizable. These characteristics harness the available system resources and reduce the overall duration of an analysis.

#### 4.1.4.1 Thread Management

The core of Preana's thread scheduling and management is the `CRTP ThreadManager`.<sup>58</sup> A thread manager is necessary to prevent a large number of simultaneous threads from monopolizing resources and choking system-wide responsiveness. For example, the analysis of a test spawns 32 threads, one for each channel. An average workstation would bog down the intensive workload if all 32 threads were running simultaneously. Instead, `ThreadManager` queues all the threads, then runs a limited number of threads concurrently. The next thread in the queue is started once a running thread ends, until the queue is emptied.

A instantiating class of `ThreadManager` provides two arguments to the constructor. The first, the refresh rate interval, specifies the frequency at which the managed threads statuses are polled. The second, the maximum number of concurrent threads, limits the number of threads the manager can have executing simultane-

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<sup>58</sup>`Thread Manager.h`

ously. The implementing class is permitted to provide the limit, which should be based on an understanding of the underlying resource loads and system hardware capabilities. For example, three derived classes use the number of CPUs<sup>59</sup> available to determine this limit.<sup>60</sup>

ThreadManager uses a template class ThreadTable<sup>61</sup> to store the information about queued and running threads. All threads require the creation of dynamically allocated data structures to store the execution information and parameters. ThreadTable assumes ownership of these dynamically allocated data, and deletes them when the associated thread is removed.

The thread management involves transitioning threads between events based on the thread status. For example, a thread process must have ended before its associated data can be deleted. Premature deletion of data will cause a program error and possible termination. The AdvanceFromThreadEvents()<sup>62</sup> is primarily responsible for managing changes in thread statuses.

#### 4.1.4.2 Progress Visualization

Most tasks that are parallelizable are lengthy process. Also, they are intrinsically capable of reporting progress to completion. Finally, the user experience is greatly enhanced by a visualization that implies work is being done.

This functionality is implemented by ProgressManagerCRTP, which extends both ThreadManager and WinProcDynamicSizing, in order to manage jobs and display progress. The CRTP form allows for specialization based on the task. Currently, three classes that provide concrete implementation: FileLoadingProgressManager, Analysis-

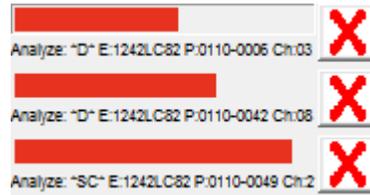
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<sup>59</sup>central processing units

<sup>60</sup>The three classes that used knowledge of the system hardware are: Analysis Progress Manager.cpp:32, File Loading Progress Manager.cpp:28, and Simple Function Thread Controller.cpp:17

<sup>61</sup>Thread Table.h

<sup>62</sup>Thread Manager:135-208



**Figure 4.7** – Progress Manager

ProgressManager, and ChainedProgressThreadManager.<sup>63</sup> Figure 4.7 shows an example of a progress window displaying the progress of three analysis threads.

ProgressManagerCRTP is designed such that any derived class needs only to define a four static variables. Two variables control the appearance of the progress bars by specifying the color and text descriptors, and the other two work with the Windows API to generate a unique window instance.

#### 4.1.4.3 Thread Parameters

Preana includes a suit of CRTP modules that simplify the creation and organization of the thread parameter structures. Each module is created for a specific task and stores the required data. There are modules currently for animation, sequence locked execution, progress reporting, self identification, and window support.

A base class, BasicThreadParameters,<sup>64</sup> provides the common data that all threads require. This, combined with the aforementioned modules, create the thread parameter classes: AnimateWindowThreadParameters,<sup>65</sup> ChainedProgressThreadParameters,<sup>66</sup> ManagerThreadParameters,<sup>67</sup> ProgressBarThreadParameters,<sup>68</sup> and SimpleThreadParameters.<sup>69</sup>

<sup>63</sup>Chained Progress Thread Manager.h

<sup>64</sup>Basic Thread Parameters.(h/cpp)

<sup>65</sup>Animate Window Thread Parameters.(h/cpp)

<sup>66</sup>Chained Progress Thread Parameters.(h/cpp)

<sup>67</sup>Manager Thread Parameters.(h/cpp)

<sup>68</sup>Progress Bar Thread Parameters.(h/cpp)

<sup>69</sup>Simple Thread Parameters.(h/cpp)

One of the required template parameters for `ProgressManagerCRTP` and `ThreadManager` is the thread parameters class type. As a result, a thread manager class implementation is usually created for each of the thread types. This is by design so that each manager can perform specialized tasks as needed.

### 4.1.5 Data Fitting

The `Minuit2` minimization library is the core of Preana's analysis capabilities. `Minuit2` provides the extensive suite of tools for fitting the waveforms contained in the test stand data. These fit parameters are used to generate the calibration measurements required to provide precise TPC nuclear data measurements.

`Minuit2` is a C++ adaptation of the Fortran-based `Minuit` minimization routines. It is not a program or application unto itself, but rather source code that can be downloaded and integrated directly into a program.<sup>70</sup>

#### 4.1.5.1 Fitting

`Minuit2` minimization requires, at a minimum, the implementation of two classes: `FCNBase`<sup>71</sup> and `MnUserParameters`.<sup>72</sup> Each has its own unique requirements and pure virtual methods. A single class in Preana, `Fitting`, uses multiple inheritance to implement both classes. `FCNBase` is inherited as public, while `MnUserParameters` is inherited as protected. This is because of the methods in the former require external visibility, while it is safer to hide the data and a most methods of the latter.

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<sup>70</sup>The source is available from the project website: <http://seal.web.cern.ch/seal/snapshot/work-packages/mathlibs/minuit/>

<sup>71</sup>`FCNBase.h`

<sup>72</sup>`MnUserParameters.(h/cxx)`

Fitting is designed to be applicable to all current and any future fitting needs in Preana. Although the current application fits only waveforms, other applications are possible. For example, it could be used to fit a cumulative distribution of fitting results. The only requirements are that it be provided with a handle to the function for fitting (refer to section 4.1.5.2), a vector of data to fit, and parameter seeds.<sup>73</sup> A companion vector of data uncertainties may also be provided, but is not required.

Methods for controlling the minimization process are also provided. These include limit setting of valid parameter ranges, fixing a parameter, and providing parameter uncertainties. The `operator()`<sup>74</sup> function provides the  $\chi^2$  value calculation.

The actual fitting is started by calling `Fit()`.<sup>75</sup> The fitting uses the `MnMigrad`<sup>76</sup> minimizer by default. During the fitting `Minuit2` performs a search to find the parameter values that minimize the  $\chi^2$  value provided by the `Fitting` class instance. `Minuit2` also inherently performs its own error calculations on the parameter values as it converges on a solution.

When the fitting is completed all unnecessary data are erased to preserve memory.<sup>77</sup> The resulting fit parameters and calculated errors are stored locally and accessible via the getter functions. Finally, a  $\chi^2$  value without parameter weighting is calculated and stored.

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<sup>73</sup>Fitting.h:26-29

<sup>74</sup>Fitting.cpp:225-231

<sup>75</sup>Fitting.h:32-34, Fitting.cpp:77-120

<sup>76</sup>MnMigrad.h

<sup>77</sup>The `FunctionMinimum` class, which stores the minimization results, is very large. Each `Waveform` contains an instance of `Fitting`, which contains an instance of `FunctionMinimum`. These quickly add up and consume system memory during an analysis.

#### 4.1.5.2 Base Function Class

The base function class is `AbstractFunction`.<sup>78</sup> The number of parameters is fixed upon initialization, so a derived class must provide the information either as an integer or a vector of initial parameter values. The Fitting class depends on concrete implementations of `AbstractFunction` to perform the fitting.

The core of `AbstractFunction` are the pure virtual functions `SetParameters()`<sup>79</sup> and `operator()`.<sup>80</sup> `SetParameters()` sets the function parameters. These are used in `operator()`, along with a position argument, to compute and return the evaluated function value.

Two more pure virtual function must be implemented by derived classes: `GetParameterName()`<sup>81</sup> and `IsValueImportant()`.<sup>82</sup> The implementation of `GetParameterName()` takes a parameter number argument and returns the parameter name as a string. `IsValueImportant()` is used to determine whether a particular location or value is important to the physical representation of the function.

#### 4.1.5.3 Fitting Selection

The fitting is controlled by a variable of enumeration type `FittingMethod`.<sup>83</sup> These values correspond to combinations of the fitting functions and minimization approaches. Table 4.3 contains the current list of options. The qualifiers, if more than one are used, are delimited by a '\_' character. The values are additive, e.g. `EXP_FUNCTIONFIT_FIX` contains the `EXP`, `FUNCTIONFIT`, and `FIX` qualifiers for a total value of 31.

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<sup>78</sup>`Abstract Function.(h/cpp)`

<sup>79</sup>`Abstract Function.h:34`

<sup>80</sup>`Abstract Function.h:33`

<sup>81</sup>`Abstract Function.h:27`

<sup>82</sup>`Abstract Function.h:31-32`

<sup>83</sup>`Fundamentals.h:188-207`

**Table 4.3** – Fitting Methods

Qualifier	Value	Meaning
ESTIMATED <sup>*,†</sup>	1	Use the first and mid-plateau datum to estimate the waveform properties
COARSE <sup>†</sup>	2	Scan the data for the transition, then average the data before and after to calculate the pedestal and plateau, respectively
EXP	20	Use an exponential function to fit the RC decay
LINEAR	40	Fit the RC decay with a simple linear function
ADAPTEDFIT <sup>‡</sup>	0	Fit each waveform with parameters seeded by the previously fitted waveform
FUNCTIONFIT	10	Independently fit each waveform
FIX	1	Fix the RC time constant so that it is not included in the minimization

\*Cannot be requested by the user; calculated only when first loading the data

†A test fit with this method cannot be used for generating a comparison test

‡Result of an attempt to optimize the minimization, no quantifiable effect has been found (see section 4.2.3)

The `FittingMethod` values are used internally by the data storage classes (see section 4.1.2) to determine which analysis approach to use. Specifically, the `Waveform` class requires a `FittingMethod`-type argument for its `Fit()`<sup>84</sup> function. `Waveform` then uses this value set up the fit configuration before using its instance of `Fitting` to perform the fitting.

#### 4.1.5.4 Implementation Example: Fermi Function Fit

Waveforms are best represented by a Fermi function with an added  $RC$ <sup>85</sup> decay component. This function fit implemented in the class `WaveformFunction`,<sup>86</sup> which inherits from `AbstractFunction`. The Fermi function is used in the form shown by eq. (4.1). Parameter  $A$  represents the pedestal height,  $B$  is the charge,  $C$  is the onset

<sup>84</sup>`Waveform.h:43`

<sup>85</sup>resistor-capacitor

<sup>86</sup>`WaveformFunction.(h/cpp)`

of the transition point,  $D$  is the rise curvature, and  $g(t)$  is the RC decay applied after the rise.

$$f(t) = \begin{cases} A + \frac{B}{\exp\left(\frac{C-t}{D}\right) + 1} & \text{when } C < t \\ A + \frac{B \times g(t)}{\exp\left(\frac{C-t}{D}\right) + 1} & \text{when } C \geq t \end{cases} \quad (4.1)$$

The RC decay is applied via the pure virtual function `GetDecayMultiplier()`.<sup>87</sup> Two forms are provided for the RC decay: the exact exponential form and an approximate linear form. Equation (4.2) is the form of exponential decay, and eq. (4.3) the form of linear decay. These are implemented in `WaveformFunctionExponential`<sup>88</sup> and `WaveformFunctionLinear`,<sup>89</sup> respectively. Parameter  $C$  is the onset of the transition point as before, and  $E$  is the decay constant.

$$g(t) = \exp\left(\frac{C-t}{E}\right) \quad (4.2)$$

$$g(t) = 1 - E \times (C - t) \quad (4.3)$$

`WaveformFunction` uses the `IsValueImportant()`<sup>90</sup> to indicate that the values surrounding the transition point are less significant. This is because of the presence of overshoot immediately after the transition, which otherwise will incorrectly increase the charge parameter.

#### 4.1.6 Statistics Template Class

An important part of the analysis process is calculating the statistical properties of distributions, such as a collection of channel gains. The preferred solution is a

<sup>87</sup>Waveform Function.h:53

<sup>88</sup>Waveform Function - Exponential.(h/cpp)

<sup>89</sup>Waveform Function - Linear.(h/cpp)

<sup>90</sup>Waveform Function.cpp:140-178

generalized statistics class that can be used for all numeric types. `Statistics`,<sup>91</sup> a template class, was developed and included in `Preana` to satisfy this need.

Frequently, calculating the width of a distribution requires two passes over the data. The first pass calculates the mean of the distribution, and the second pass uses the mean to calculate the standard deviation or RMS.<sup>92</sup> `Statistics` includes an algorithm for calculating both the mean and standard deviation in real time, i.e. while data are being added. No second pass is needed.

The algorithm requires calculating three parameters after each added value, using the formulas shown in eq. (4.4).  $n$  represents the total number of values,  $x$  is the new value, and  $\bar{x}$  is the running mean. These formulas have been thoroughly analyzed and found to be very robust, even when considering the effects of floating-point round-off errors. The zeroth values are all 0, and it is not necessary to preserve the old values.

$$\begin{aligned}\Delta_n &= x - \bar{x}_{n-1} \\ \bar{x}_n &= \bar{x}_{n-1} + \frac{\Delta_n}{n} \\ M_n &= M_{n-1} + \Delta_n \times (x - \bar{x}_n)\end{aligned}\tag{4.4}$$

The standard deviation  $\sigma^2$  can be extracted at any time using the formula in eq. (4.5). At least two values are required for valid calculations, otherwise a NaN will be generated.

$$\sigma_n^2 = \frac{M_n}{n - 1}\tag{4.5}$$

Even though it is not necessary to preserve old values for calculating the distribution properties, `Statistics` is able to store the values for later recall. The default action is to store the values. This behavior is set when constructing an instance

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<sup>91</sup>`Statistics.h`

<sup>92</sup>residual mean square

of Statistics and toggled by calling the `SetStoreData()`<sup>93</sup> function. All previously recorded data are immediately discarded if the storage action is disabled.

An extension class, `StatisticsWithExternalUncertainty`,<sup>94</sup> provides for propagating uncertainty [6] when evaluating distributions composed of quantities with inherent uncertainties. A basic assumption of uncertainty propagation is that the measurement equation, which accounts for all sources of variability in the measurement, is of the form shown in eq. (4.6). Parameter  $Y$  is the measurand,  $f$  is the relational function,  $N$  is the number of measurement quantities, and the  $X_i$  are the variability-corrected measurement quantities. The uncorrected output estimate is shown in eq. (4.7). Parameter  $y$  is the output estimate, and the  $x_i$  are the directly measured quantities.

$$Y = f(X_1, X_2, \dots, X_N) \quad (4.6)$$

$$y = f(x_1, x_2, \dots, x_N) \quad (4.7)$$

Uncertainty propagation is evaluated using the law of propagation of uncertainty, shown in eq. (4.8). Parameter  $u^2$  is the standard uncertainty, the subscript  $t$  denotes a total value, and all other parameters are as defined previously.

$$u_t^2(y) = \sum_{i=1}^N \left( \frac{\partial f}{\partial x_i} \right)^2 u^2(x_i) + 2 \sum_{i=1}^{N-1} \sum_{j=i+1}^N \frac{\partial f}{\partial x_i} \frac{\partial f}{\partial x_j} u(x_i, x_j) \quad (4.8)$$

The simplified combined standard uncertainty form, as shown in eq. (4.9), can be used if the input estimates  $x_i$  are uncorrelated.

$$u_t^2(y) = \sum_{i=1}^N u^2(x_i) \quad (4.9)$$

`StatisticsWithExternalUncertainty` is a generalized implementation—the origination of the uncertainties and correlation between quantities are unknown—thus

<sup>93</sup>Statistics.h:39-40

<sup>94</sup>Statistics With External Uncertainty.h

it is assumed that the input estimates  $x_i$  are uncorrelated and eq. (4.9) is used to propagate uncertainties. The standard deviation  $\sigma^2$  is used for the standard uncertainty  $u^2$  value.

Individual value uncertainties are retained if data storage is enabled. Further, templated functions are provided that allow for the bulk addition of data and uncertainties from another Statistics-based class. This provides a quick and useful mechanism for aggregating data, e.g. the analysis results from multiple waveforms, subphases, phases, and/or channels.

## 4.2 Examples of Fitting Capabilities

Preana has the ability to export the results and statistics of a fitting analysis for external validation and verification, which allows for the results of multiple analyses to be aggregated together and interpreted in a global manner.

An external package that is used and trusted by physicists world-wide, ROOT contains a powerful toolset for quickly performing operations on data. ROOT is used not for plotting results or calibration analysis, but rather as a validation tool for Preana's analysis capabilities. Internal validation tools could conceivably be built into Preana; however, this is not considered a necessary component of the framework's final design requirements for performing calibration measurements.

The functionality for collecting all the data for export is built into the data storage classes (see section 4.1.2). The export process appends everything if the file already exists, otherwise it creates the file. This allowed the data from multiple minimizations to be combined into one file for easier comparison.

The file is generated as a csv with one line for each waveform's analysis results. Aggregate results for each subphase, phase, and channel are also included. The

file is saved with `.prf` as the extension. The first line of the file contains the item headers, providing information about the order in which the values are presented. The names and interpretations are documented in `Variable Documentation.txt`, and the less-intuitive values are summarized in table 4.4.

The `.prf` file is converted into a ROOT-formatted TTree and saved into a `.root` file using the `PRF_to_TTree.C` script. The documentation file `Instructions.txt` describes how to perform the conversion operation. Information is also given on working with ROOT's TTree to generate plot data. Finally, `PlotGenerator.C` and `PlotsVsVoltage.C` are provided for generating a set of standard plots from the `.root` file.

Initially, the option of adding the ROOT API to Preana was considered. This would have provided the possibility of internally performing the validations described previously. However, to do so would typically require ROOT to be compiled on each computer running Preana. ROOT is a very large package. Experience shows that the pre-build configuration is not trivial, particularly on a Windows system. The two-step file output and conversion approach is the preferred method instead—especially since the use of ROOT is limited to the Preana validation scenarios, not the core components.

The exporting is queued using the `ChainedProgressThreadManager`. One thread is created for each channel, and execution occurs in sequential order. This is done to prevent a collision from multiple simultaneous write operations on the same file; the export format does not require that the data be ordered by increasing channel number. Also, the threading allows the GUI to remain responsive while the exporting is occurring.

Table 4.4 – Data Export Item Specifications

Item #	Name	Definition in Code	
		Value	Interpretation
1	Category	Export Operations.h:19-26 (Categories)	
		0	waveform
		1	subphase
		2	phase
2	Source Type	Fundamentals.h:389-399 (TestTypes)	
		0	single channel test
		1	distribution test
		3	channel
5	Phase*	Fundamentals.h:284-324 (PhaseTypes)	
		0	UNKNOWN or undefined
		1 to 32	channel number
		256	bank AB
		512	bank CD
		1024	bank EF
6	Preamp Proximity <sup>†</sup>	Fundamentals.cpp:250-322	
		255 <sup>‡</sup>	same side, channel # - 2
		0	pulsed channel
		1	same side, channel # + 2
		2	opposite
		3	kiddy-corner (edge case)
7	Distribution Board Proximity <sup>§</sup>	Fundamentals.cpp:173-248	
		0	pulsed bank
		-3 to 3	location offset of pulsed bank
8	Fitting Method	<i>see table 4.3</i>	

\*Provides the source of the primary pulse for the entity

<sup>†</sup>Represents the relative location of the nearest pulsed channel on the preamp card

<sup>‡</sup>Hexadecimal value of 0xFF, which is interpreted as -1 in a signed context

<sup>§</sup>Represents the relative location of the nearest pulsed bank on the distribution board

### 4.2.1 $\chi^2$ Distribution

$\chi^2$  distributions are used to understand the goodness of fit and are fundamental to anyone developing a specific calibration procedure. The  $\chi^2$  data from all fits are properly stored, and the resulting distributions can be compared.

Two distributions from different fitting methods are shown in fig. 4.8. Figure 4.8b is the FIX equivalent of fig. 4.8a, although the FIX distribution has both a higher mean value and uncertainty. The reason for fixing the decay constant is shown fig. 4.9, where it is demonstrated that the minimization procedure infrequently discovers a local minimum that does not accurately describe the waveform.<sup>95</sup>

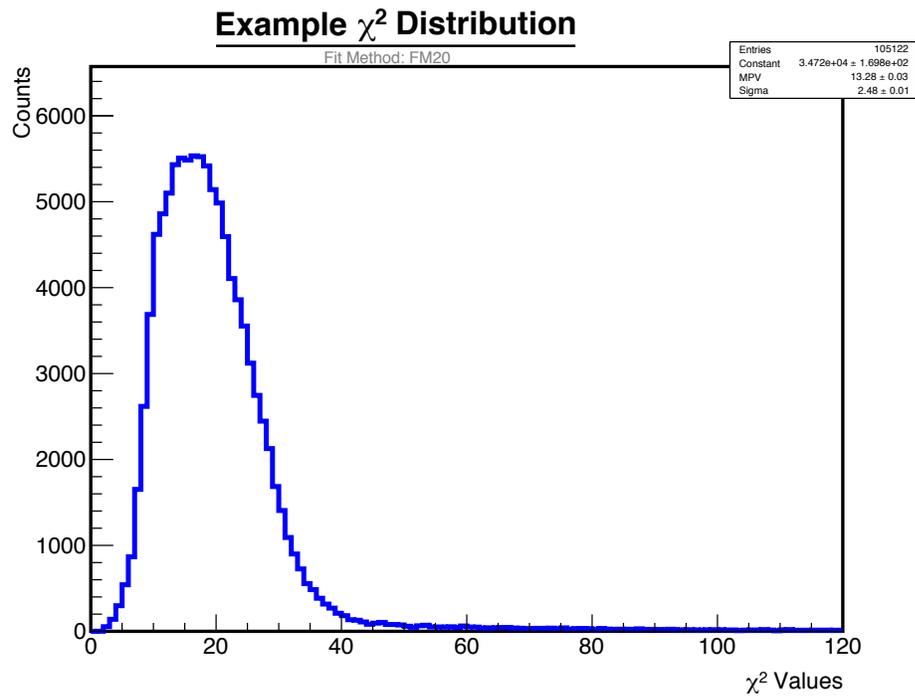
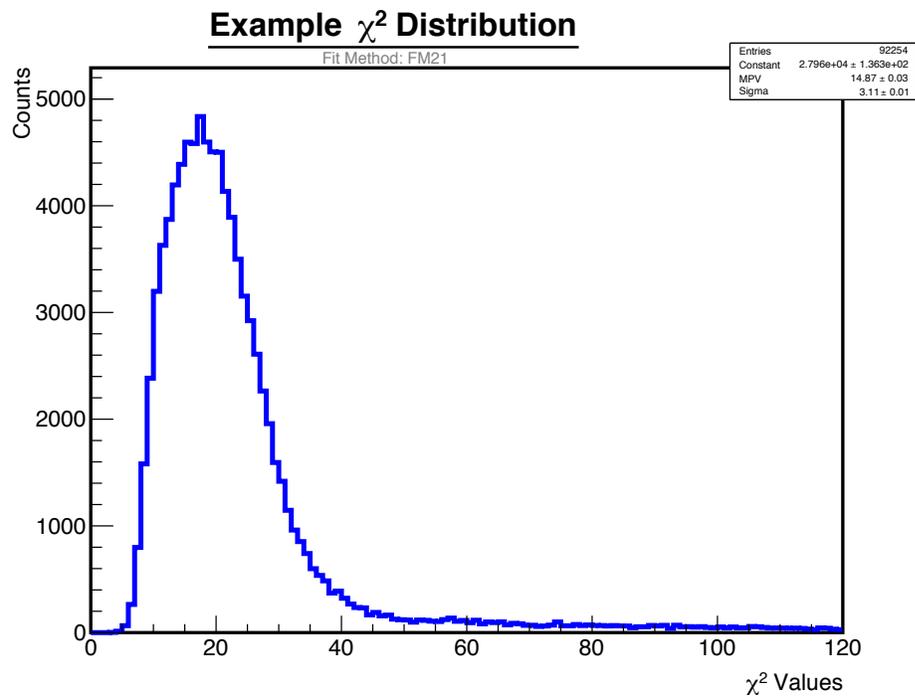
Fixing the RC constant forces the fit of the plateau to more closely match the data, providing a much better parametrization of the gain. The trade-off is that there are slight differences between the RC decay values, and the fixed value is only an estimate of the actual channels-specific values. However, the RC errors due to these differences is much less than the error contributed by the false minima, and the result is an overall improvement in the fit accuracy. This is a simple example of what a physicist might do in developing the correct calibration procedure.

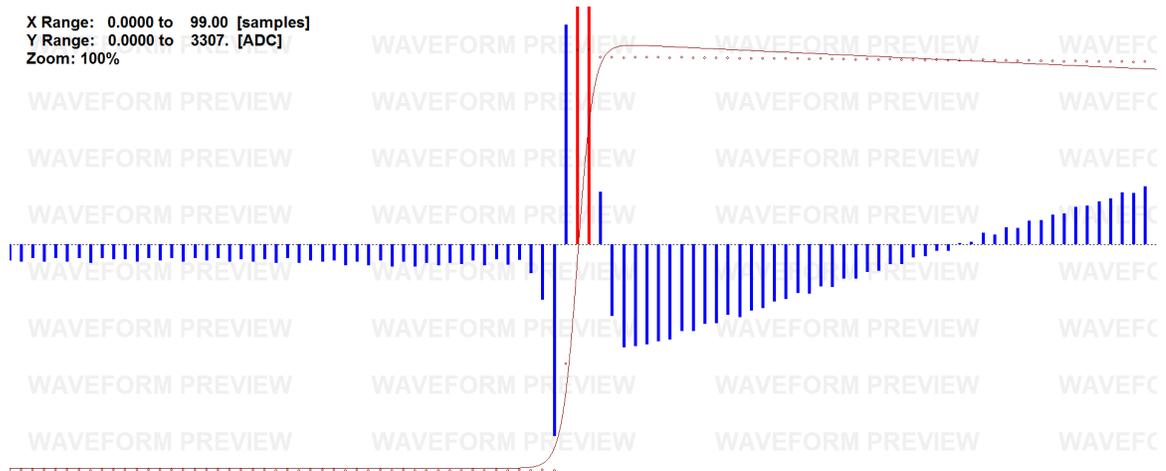
### 4.2.2 Gain Distribution

Gain distributions can be used to understand the accuracy of a fitting a specific function to a set waveforms. The linear performance of a channel can also appear in the width and/or skewdness of the gain distribution. The gain distributions shown herein contain aggregated subphase gain analysis data taken from one

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<sup>95</sup>Differences between the fit and data are most easily identified in the <Preview Pane>, which plots the relative difference using colored bars extending from the center of the graph. See fig. 4.9 for an example.

(a) Typical  $\chi^2$  Distribution(b)  $\chi^2$  Distribution with Fixed RC ConstantFigure 4.8 – Minimization  $\chi^2$  Distributions



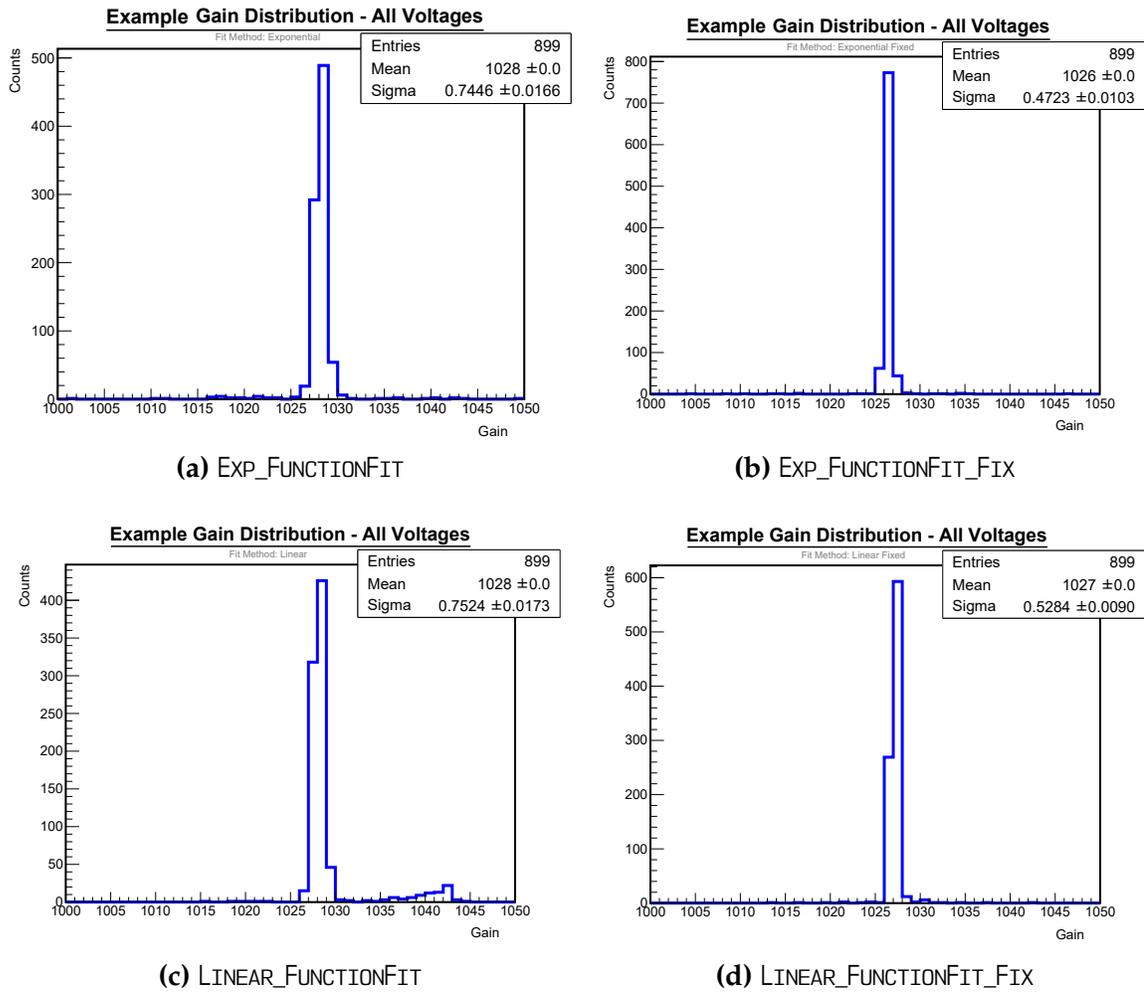
**Figure 4.9** – Local Minima Example

single channel test. Distributions for different fitting methods on the same data are shown.

The improved minimization effect of fixing the RC time constant is further demonstrated by investigating the gains directly. Figure 4.10 shows the results of different fitting methods on the same data set. The mean and sigma values are the parameters of a normal distribution fitted to the data.

The mean values of each distribution are within 0.2% of each other. These distributions globally verify the performance of the E/p card pairs; the cards are shown to have a very linear response over the tested dynamic range, based on the tightness and shape of the distributions. More in-depth analysis on the results of each subphase could be used if more detail on the actual performance is needed.

A marked improvement in the distribution is seen after fixing the RC time constant. This is contrasted most dynamically by EXP\_FUNCTIONFIT (fig. 4.10a) with the highest uncertainty, while its fixed counterpart EXP\_FUNCTIONFIT\_FIX (fig. 4.10b) has the lowest uncertainty.



**Figure 4.10** – Gain Distribution Comparison of Different Fitting Methods

This improvement is expected since the exponential decay component increases the complexity of the system—thus the possibilities for locating local minima—with a resulting higher uncertainty. However, once the RC time constant is fixed then the exponential form most accurately represents the physical behavior of the test system.

This demonstrates that Preana is capable of performing robust analyses on data, which can be verified externally. Again, this is just an example of what might

be done in determining the correct calibration procedure to be implemented in Preana for production-level analysis.

### 4.2.3 Optimization Attempts

The duration of a full-test analysis ranges, on average, from 30 s to 3 min. Although Preana's performance is sufficient, it is always desirable to improve the overall performance as much as possible. Two approaches are implemented in pursuit of this goal: LINEAR- and ADAPTEDFIT-type fitting methods.

The performance gains from each approach are negligible. As such, only anecdotal information is provided. However, this information is useful when implementing the Preana analysis framework for production-level calibration analyses—the actual form of the fitting function in an AbstractFunction-based class has very minor impact on the overall speed of the Minuit2 fitting routines. Thus, developmental resources should ideally be spent on determining the correct calibration procedure rather than trying to improve efficiency.

#### 4.2.3.1 Linear-type Fitting Methods

The WaveformFunctionLinear class exists due to an attempt to decrease the minimization duration. This corresponds to the LINEAR-type fitting methods. Computationally, exponential functions are more complex to evaluate than addition and multiplication. In theory, replacing an exponential function with a linear function would leverage this computational characteristic to boost the speed.

No differences are currently observable between the LINEAR- and EXPONENTIAL-type fitting methods. It is assumed that this is due to significant improvements in modern computing, a marginal amount of time spent actually computing the

function during the minimization, and a decrease in the physical accuracy of a linear decay function in the plateau region.

#### **4.2.3.2 AdaptedFit-type Fitting Methods**

The ADAPTEDFIT exists due to an attempt to improve the performance of each individual minimization. The underlying concept is based on the assumption that all the waveforms in a subphase are identical. If so, the fitted parameters for each should likewise be identical. Thus, each minimization would be assisted by seeding the fit parameters with the results of the previous successful minimization.

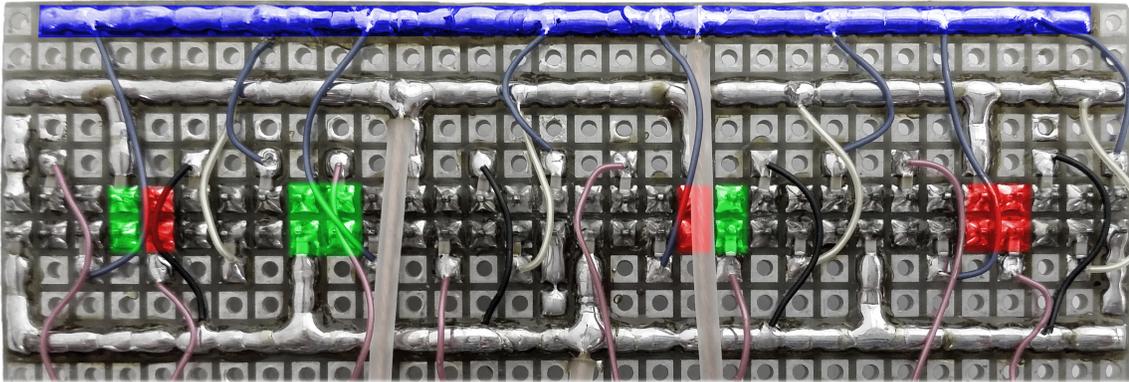
Again, the performance improvements are negligible. For a typical FUNCTIONFIT analysis lasting a few minutes, the corresponding ADAPTEDFIT offers no improvement. A comparison of the gain distributions and uncertainties associated with each method reveal that the accuracies are likewise comparable.

### **4.3 Cross Talk Module**

Initial hardware design considerations attempted to minimize crosstalk between channels. Unfortunately, the distribution board itself introduces cross talk into the pulse distribution system. Thus, all distribution-type tests are subject to cross talk interference.

#### **4.3.1 Identification of Cross Talk Origination**

The pattern of cross talk from the distribution board is irregular, and doesn't exhibit an immediately apparent relationship between channels. For example, a primary pulse on channel 6 produces a strong response on both channels 4 and 5; however, only a primary pulse on channel 4 elicits a strong response on channel 6—

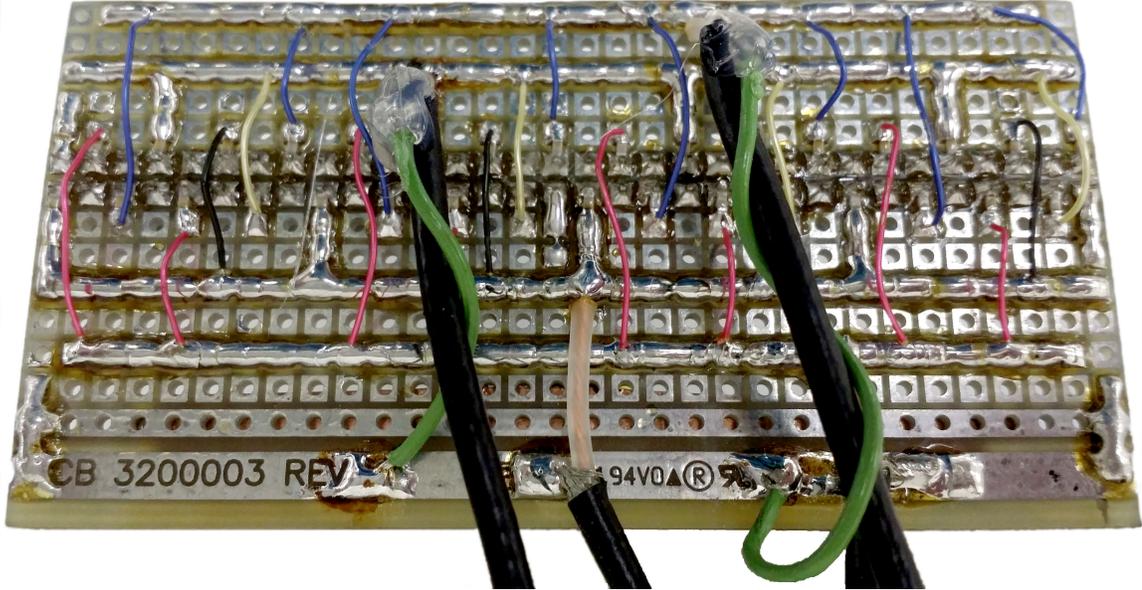


**Figure 4.11** – Correlation of Wiring Proximity to Cross Talk

no pulse from channel 5 has a significant effect on channel 6. Further, the cross talk does not follow any discernible pattern related to the position of the banks relative to each other on the distribution board. Data documenting this behavior, using ten preamp and two EtherDAQ cards to demonstrate repeatability, are collected into tables E.1 to E.9 of appendix E.

The actual cause of the cross talk is due to charge sharing that originates from the unshielded wiring on the bottom of the distribution board. The charge sharing occurs primarily where a wire carrying the primary pulse passes near another channel. The proximity of the wire to another channel has a direct correlation to the amount of charge measured by that channel. Figure 4.11, a modified version of fig. 2.5a, illustrates this correlation. The image enhancement represents a primary pulse sent to bank AB, highlighted by the blue bar. The colors of the charge sharing locations represent the magnitude of the resulting cross talk: red is large, and green is small. Charge sharing locations with negligible results are left unmarked.

This theory of the charge sharing locations was confirmed by modification of the distribution board. The shielding on the two bank bar feeds that extend over the jumper connections was extended, and the wiring was pulled back from the board as much as possible (see fig. 4.12). Data was recorded using the modified

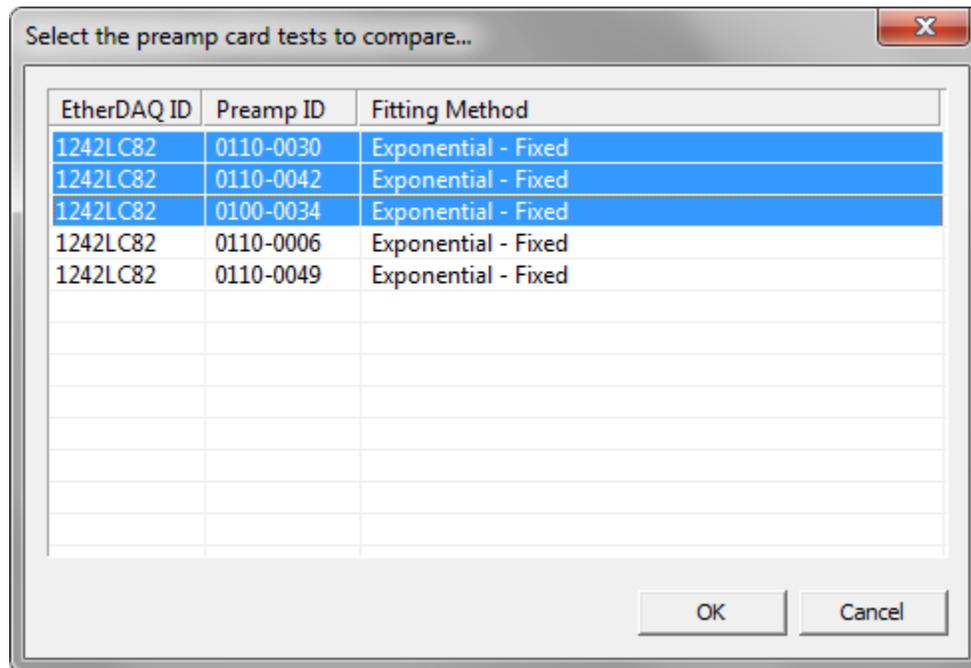


**Figure 4.12** – Modification of the Distribution Board

distribution board and is compiled into table E.10. The modifications caused a reduction of cross talk ADC value, slashed by as much as 90%, in the channels that exhibited significant cross talk.

### 4.3.2 Deconvolution

Cross talk deconvolution allows the distribution test data, which is significantly simpler and faster to collect, to be used for the calibration measurements. Development of a deconvolution matrix requires at least one data set each from the distribution and single channel test types. More than one of each type can be used, and is actually recommended since it will improve the statistical validity of the measurement. Additionally, not all E/p pairs have 100% of their channels operation, so more than one test of each from different E/p pairs helps to ensure a complete deconvolution matrix for all 32 channel.



**Figure 4.13** – Test Comparison Selection

Validation of a deconvolution matrix requires two separate groups of data. The two groups must not share data from  $E/P$  pairs, i.e. no test data from an  $E/P$  may be used in both. The first group is used to generate the response matrices, and the second to verify the deconvolution. This ensures that the results are unbiased.

The menu command `<Analysis> ▷ Compare Test Types...` is used to generate a response matrix for a single  $E/P$  pair. A selection dialog, shown in fig. 4.13, displays the tests that can be used. Only  $E/P$  pairs that have both distribution and single channel test data loaded are displayed. Multiple tests can be selected for simultaneous analysis by pressing `CTRL` while clicking.

A deconvolution matrix can be generated, as soon as one or more response matrices are available, using the menu command `<Breakout Board Response> ▷ Generate....`. The menu command `<Breakout Board Response> ▷ Apply & Predict...` is then

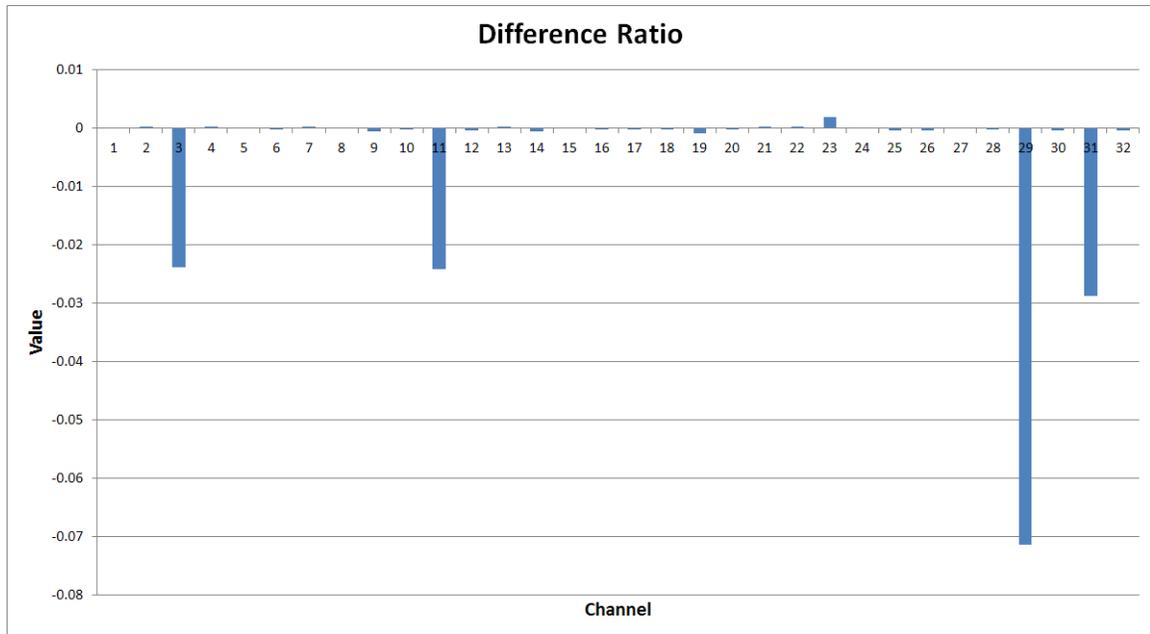
used to apply the deconvolution matrix to a test and predict the outcome of the resulting test type, whether distribution or single channel.

This method of deconvolution is limited by one important assumption: the cross talk and charge sharing must be linear. The accuracy is limited by the accuracy of the data. The deconvolution matrix itself is a simple channel-by-channel ratio of the gain between the distribution and the single channel test results. Conversion between forms is simple linear scaling operation.

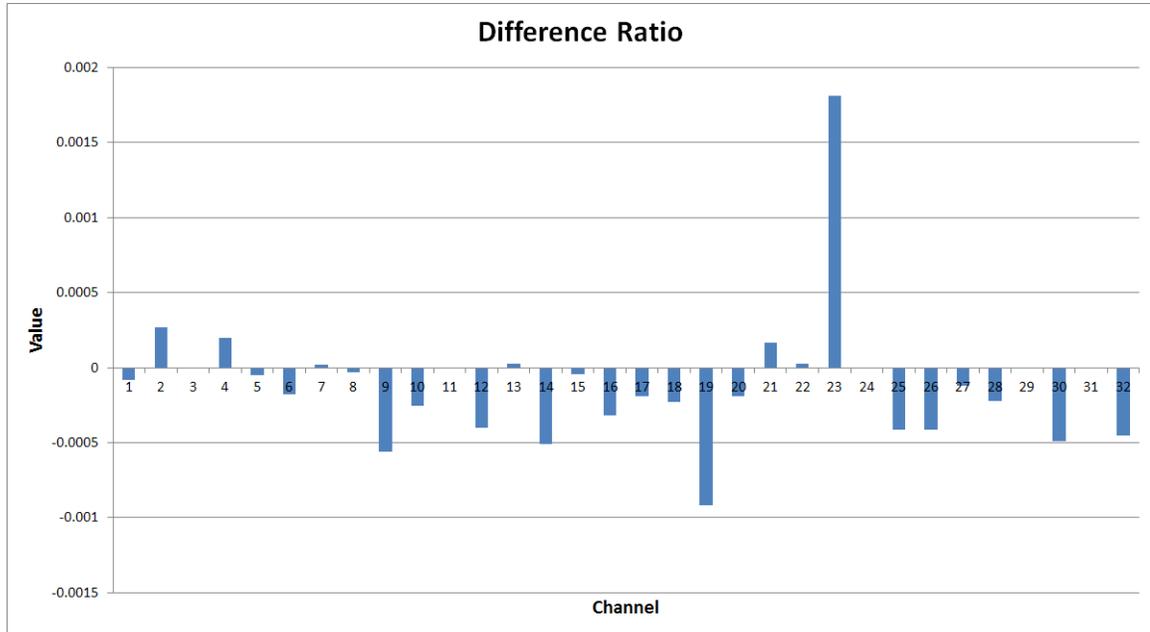
The results of an example deconvolution are contained in appendix F. The deconvolution matrix, shown in fig. F.1, is generated from four response matrices. It is then applied to the results of distribution test analysis, shown in fig. F.2. The predicted response results are compared against the actual single channels test data, respectively figs. F.3 and F.4.

Ratios of the differences between the predicted and actual values to the actual values are shown in fig. 4.14a. The ratios of the significantly different channels are removed in fig. 4.14b, in which the remaining ratios are less than 0.2%.

Something as simple as an accidental nudging of the wires with a finger alters the distribution board responses; the ratios corresponding to channels 3, 11, 29, and 31 are characteristic of changes in the wiring configuration. These results further establish that 1) the wiring on the distribution board as the source of cross talk in the distribution tests, and 2) that the cross talk levels are extremely sensitive to the wire proximities to the connectors for the breakout board.



(a) All Channels



(b) Channels 3, 11, 29, and 31 Removed

Figure 4.14 – Ratios of Deconvolution Result Differences

# Chapter 5

## Conclusions

The framework is developed to support automated E/p card testing and routine calibration measurements.

A test stand is used to emulate the connections and charge signals an E/p pair would receive on the NIFFTE TPC, a fundamental aspect of performing calibration measurements. The pulse generating equipment exhibits extraordinary performance, which ensures the quality of the charge signals. A distribution board provides a method for simultaneously testing all 32 channels on a E/p pair.

EtherDaqGUI interfaces with the test stand hardware to interrogate E/p pairs and collect test data. It has been enhanced to be more user-friendly and operate pulse generation equipment to provide automated testing capabilities. The testing parameters are fully customizable by the user; default parameters comprehensively test an E/p pair in under 5 min, and the resulting data can be used to evaluate channel linearity, check for cross talk, and perform calibration measurements. An initial health evaluation is also performed, which reports channels behaving outside acceptable tolerances. All collected data is saved for later detailed analysis and calibration measurements in the analysis framework.

Preana, the analysis framework, is capable of performing complex and detailed analysis using the embedded Minuit2 library. The Minuit2 minimization routines are used to fit representative functions to the waveform data and extract the characteristic parameters, primarily the gain. Preana is designed to be extremely functional, as demonstrated by the example analyses performed for establishing its capabilities. A flexible design provides for future development as needs arise, and functionality for exporting analysis results enables external validation and verification using ROOT. Finally, Preana boasts a clean and intuitive user interface with functionality for browsing imported data, displaying waveforms with fit residuals, and plotting distributions of analysis result.

## 5.1 Summary

Calibration measurements of the  $E/p$  card pairs are central to attaining the sub-1% measurement uncertainty using the TPC (chapter 1). The  $E/p$  pairs are tested using the test stand hardware (chapter 2). The test stand equipment is controlled by EtherDaqGUI, which performs an initial health check on the  $E/p$  pairs and also records the test results for subsequent detailed analysis (chapter 3). Preana, a user-friendly and flexible analysis framework, is designed to support the detailed analysis requirements for generating calibration measurements (chapter 4).

## 5.2 Future Work

The following items are needed to satisfy the global objective of performing calibration measurements, which is beyond the scope of this work.

### 5.2.1 Distribution Board Resolution

In its current state the distribution board is still changeable, i.e. a accidental or intentional alteration of the wiring will change the cross talk behavior. The test stand will be incapable of performing any meaningful calibration measurements as long as this is the case. Two solutions are proposed to eliminate this Achilles heel:

1. replace the distribution board by another containing no movable/alterable components
2. stabilize the wiring configuration on the back
  - (a) hot glue: provide for future alterations
  - (b) epoxy: inhibit any future alterations

Developing a new distribution board will likely eliminate all sources of measurable cross talk in the system. Conversely, the cross talk deconvolution module in Preana has been shown to be perfectly capable of removing the effects of the distribution board. Both solutions are equally valid; however, any changes or modifications will need to be thoroughly checked. The level of cross talk present in the system will need to be re-evaluated against the pure single channel tests.

### 5.2.2 Baseline Response Matrix

Once the distribution board issue is resolved, it well necessary to generate the response matrix correlating the distribution board to the single channel board. It will be necessary to save this master response matrix to a file, which can then be quickly loaded when starting a new analysis session. The menu commands to export and import a response matrix are already available in anticipation of this need, but the functionality must still be implemented in the code.

### 5.2.3 Database Integration

The final step is to make the calibration measurements available through NIFFTE's central SQL<sup>1</sup> reconstruction database. Preana must be expanded to include SQL database communications. The calibration constant can then be properly formatted and uploaded as analyses are performed.

The NIFFTE fission TPC project will best accomplish its goal—generating nuclear data measurements with sub-1% uncertainties—through the application of these calibration measurements in data reconstruction efforts.

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<sup>1</sup>structured query language

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# Appendices

# **Appendix A**

## **Formatting**

A few different typefaces and formats are used throughout this thesis, each with a unique meaning.

This thesis contains hyperlinks; clicking on a hyperlink will navigate to, or open up, the linked resource when this document is viewed with a supporting document reader. Most document viewers indicate when the mouse is over a hyperlink by changing the cursor. If any hyperlink-type items are used in a special section, such as a title or caption, they will be typeset uniformly with the surrounding type. Nevertheless, the hyperlinks will still be active.

**Table A.1** – Formatting

Typeface	Format	Example	Meaning
serif	normal	Lorem ipsum	The normal text throughout the document
serif	small caps	LOREM IPSUM	An acronym, the first occurrence will include a definition in the footnotes; hyperlink
sans serif	normal	Lorem ipsum	A term found in the main glossary; hyperlink
monospace	normal	Lorem ipsum	A computer-related item, may be one of the following: <ol style="list-style-type: none"> <li>1. Name of a file, class, or function</li> <li>2. A software library</li> <li>3. An IP or MAC address</li> <li>4. An internet URL (e.g. <code>www.isu.edu</code>); hyperlink</li> </ol>
monospace	<code>&lt;text&gt;</code>	<code>&lt;Lorem ipsum&gt;</code>	Name of an interactive item within a program's GUI
monospace	small caps	LOREM IPSUM	A macro, parameter, or enumerated value in the code

It can be easier to represent some concept using substitutions. Any occurrence of substitution uses the conventions below.

**Table A.2** – Substitution Conventions

<b>Appearance</b>	<b>Meaning</b>
$\langle \ \rangle$	contains an element that requires substitution
$  \  $	used inside $\langle \ \rangle$ , contains information about that substitution
...	a repeating pattern
F	a base-10 floating point decimal
H	a base-16 (hexadecimal) integer
N	a single numeral in the range 0–9
S	a string of one or more characters
X	a base-10 integer

# **Appendix B**

## **Equipment Spec Sheets**

**Table B.1** – Spec Sheet: Agilent E3620A and E3630A [7]

(a) 1 of 2

	E3620A	E3630A
<b>Features</b>	Isolated dual outputs, 10 turn pots CV, CL	Tracking, CV, CL ( $\pm 20$ V) CV, CF (+6 V)
<b>Number of outputs</b>	2	3
<b>Number of Output Ranges</b>	1	1
<b>DC Output Rating</b>	25 V, 1 A 25 V, 1 A	+6 V, 2.5 A +20 V, 0.5 A – 20 V, 0.5 A
<b>Load and Line Regulation</b>	$< 0.01\% + 2$ mV	
<b>Ripple and Noise</b> (20 Hz to 20 MHz)		
Normal mode voltage	$< 350$ $\mu$ Vrms, $< 1.5$ mVpp	
Normal mode current	–	
Common mode current	$< 1$ $\mu$ Arms	
<b>Transient Response Time</b>	$< 50$ $\mu$ sec following a change in output current from full load to half load for output to recover within:	
	15 mV	
<b>Meter Accuracy</b>	$\pm 0.5\% + 2$ counts at $25$ $^{\circ}$ C $\pm 5$ $^{\circ}$ C	
<b>Meter Resolution</b>		
Voltage	10 mV (0–20 V), 100 mV ( $> 20$ V)	10 mV
Current	1 mA	10 mA
<b>Isolation</b>	240 Vdc	

(b) 2 of 2

## Supplemental characteristics

	<b>E3620A</b>	<b>E3630A</b>
<b>Control Mode</b>	CV/CL	CV/CL ( $\pm 20$ V) CV/CF (+6 V)
<b>Temperature Coefficient per °C</b>		
Voltage	< 0.02% + 1 mV	
Current	-	
<b>Output Drift</b>		
Voltage	Less than 0.1% + 5 mV total drift for 8 hours after initial warm-up of 30 minutes	
Current	N/A	
<b>Temperature Range</b>		
	Derate output current 50% between 40 °C to 55 °C	
<b>Cooling</b>	Convection cooling	
<b>Isolation</b>	$\pm 240$ Vdc	
<b>AC Input</b>	100 Vac $\pm 10\%$ , 47–63 Hz (opt. 0E9) 115 Vac $\pm 10\%$ , 47–63 Hz (std) 230 Vac $\pm 10\%$ , 47–63 Hz (0E3)	
<b>Weight</b>	5.0 kg (11.0 lbs) net, 6.25 kg (13.8 lbs) shipping	3.8 kg (8.4 lbs) net, 5.1 kg (11.3 lbs) shipping
<b>Size</b>	88.1 mm H x 212.3 mm W x 392.4 mm D 3.5" H x 8.4" W x 15.4" D	88.1 mm H x 212.3 mm W x 318.4 mm D 3.5" H x 8.4" W x 12.5" D
<b>Warranty</b>	Three year for E3600 Series power supplies Three months for standard shipped accessories	
<b>Product Regulation</b>	Certified to CSA 22.2 No. 231; conforms to IEC 1010-1; carries CE mark; complies with CISPR-11, Group 1, Class A, KC South Korean EMC Mark, Canadian ICES/NMB-001, Australian C Tick Mark	

**Table B.2 – Spec Sheet: Arbstudio Waveform Generator [8]**

(a) 1 of 4

	ArbStudio 1102	ArbStudio 1102D	Arb Studio 1104	ArbStudio 1104D
Channels	2	2	4	4
Digital Pattern Generator	NA	18 Channels	NA	36 Channels
Waveforms	Sine, Cosine, Triangle, Rectangle, Sawtooth, Ramp, Pulse, Sinc, Exponential, Sweep, DC, Noise, From File, Arbitrary			

**Waveform Characteristics**

Sine	
Frequency Range (Arbitrary)	2 $\mu$ Hz to 125 MHz
Frequency Range @ Max Sample Rate (DDS)	3.7 mHz to 110 MHz
Amplitude Flatness (1 $V_{p-p}$ , Typical)	
DC to 110 MHz (DDS)	< $\pm 0.1$ dB
DC to 125 MHz (Arbitrary)	< $\pm 0.1$ dB
Harmonics Distortion (1 $V_{p-p}$ , Typical)	
$\leq 1$ MHz	< -66 dBc
1 MHz to 5 MHz	< -63 dBc
5 MHz to 10 MHz	< -59 dBc
10 MHz to 25 MHz	< -53 dBc
25 MHz to 75 MHz	< -38 dBc
75 MHz to 110 MHz (DDS)	< -31 dBc
75 MHz to 125 MHz (Arbitrary)	< -28 dBc
Non Harmonic Distortion (1 $V_{p-p}$ , Typical)	
$\leq 1$ MHz to 10 MHz	< -71 dBc
10 MHz to 25 MHz	< -66 dBc
25 MHz to 75 MHz	< -53 dBc
75 MHz to 125 MHz (Arbitrary)	< -47 dBc
75 MHz to 100 MHz (DDS)	< -61 dBc
100 MHz to 110MHz (DDS)	< -30 dBc
THD	
(100 kHz, 1 $V_{p-p}$ , Typical)	< 0.15%
Phase Noise (20 MHz, 1 $V_{p-p}$ , Typical)	
10 kHz Offset	-106 dBc / Hz
100 kHz Offset	-113 dBc / Hz
1 MHz Offset	-128 dBc / Hz
Analog Bandwidth	
Arbitrary / DDS	125 MHz / 110 MHz
Square Wave, Pulse (1 $V_{p-p}$ )	
Frequency Range	2 $\mu$ Hz to 62.5 MHz
Duty Cycle Range	1% to 99%
Rise / Fall Time (Typical)	< 3.5 ns
Overshoot (Typical)	< 5.5%
Random Jitter (rms, Typical)	< 20 ps
Triangle / Ramp	
Frequency Range	2 $\mu$ Hz to 31.25 MHz
Start Phase Range	0 to 360°
Sinc (Sin(x)/x)	
Frequency Range	2 $\mu$ Hz to 15.5 MHz
Minimum Lobe Width	8 ns

**(b) 2 of 4****ArbStudio 1102****ArbStudio 1102D****Arb Studio 1104****ArbStudio 1104D****Waveform Characteristics (cont'd)**

Waveform Sequencing	
Waveforms	All, From File, Arbitrary
Waveform Repetitions	1 to $(2^{33} - 1)$
Start Source	Software, Internal, External
No. of Waveforms	1 to 511

**Common Characteristics**

Arbitrary	
Sample Rate Real Time	4 S/s to 250 MS/s
Vertical Resolution	16-bit
Waveform Memory	2 Mpts / Ch
Minimum Waveform Length	8 points
Waveform Resolution	2 points
Noise Bandwidth (-3 dB Gaussian Noise), Typical	100 MHz
Run Modes	Single, Continuous, Stepped, Burst
Direct Digital Synthesis (DDS)	
Sample Rate Real Time	125 MS/s to 250 MS/s
Run Modes	Single, Continuous, Burst
Carrier Waveform Memory	2048 Samples / Ch
Amplitude, 50 $\Omega$ Load (1 kHz)	0 V to +12 V <sub>p-p</sub>
Amplitude, Open Circuit	0 V to +24 V <sub>p-p</sub>
Amplitude Resolution	< 1 mV
DC Accuracy, Open Circuit ( $\pm 12$ V Range)	$\pm 0.25\%$ of amplitude range (within $\pm 10$ °C of calibration temperature T=25 °C, Humidity $\leq 80\%$ ) $\pm 0.3\%$ of amplitude range (0 to 50 °C)
DC Accuracy, 50 $\Omega$ Load ( $\pm 6$ V Range)	$\pm 0.25\%$ of amplitude range (within $\pm 10$ °C of calibration temperature T=25 °C, Humidity $\leq 80\%$ ) $\pm 0.3\%$ of amplitude range (0 to 50 °C)
AC Accuracy, Open circuit (0 V <sub>p-p</sub> to +24 V <sub>p-p</sub> range, 1 kHz Sine Wave)	$\pm 0.25\%$ of amplitude range (within $\pm 10$ °C of calibration temperature T=25 °C, Humidity $\leq 80\%$ ) $\pm 0.3\%$ of amplitude range (0 to 50 °C)
AC Accuracy, 50 $\Omega$ Load (0 V <sub>p-p</sub> to +12 V <sub>p-p</sub> range, 1 kHz Sine Wave)	$\pm 0.25\%$ of amplitude range (within $\pm 10$ °C of calibration temperature T=25 °C, Humidity $\leq 80\%$ ) $\pm 0.3\%$ of amplitude range (0 to 50 °C)
Output Impedance	Selectable: 50 $\Omega$ , Low or High Impedance
Short Circuit Protection	Signal outputs are robust against permanent shorts against floating ground
Frequency accuracy	
Stability	< $\pm 5$ ppm
Aging	< $\pm 2$ ppm / year
Max Interpolated Sample Rate	1 GS/s (4x interpolation)
Interpolation Factors	1x, 2x, 4x
Sampling Frequency Resolution	15 digits limited by 1 nHz
Multi Channel Specifications	
Sampling Rate Tuning	Programmable per channel couple (Ch 1-2) Programmable per channel couple (Ch 1-2, Ch 3-4)
Skew Between Channels (at Common Sample Rate)	
Average (Typical)	< 300 ps
Standard Deviation (Typical)	< 35 ps
Math	Sum, Difference, Multiply between the two channels (Ch 1-2)

(c) 3 of 4

**ArbStudio 1102      ArbStudio 1102D      Arb Studio 1104      ArbStudio 1104D**

**Modulation**

Amplitude Modulation	
Modulation Type	Arbitrary AM, ASK
Carrier Waveform	All, From File, Arbitrary
Modulating Waveforms	All, From File, Arbitrary
Modulating Source	Internal
Modulating Waveform Sample Clock at Max. Sampling Rate	0.46 S/s to 125 MS/s
Memory Size	2047 entries

Phase / Frequency Modulation	
Modulation Type	Arbitrary FM/PM, FSK, PSK
Carrier Waveform	All, From File, Arbitrary
Modulating Waveforms	All, From File, Arbitrary
Modulating Source	Internal
Carrier Frequency at Max. Sample Rate	
Sine Wave	3.7mHz to 110 MHz
Square	3.7mHz to 62.5 MHz
Triangle / Ramp	3.7mHz to 31.25 MHz
Modulating Waveform Sample Clock at Max. Sample Rate	From 119.2S/s to 125 MS/s (per sample programmable)
Memory Size	511 entries
Frequency Resolution at 125 MS/s Sample Rate	0.0019 Hz (FSK) 2.15E-5° (PSK)
Frequency Resolution at 250 MS/s Sample Rate	0.0037 Hz (FSK) 4.30E-5° (PSK)

Pulse Width Modulation	
Carrier Waveform	Pulse
Carrier Frequency	100 mHz to 20 MHz
Duty Cycle Modulating Waveform	Sine, Triangle, Ramp, Noise, Manual
Duty Cycle Modulating Frequency	10 µHz to 6.67 MHz
Source	Internal
Duty Cycle Deviation	0 % to 100 % of pulse period

Frequency Sweep	
Carrier Waveform	All, From File, Arbitrary
Sweep Type	All waveforms
Sweep Direction	Up or Down
Sweep Range at Max. Sample Rate	
Sine Wave	3.7 mHz to 110 MHz
Square	3.7 mHz to 62.5 MHz
Triangle / Ramp	3.7 mHz to 31.25 MHz
Sweep Time at Max. Sample Rate	100 ns to 4.2 s

**Pattern Generator Characteristics**

Number of Channels	N/A	18	N/A	18 / 36
Vector Memory Depth	N/A	1 Mpts / Ch (per Ch programmable direction)	N/A	1 Mpts / Ch (per Ch programmable direction)
Acquisition Memory Depth	N/A	2 Mpts / Ch	N/A	2 Mpts / Ch
Update Frequency	N/A	125 MS/s (per Ch programmable direction)	N/A	125 MS/s (per Ch programmable direction)
Sampling Frequency	N/A	250 MS/s	N/A	250 MS/s
Direction Control	N/A	Per Ch programmable	N/A	Per Ch programmable
Output Voltage Level	N/A	1.2 V to 3.6 V	N/A	1.2 V to 3.6 V
Trigger Levels	N/A	31	N/A	31
Operating Modes	N/A	18 Ch Digital or 2 Ch Analog	N/A	36 Ch Digital or 4 Ch Analog or 18 Ch Digital plus 2 Ch Analog

(d) 4 of 4

	ArbStudio 1102	ArbStudio 1102D	Arb Studio 1104	ArbStudio 1104D
<b>Multi-Instrument Synchronization</b>				
Max Number of Instruments	N/A	N/A	Up to 8 units with AS-SYNC Cable	
Synchronization Accuracy	N/A	N/A	< 300 ps	
<b>Auxiliary Inputs/Outputs</b>				
Analog Outputs				
Output Connector	Front panel BNC			
Output Impedance	50 $\Omega$ , Low or High Impedance			
External Trigger Output				
Output Connector	Front panel BNC			
Output Level	TTL compatible into > 1 K $\Omega$			
Output Impedance	50 $\Omega$ nominal			
External Trigger Input				
Input Connector	Front panel BNC			
Frequency Range	DC to 125 MHz			
Threshold Level	VILmax = 0.8 V, VIHmin = 2 V			
Voltage Range	-0.5 V to 4 V			
Damage Level	VINmax < 6 V, VINmin > -2 V			
Slope	Rising Edge or Falling			
External Clock				
Input Connector	Front panel BNC			
Frequency Range	0 MHz to 125 MHz			
Min. Input Voltage Swing	$\Delta$ VINmin > 2 V			
Damage Level	VINmax < 5 V, VINmin > -5 V			
Digital I/O				
Connector	50 pin high density (1.27 mm) SCSI connector			
Connector count	1		2	
<b>General Characteristics</b>				
Power Supply Voltage Range	100 $\pm$ 10% to 240 $\pm$ 10% VAC			
Power Consumption	35 W max.			
Power Frequency Range	50 / 60 Hz $\pm$ 5%			
PC Interface	USB 2.0			
<b>Physical Characteristics</b>				
External Dimensions (HWD)	2.4" x 12.8" x 7.2" (62 x 326 x 182 mm)			
Weight	2.8 lbs (1.3 kg)			
<b>Environmental Characteristics</b>				
Temperature (Operating)	Main equipment: 0 to 50 $^{\circ}$ C, Power adapter: 0 to 40 $^{\circ}$ C			
Temperature (Non-Operating)	Main equipment: -40 to 71 $^{\circ}$ C, Power adapter: -25 to 71 $^{\circ}$ C			
Humidity (Operating)	5% to 80% RH (non-condensing) at $\leq$ 30 $^{\circ}$ C, 50% max RH (non-condensing) at 40 $^{\circ}$ C			
Humidity (Non-Operating)	5% to 95% max RH (non-condensing)			
Altitude (Operating)	Up to 3,048 m (10,000 ft) at $\leq$ 30 $^{\circ}$ C			
Altitude (Non-Operating)	Up to 12,192 m (40,000 ft)			
<b>Minimum PC Requirements</b>				
Operative System	Microsoft Windows <sup>®</sup> 2000 / XP SP2 / Vista / 7 32-bit Editions			
Processor	Intel <sup>®</sup> Pentium <sup>®</sup> III processor, or better			
Memory	512 MB RAM			
Hard Disk	150 MB available free space			
Display Resolution	800 x 600 or better			
Connectivity	USB 2.0 or 1.1			

**Table B.3 – Spec Sheet: SRS CG635 Clock Generator [9]**

<b>Frequency</b>		<b>CMOS Output</b>	
Range	DC, 1 $\mu$ Hz to 2.05 GHz	Output	Front-panel BNC
Resolution	16 digits ( $f \geq 10$ kHz), 1 pHz ( $f < 10$ kHz)	Frequency range	DC to 250 MHz
Accuracy	$\Delta f < \pm(2 \times 10^{-19} + \text{timebase error}) \times f$	Low level	$-1.00 \text{ V} \leq V_{\text{LOW}} \leq +1.00 \text{ V}$
Settling time	<30 ms	Amplitude	$500 \text{ mV} \leq V_{\text{AMPL}} \leq 6.00 \text{ V}$ ( $V_{\text{AMPL}} \equiv V_{\text{HIGH}} - V_{\text{LOW}}$ )
<b>Timebase</b>		Level resolution	10 mV
	(+20 °C to +30 °C ambient)	Level error	<2 % of $V_{\text{AMPL}} + 20 \text{ mV}$
Stability	<5 ppm (std. timebase) <0.01 ppm (Opt. 02 OCXO) <0.0001 ppm (Opt. 03 Rb timebase)	Transition time	<1 ns (20 % to 80 %)
Aging	<5 ppm/yr. (std. timebase) <0.2 ppm/yr. (Opt. 02 OCXO) <0.0005 ppm/yr. (Opt. 03 Rb timebase)	Symmetry	<500 ps departure from nominal 50 %
External input	10 MHz $\pm$ 10 ppm, sine >0.5 Vpp, 1 k $\Omega$	Source impedance	50 $\Omega$ (reverse terminates cable reflection)
Output	10 MHz, 1.41 Vpp sine into 50 $\Omega$	Load impedance	Unterminated 50 $\Omega$ cable of any length
<b>Phase Noise</b>		Attenuation (50 $\Omega$ load)	Output levels are divided by 2
	(at 622.08 MHz)	Pre-programmed levels	1.2 V, 1.8 V, 2.5 V, 3.3 V or 5.0 V
100 Hz offset	<-90 dBc/Hz	<b>RS-485 Output</b>	
1 kHz offset	<-100 dBc/Hz	Output	Rear-panel RJ-45
10 kHz offset	<-100 dBc/Hz	Frequency range	DC to 105 MHz
100 kHz offset	<-110 dBc/Hz	Transition time	<800 ps (20 % to 80 %)
<b>Jitter and Wander</b>		Clock output	Pin 7 and pin 8 drive twisted pair
Jitter (rms)	<1 ps (1 kHz to 5 MHz bandwidth)	Source impedance	100 $\Omega$ between pin 7 and pin 8
Wander (p-p)	<20 ps (10 s persistence)	Load impedance	100 $\Omega$ between pin 7 and pin 8
<b>Time Modulation</b>		Logic levels	$V_{\text{LOW}} = +0.8 \text{ V}$ , $V_{\text{HIGH}} = +2.5 \text{ V}$
	(rear-panel input, 1 k $\Omega$ )	Recommended cable	Straight-through Category-6
Sensitivity	1 ns/V, $\pm 5$ %	<b>LVDS Output</b>	
Range	$\pm 5$ ns		(EIA/TIA-644)
Bandwidth	DC to greater than 10 kHz	Output	Rear-panel RJ-45
<b>Phase Setting</b>		Frequency range	DC to 2.05 GHz
Range	$\pm 720^\circ$ (max. step size $\pm 360^\circ$ )	Transition time	<100 ps (20 % to 80 %)
Resolution	<14 ps	Clock output	Pin 1 and pin 2 to drive twisted pair
Slew time	<300 ms	Source impedance	100 $\Omega$ between pin 1 and pin 2
<b>Q and <math>\bar{Q}</math> Outputs</b>		Load impedance	100 $\Omega$ between pin 1 and pin 2
Outputs	Front-panel BNC connectors	Logic levels	$V_{\text{LOW}} = +0.96 \text{ V}$ , $V_{\text{HIGH}} = +1.34 \text{ V}$
Frequency range	DC to 2.05 GHz	Recommended cable	Straight-through Category-6
High level	$-2.00 \text{ V} \leq V_{\text{HIGH}} \leq +5.00 \text{ V}$	<b>PRBS (Opt. 01)</b>	
Amplitude	$200 \text{ mV} \leq V_{\text{AMPL}} \leq 1.00 \text{ V}$ ( $V_{\text{AMPL}} \equiv V_{\text{HIGH}} - V_{\text{LOW}}$ )		(EIA/TIA-644)
Level resolution	10 mV	Outputs	PRBS, -PRBS, CLK and -CLK
Level error	<1 % + 10 mV	Frequency range	DC to 1.55 GHz
Transition time	<100 ps (20 % to 80 %)	Level	LVDS on rear-panel SMA jacks
Symmetry	<100 ps departure from nominal 50 %	PRBS generator	$x^7 + x^6 + 1$ for a length of $2^7 - 1$ bits
Source impedance	50 $\Omega$ ( $\pm 1$ %)	Transition time	<100 ps (20 % to 80 %)
Load impedance	50 $\Omega$ to ground on both outputs	Load impedance	50 $\Omega$ to ground on all outputs
Pre-programmed levels	PECL, LVDS, +7 dBm, ECL	<b>General</b>	
		Computer interfaces	GPIB and RS-232 std. All functions can be controlled through either interface.
		Non-volatile memory	Ten sets of instrument configurations can be stored and recalled.
		Power	90 to 264 VAC, 47 to 63 Hz, 50 W
		Dimensions, weight	8.5" $\times$ 3.5" $\times$ 13" (WHD), 9 lbs.
		Warranty	One year parts and labor on defects in materials and workmanship

**Table B.4 – Spec Sheet: SRS DG645 Pulse Generator [10]**

**Delays**

Channels	4 independent pulses controlled in position and width. 8 delay channels available as an option (see <i>Output Options</i> ).
Range	0 to 2000 s
Resolution	5 ps
Accuracy	1 ns + (timebase error × delay)
Jitter (rms)	
Ext. trig. to any output	25 ps + (timebase jitter × delay)
T <sub>0</sub> to any output	15 ps + (timebase jitter × delay)
Trigger delay	85 ns (ext. trig. to T <sub>0</sub> output)

**Timebases**

Model #	Type	Jitter (s/s)	Stability (20 to 30 °C)	Aging (ppm/yr)
Std.	crystal	10 <sup>-8</sup>	2 × 10 <sup>-6</sup>	5
Opt. 4	OCXO	10 <sup>-11</sup>	1 × 10 <sup>-9</sup>	0.2
Opt. 5	Rb	10 <sup>-11</sup>	1 × 10 <sup>-10</sup>	0.0005

External input	10 MHz ± 10 ppm, sine >0.5 V <sub>pp</sub> , 1 kΩ impedance
Output	10 MHz, 2 V <sub>pp</sub> sine into 50 Ω

**External Trigger**

Rate	DC to 1/(100 ns + longest delay) (maximum of 10 MHz)
Threshold	±3.50 VDC
Slope	Trigger on rising or falling edge
Impedance	1 MΩ + 15 pF

**Internal Rate Generator**

Trigger modes	Continuous, line or single shot
Rate	100 μHz to 10 MHz
Resolution	1 μHz
Accuracy	Same as timebase
Jitter (rms)	<25 ps (10 MHz/N trigger rate) <100 ps (other trigger rates)

**Burst Generator**

Trigger to first T <sub>0</sub>	
Range	0 to 2000 s
Resolution	5 ps
Period between pulses	
Range	100 ns to 42.9 s
Resolution	10 ns
Delay cycles per burst	1 to 2 <sup>32</sup> - 1

**Outputs (T<sub>0</sub>, AB, CD, EF, and GH)**

Source impedance	50 Ω
Transition time	<2 ns
Overshoot	<100 mV + 10 % of pulse amplitude
Offset	±2 V
Amplitude	0.5 to 5.0 V (level + offset <6.0 V)
Accuracy	100 mV + 5 % of pulse amplitude

**General**

Computer interfaces	GPIB (IEEE-488.2), RS-232, and Ethernet. All instrument functions can be controlled through the interfaces.
Non-volatile memory	Nine sets of instrument configurations can be stored and recalled.
Power	<100 W, 90 to 264 VAC, 47 Hz to 63 Hz
Dimensions	8.5" × 3.5" × 13" (WHD)
Weight	9 lbs.
Warranty	One year parts and labor on defects in materials & workmanship

**Output Options**

**Option 01 (8 Delay Outputs on Rear Panel)**

Outputs (BNC)	T <sub>0</sub> , A, B, C, D, E, F, G and H
Source impedance	50 Ω
Transition time	<1 ns
Overshoot	<100 mV
Level	+5 V CMOS logic
Pulse characteristics	
Rising edge	At programmed delay
Falling edge	25 ns after longest delay

**Option 02 (8 High-Voltage Delay Outputs on Rear Panel)**

Outputs (BNC)	T <sub>0</sub> , A, B, C, D, E, F, G and H
Source impedance	50 Ω
Transition time	<5 ns
Levels	0 to 30 V into high impedance 0 to 15 V into 50 Ω (amplitude decreases by 1%/kHz)
Pulse Characteristics	
Rising Edge	At programmed delay
Falling Edge	100 ns after the rising edge

**Option 03 (Combinatorial Outputs on Rear Panel)**

Outputs (BNC)	T <sub>0</sub> , AB, CD, EF, GH, (AB+CD), (EF+GH), (AB+CD+EF), (AB+CD+EF+GH)
Source impedance	50 Ω
Transition time	<1 ns
Overshoot	<100 mV + 10 % of pulse amplitude
Pulse characteristics	
T <sub>0</sub> , AB, CD, EF, GH	Logic high for time between delays
(AB+CD), (EF+GH)	Two pulses created by the logic OR of the given channels
(AB+CD+EF)	Three pulses created by the logic OR of the given channels
(AB+CD+EF+GH)	Four pulses created by the logic OR of the given channels

**Option SRD1 (Fast Rise Time Module)**

Rise time	<100 ps
Fall time	<3 ns
Offset	0.8 V to 1.1 V
Amplitude	0.5 V to 5.0 V
Load	50 Ω

# **Appendix C**

## **Manual Analysis Mode Options**

**Table C.1** – Manual Analysis Mode Options

<b>Mode</b>	<b>Display Type</b>	<b>Description</b>
Waveform Comparison	Plot	Allows for the direct visual comparison of any waveforms generated from the same pulse set
Waveform Statistics	Report	A summary of the waveform analysis results including data uncertainties
Linearity	Plot	Shows the gain as a function of the pulse voltage, overlays the best-fit simple linear regression line, and prints the function and R value generated from the fitting
Gain Histogram	Histogram	Displays the average gain for each selected channel
Y-Intercept Histogram	Histogram	Displays the y-intercept value from the simple linear regression analysis (can be used to check for correlations between groupings)
Cross Talk Higher	Plot	Shows the cross talk between a channel and the higher-numbered neighbor channel on the same side of the preamp
Cross Talk Lower	Plot	Shows the cross talk between a channel and the lower-numbered neighbor channel on the same side of the preamp
Cross Talk Over	Plot	Shows the cross talk between a channel and the channel physically located on the opposite side of the preamp card
Cross Talk on a Channel	Plot	Shows the cross talk the selected channel exhibits by pulses on another bank
Saturation Points*	Histogram	Shows the saturation point, if any, based on the detection algorithm of the simple linear regression analysis
Timestamp Consistency by Single Pulse	Report	Prints the consistency of the timestamps collected from a single pulse set
Timestamp Consistency by Phase	Report	Prints the average consistency of all timestamps collected from all the pulse sets during a complete phase
Pedestals	Histogram	Displays the average pedestal values
Pedestal Widths	Histogram	Displays the uncertainty associated with the average pedestal values

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<b>Mode</b>	<b>Display Type</b>	<b>Description</b>
Calculated Pedestal Widths	Histogram	Displays the corrected pedestal uncertainties based on system characterization
Pedestals vs. Test	Plot	Shows the trend of the pedestal values as a function of the test and phases
Slope Comparison	Histogram	Displays the slope values from the simple linear regression analysis

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\*Not implemented, i.e. doesn't display anything, due to a decision to keep the pulse voltages within the preamp and ADC dynamic range

# Appendix D

## Source Code Information

This document references the source in committed revision 3721 of the `svn` repository located at `nuclear.calpoly.edu/home/niffte/SVN/trunk`

**Table D.1 – Notable EtherDaqGUI Revisions**

<b>Revision</b>	<b>Significance</b>
1575	First commit
1622	Software-based waveform simulation
1674	Waveform viewer
1721	Image saving
1781	Major bug fixes
2013	Ability to disconnect Ethernet interface
2252	ArbStudio interface
2262	Waveform customizer
3721	Current version

**Table D.2 – Notable Preana Revisions**

<b>Revision</b>	<b>Significance</b>
2166	First commit
2176	Interface windows singleton for Windows API
2210	Minuit2 and waveform fitting
2578	Thread manager template
2614	Data browser toolbar
2681	Event-based threaded framework
2930	Histogram class
2975	Test and analysis multiselect capability
3098	Dynamic font sizing
3163	Image saving
3721	Current version

# Appendix E

## Cross Talk Data

The data contained herein is extracted from the .ana files generated by EtherDaq-GUI. Thus, the parameter uncertainties are inherently much larger than those produced by a more robust analysis in Preana.

**Table E.1** – Cross Talk Data: Bank AB, EtherDAQ ID BEAC02

Channel	Preamp ID									
	0100-0034	0110-0006	0110-0030	0110-0042	0110-0049	0400-0009	0400-0017	0400-0021	0400-0036	0400-0047
1	2634.615	3246.779	3167.003	3180.517	3202.968	3504.023	159.942	3359.884	3577.953	3313.133
2	10.093	10.876	9.164	10.360	9.716	9.640	16.998	10.044	10.140	9.642
3	8.220	8.379	7.910	7.713	8.572	7.819	35.258	8.219	7.272	7.436
4	102.974	102.141	99.579	103.590	99.339	102.115	103.424	101.760	102.672	100.105
5	166.475	167.573	164.524	167.531	162.440	162.924	165.625	165.995	160.857	163.788
6	3205.246	100.092	3165.172	3177.021	3250.730	3259.573	3153.961	3127.715	3161.655	3176.045
7	10.303	10.507	9.232	9.641	9.723	10.764	4.309	9.602	9.373	10.504
8	11.835	12.276	11.025	12.197	12.331	12.838	12.575	12.198	12.387	11.102
9	3162.830	3191.463	3371.791	3170.876	3183.353	3105.175	3214.566	3050.363	3150.405	3231.862
10	10.398	9.989	10.631	10.163	10.311	10.538	10.348	9.891	11.625	10.055
11	13.068	12.581	12.267	12.557	11.657	12.989	11.918	12.625	0.000	11.823
12	44.246	44.552	49.402	45.774	43.600	44.197	44.798	46.056	44.555	44.485
13	105.440	109.404	110.138	106.940	116.185	93.856	116.195	109.503	103.650	105.038
14	3268.438	3317.357	3194.293	3300.715	3166.217	3454.954	3572.378	3482.743	3236.183	3171.912
15	15.258	15.942	14.744	19.607	16.017	5.982	15.666	15.945	16.774	16.535
16	9.739	9.229	9.253	8.727	9.249	10.354	8.622	8.896	10.603	8.970
17	3257.520	3221.677	3129.174	0.077	3156.860	3250.374	3271.430	3221.458	3030.602	3169.709
18	7.111	6.963	6.826	6.797	6.881	7.236	6.845	6.791	6.830	6.573
19	2.617	2.023	2.825	5.975	2.433	2.258	1.853	2.524	2.385	1.372
20	8.867	8.684	7.886	7.816	8.404	13.429	7.870	8.477	8.441	8.529
21	0.191	2.964	5.298	3.675	3.375	0.748	0.105	2.947	2.928	2.830
22	3417.741	3220.346	3213.666	3175.147	3062.709	2478.502	3159.598	3259.005	3185.102	3211.566
23	3.481	40.233	84.011	45.585	40.539	3.581	41.026	39.747	40.242	39.727
24	25.079	24.394	30.654	1.386	24.489	31.833	23.852	24.933	24.625	24.535
25	3175.019	3086.971	0.019	3115.183	3363.304	3178.590	3223.833	3151.377	3192.682	3111.058
26	9.250	9.104	19.404	9.508	9.720	9.418	10.148	9.864	10.297	9.023
27	9.083	8.940	58.572	9.052	9.190	9.241	9.760	9.111	9.396	9.804
28	135.446	135.862	138.723	135.105	0.228	139.492	135.268	134.168	140.122	136.908
29	39.639	39.706	-0.141	37.235	39.102	37.644	11.102	39.436	39.680	39.622
30	3157.945	2941.908	2862.659	2938.223	2936.102	2977.334	2977.802	2970.923	2937.256	2872.906
31	3.046	2.794	4.582	3.011	3.352	-0.022	0.017	2.972	3.016	2.667
32	8.275	8.713	7.867	1.721	8.283	8.771	9.502	9.279	8.620	9.129

**Table E.2 – Cross Talk Data: Bank AB, EtherDAQ ID 1242LC82**

Channel	Preamp ID									
	0100-0034	0110-0006	0110-0030	0110-0042	0110-0049	0400-0009	0400-0017	0400-0021	0400-0036	0400-0047
1	2 657.898	3 253.502	3 172.892	3 185.829	3 210.834	3 510.929	152.885	3 366.517	3 584.643	3 319.244
2	9.805	11.252	9.415	10.486	10.139	9.611	17.212	10.437	10.167	9.944
3	8.351	8.509	8.171	7.519	8.984	7.813	35.500	8.167	7.323	7.380
4	103.588	102.039	99.645	102.980	99.410	102.453	103.917	101.863	102.977	100.295
5	166.644	167.611	163.712	166.424	162.621	163.013	165.868	166.248	160.893	163.767
6	3 208.442	838.754	3 169.975	3 181.391	3 256.024	3 263.936	3 157.643	3 130.917	3 165.484	3 179.529
7	10.488	10.657	9.671	9.641	10.046	10.747	4.266	10.005	9.396	10.499
8	11.956	12.775	11.264	12.276	12.573	12.878	12.653	12.654	12.537	11.254
9	3 145.300	3 174.934	3 354.272	3 153.561	3 166.883	3 088.080	3 196.655	3 033.658	3 132.781	3 213.587
10	9.834	9.757	10.610	10.193	10.451	10.550	10.073	9.805	10.945	9.925
11	13.111	12.214	12.000	12.237	11.488	13.216	11.654	12.691	0.000	11.591
12	43.625	44.076	48.348	44.433	43.049	44.226	44.410	45.455	43.502	43.586
13	106.358	108.707	105.647	104.493	115.629	96.232	114.980	108.466	103.016	103.638
14	3 241.341	3 290.872	3 168.857	3 273.550	3 141.227	3 426.619	3 542.499	3 454.331	3 209.495	3 145.463
15	14.909	15.626	14.668	19.399	15.937	6.570	15.751	15.669	16.058	16.180
16	9.523	8.918	9.099	8.366	9.323	10.208	8.456	8.846	10.093	8.884
17	3 286.107	3 251.267	3 157.076	-0.025	3 186.149	3 281.104	3 300.818	3 250.481	3 057.617	3 198.044
18	6.969	6.821	7.012	6.577	6.788	7.713	7.143	7.101	6.995	7.141
19	2.778	1.721	3.107	6.118	2.568	2.977	2.048	2.511	2.514	1.835
20	8.851	8.472	8.295	7.687	8.276	13.436	8.350	8.698	8.552	9.004
21	0.060	2.829	5.416	3.588	3.218	0.909	0.005	2.852	3.000	3.158
22	3 449.612	3 252.626	3 245.874	3 206.596	3 093.677	2 547.770	3 190.468	3 290.467	3 215.822	3 242.390
23	3.524	40.255	83.658	44.617	40.618	3.828	41.666	40.361	40.569	39.843
24	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000
25	3 170.607	3 084.613	0.002	3 111.693	3 360.142	3 175.267	3 218.368	3 148.517	3 188.600	3 106.831
26	9.189	9.259	19.509	9.402	9.672	9.624	9.646	9.492	10.306	9.075
27	9.212	8.640	58.563	9.065	9.264	9.227	9.391	9.029	9.511	9.750
28	135.455	135.502	138.672	134.455	0.380	138.490	135.636	134.048	139.788	136.627
29	38.820	39.735	-0.129	37.309	39.091	38.531	12.165	39.113	39.576	39.451
30	3 153.123	2 938.660	2 860.240	2 935.470	2 933.068	2 973.706	2 974.055	2 967.886	2 933.126	2 868.412
31	3.164	2.977	4.631	2.975	3.307	-0.051	0.111	3.115	3.112	2.984
32	8.268	8.336	8.599	1.706	8.474	8.853	8.814	8.673	9.287	8.294

**Table E.3 – Cross Talk Data: Bank CD, EtherDAQ ID BEAC02**

Channel	Preamp ID									
	0100-0034	0110-0006	0110-0030	0110-0042	0110-0049	0400-0009	0400-0017	0400-0021	0400-0036	0400-0047
1	0.000	180.745	172.981	173.723	177.941	194.795	22.113	186.697	199.091	184.050
2	3 103.648	3 218.613	3 053.520	3 271.354	3 178.635	3 063.400	3 077.155	3 191.162	3 254.966	3 100.046
3	14.718	14.158	15.008	14.221	16.363	16.051	15.335	14.565	14.521	14.540
4	6.253	5.774	6.185	5.784	5.601	5.809	6.201	6.538	6.295	6.128
5	3 180.004	3 177.820	3 128.640	3 184.923	3 104.012	3 117.490	3 132.954	3 177.858	3 075.423	3 130.841
6	4.807	2.128	4.519	4.648	4.742	4.440	4.328	4.363	4.515	4.496
7	13.845	13.549	13.171	13.575	13.561	13.792	5.224	12.634	13.145	13.765
8	69.325	64.715	66.361	66.611	67.432	68.361	67.561	66.624	66.495	64.907
9	87.914	88.001	93.540	87.755	87.961	85.684	88.864	84.350	87.177	89.472
10	3 107.507	3 100.293	3 368.680	3 161.494	3 232.110	3 183.998	3 257.353	3 111.767	3 402.300	3 188.978
11	11.931	11.802	10.853	11.821	10.415	11.245	10.508	10.487	0.000	11.570
12	6.142	5.651	6.487	5.559	4.982	5.472	5.626	6.399	5.238	5.630
13	3 193.159	3 299.381	3 195.607	3 151.250	3 502.268	3 232.617	3 505.778	3 298.458	3 125.986	3 172.843
14	3.430	3.484	3.177	3.354	3.005	3.403	3.406	3.576	3.301	3.005
15	10.219	10.366	10.351	10.672	9.741	3.733	11.096	9.685	10.989	11.089
16	4.385	4.106	4.300	3.904	4.323	4.936	3.091	3.693	3.965	4.166
17	122.193	120.294	116.848	0.228	117.398	113.718	122.585	120.154	113.048	118.409
18	3 166.521	3 261.697	3 282.400	3 246.543	3 238.038	3 345.598	3 242.810	3 322.873	3 256.501	3 229.639
19	19.595	15.966	15.100	15.137	14.820	22.596	32.515	15.673	15.761	14.731
20	21.278	20.870	22.371	21.212	20.060	24.601	27.286	20.867	20.516	21.055
21	0.118	3 223.755	3 246.605	3 218.083	3 584.481	2 162.775	4.756	3 140.701	3 207.929	3 280.294
22	84.809	79.664	81.894	80.635	76.450	10.542	87.764	81.363	78.933	80.245
23	1.154	10.109	12.249	11.113	10.735	1.929	37.875	10.064	10.165	10.575
24	8.408	7.831	8.793	0.351	8.838	8.658	8.433	9.079	8.346	8.750
25	19.205	17.794	-0.114	18.034	19.314	19.233	17.907	18.632	18.283	17.937
26	3 360.736	3 380.259	3 423.895	3 370.154	3 382.651	3 428.027	3 478.645	3 427.509	3 682.412	3 311.663
27	188.073	182.877	257.082	186.910	194.121	185.847	227.829	189.856	179.797	201.756
28	5.542	5.203	13.497	5.164	1.654	4.444	11.474	5.011	4.979	4.739
29	2 872.377	2 952.004	-0.957	3 159.496	3 086.466	3 222.277	202.515	2 971.752	3 060.761	2 877.592
30	3.499	2.970	14.202	2.857	2.975	2.788	12.848	3.227	2.702	2.876
31	6.577	6.308	77.730	6.503	7.420	0.147	0.123	6.353	6.128	6.445
32	1.708	1.770	1.334	-0.161	1.667	1.910	2.381	1.987	1.935	1.340

**Table E.4 – Cross Talk Data: Bank CD, EtherDAQ ID 1242LC82**

Channel	Preamp ID									
	0100-0034	0110-0006	0110-0030	0110-0042	0110-0049	0400-0009	0400-0017	0400-0021	0400-0036	0400-0047
1	0.000	180.728	176.427	177.040	178.462	195.076	8.799	187.276	199.133	184.592
2	3 108.339	3 224.319	3 058.221	3 276.969	3 185.125	3 068.312	3 082.901	3 196.697	3 260.456	3 104.605
3	14.583	14.432	15.117	14.342	16.767	16.253	15.592	15.003	14.417	14.397
4	6.300	5.632	5.906	6.027	5.985	5.851	6.430	6.503	6.684	6.115
5	3 179.756	3 178.674	3 128.238	3 185.200	3 105.252	3 117.425	3 133.507	3 178.445	3 075.499	3 130.287
6	4.526	1.978	4.297	4.648	4.641	4.576	4.569	4.595	4.301	4.349
7	13.901	13.791	13.075	13.773	13.940	14.002	4.980	13.055	13.117	13.490
8	69.114	64.930	66.015	66.701	67.468	68.834	68.034	66.972	66.747	64.904
9	86.975	88.089	92.938	87.418	87.542	85.649	88.885	83.615	86.743	89.247
10	3 085.711	3 080.427	3 345.647	3 139.976	3 210.865	3 162.009	3 235.724	3 091.505	3 378.445	3 166.542
11	11.846	11.680	10.768	11.711	10.035	11.294	10.348	10.702	0.000	11.675
12	5.911	5.696	6.240	5.414	5.296	5.915	5.498	6.798	5.024	5.382
13	3 166.209	3 272.960	3 168.581	3 124.987	3 473.516	3 207.767	3 476.662	3 271.706	3 099.124	3 145.579
14	3.106	3.338	2.922	2.937	2.932	3.548	3.599	3.414	3.054	3.273
15	10.001	10.103	9.858	10.581	9.638	4.048	11.034	9.763	10.317	10.861
16	4.197	4.405	4.114	3.828	4.206	4.890	2.981	3.524	3.629	4.457
17	123.334	121.302	117.948	0.060	118.371	116.662	123.793	121.080	114.026	119.503
18	3 193.358	3 291.077	3 310.053	3 274.407	3 266.568	3 373.402	3 270.600	3 351.587	3 283.434	3 256.570
19	19.684	16.209	15.593	14.998	14.973	23.210	33.337	15.970	15.920	15.454
20	21.470	20.782	22.160	20.633	20.139	25.418	27.953	21.242	20.568	22.133
21	-0.005	3 260.290	3 276.155	3 248.509	3 624.277	2 232.914	4.725	3 175.311	3 242.405	3 315.263
22	86.610	80.079	81.235	80.300	76.210	10.892	89.104	81.829	80.056	81.180
23	1.129	10.282	12.420	11.333	10.774	1.930	38.145	10.011	10.212	10.827
24	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000
25	19.004	17.851	-0.189	17.666	19.374	19.731	17.145	18.263	18.895	17.942
26	3 353.317	3 374.226	3 416.427	3 363.130	3 376.252	3 420.865	3 471.861	3 421.922	3 675.134	3 304.491
27	186.847	182.196	255.375	185.311	194.046	186.016	226.918	189.743	179.402	201.332
28	5.450	4.859	12.987	5.036	1.528	4.423	11.170	5.137	5.006	4.848
29	3 307.070	2 890.376	-0.883	3 164.376	2 843.901	2 787.415	196.754	2 816.492	2 866.261	2 880.093
30	3.079	2.891	14.006	2.677	3.055	3.273	12.861	3.159	3.175	2.858
31	6.292	6.592	77.485	6.278	7.986	0.125	-0.059	6.601	6.558	6.234
32	2.054	2.142	2.084	-0.069	1.768	1.970	1.742	0.980	2.014	1.559

**Table E.5 – Cross Talk Data: Bank EF, EtherDAQ ID BEAC02**

Channel	Preamp ID									
	0100-0034	0110-0006	0110-0030	0110-0042	0110-0049	0400-0009	0400-0017	0400-0021	0400-0036	0400-0047
1	0.000	58.552	56.252	56.314	57.059	63.033	17.050	60.074	64.635	59.657
2	97.926	101.356	96.362	103.123	99.907	96.204	96.664	100.046	102.294	97.621
3	3 153.411	3 138.816	3 231.913	3 193.183	3 476.727	3 419.910	3 209.635	3 183.472	3 219.505	3 147.812
4	12.433	12.225	12.229	12.215	12.182	12.058	11.949	11.946	12.574	11.774
5	1.874	2.272	1.822	2.031	2.017	1.385	2.342	1.809	2.323	2.104
6	11.553	5.345	11.426	10.943	11.459	10.967	10.431	10.527	10.623	11.878
7	4.441	4.545	4.326	4.420	4.511	4.390	1.526	4.133	4.561	4.455
8	3 131.703	2 968.779	3 043.358	3 018.694	3 065.174	3 108.578	3 096.832	3 037.638	3 046.132	2 943.185
9	32.114	31.045	33.027	31.617	32.345	30.493	32.404	29.562	32.397	32.344
10	83.954	84.633	91.550	85.436	87.407	86.009	88.451	84.295	92.566	86.368
11	3 555.554	3 300.247	3 263.524	3 342.051	3 196.664	3 333.519	3 231.828	3 269.903	2 893.253	3 331.480
12	12.599	12.481	13.783	12.311	12.364	12.712	12.666	12.751	12.755	12.343
13	1.384	1.320	1.356	0.789	2.178	0.935	1.871	1.802	1.907	1.200
14	8.469	8.307	7.982	8.407	7.872	8.334	9.091	8.451	7.850	8.159
15	2.735	2.546	2.415	2.549	2.744	0.944	2.616	2.557	2.642	2.534
16	3 168.389	3 088.866	3 122.298	3 084.578	3 124.214	3 358.862	3 012.014	3 106.557	3 211.309	3 060.236
17	3.724	4.362	3.465	0.210	3.872	2.567	4.191	2.990	3.097	4.321
18	87.544	90.501	90.623	90.196	89.496	92.104	90.543	92.126	90.220	88.981
19	3 270.949	3 359.944	3 259.608	3 307.781	3 360.349	3 307.304	3 338.179	3 355.597	3 375.639	3 312.886
20	15.479	14.778	15.350	15.871	14.749	15.217	15.522	14.843	14.964	15.391
21	0.133	2.012	2.354	2.828	3.364	0.260	0.025	2.402	2.235	2.888
22	6.343	5.601	5.943	9.729	6.093	0.718	6.253	6.168	5.635	5.810
23	0.110	0.727	0.691	0.573	0.909	0.130	0.897	0.513	0.870	0.561
24	2 975.379	2 988.703	2 991.649	0.089	3 047.316	3 090.320	2 933.833	3 127.500	3 027.176	3 026.991
25	5.667	5.638	-0.017	5.368	6.439	5.821	3.955	5.949	4.893	5.536
26	15.735	16.133	15.453	18.557	15.464	15.806	16.480	15.692	16.867	15.010
27	3 080.799	2 993.742	3 084.583	3 059.856	3 190.969	3 048.956	2 924.649	3 106.334	2 961.304	3 302.555
28	68.251	68.134	69.641	71.212	-0.019	69.699	67.972	67.257	69.957	69.252
29	5.747	5.239	0.119	5.257	5.705	5.136	2.134	4.957	6.018	4.985
30	6.650	5.164	5.226	35.137	6.125	5.546	5.158	5.412	5.529	5.403
31	1.099	1.105	0.915	9.792	1.334	0.036	0.084	1.246	1.096	1.203
32	3 336.889	3 449.384	3 640.165	-11.625	3 406.865	3 390.829	3 468.277	3 473.185	3 481.640	3 365.268

**Table E.6 – Cross Talk Data: Bank EF, EtherDAQ ID 1242LC82**

Channel	Preamp ID									
	0100-0034	0110-0006	0110-0030	0110-0042	0110-0049	0400-0009	0400-0017	0400-0021	0400-0036	0400-0047
1	0.000	58.742	56.168	57.293	57.522	62.496	12.339	59.936	64.855	59.819
2	97.648	101.418	95.942	102.952	100.027	95.906	96.833	100.100	102.250	97.567
3	3 158.847	3 145.769	3 238.596	3 199.589	3 484.872	3 426.374	3 216.642	3 189.822	3 226.123	3 153.037
4	12.096	12.303	12.143	12.189	12.123	12.222	12.303	12.797	12.248	12.196
5	1.856	2.668	1.726	2.260	1.871	1.128	2.306	2.105	2.481	2.166
6	11.285	5.566	11.599	11.235	11.233	10.765	10.745	11.061	10.767	11.941
7	4.232	4.589	4.528	4.414	4.384	4.431	1.501	4.544	4.461	4.464
8	3 132.372	2 970.878	3 045.113	3 020.147	3 067.981	3 109.982	3 098.996	3 039.328	3 047.992	2 944.086
9	31.046	31.233	32.619	31.494	32.155	30.927	32.241	29.257	31.733	32.199
10	82.894	83.990	90.801	84.643	86.635	85.546	87.739	83.684	91.704	85.509
11	3 535.896	3 282.932	3 245.380	3 323.354	3 179.648	3 314.883	3 214.372	3 252.190	2 879.609	3 311.838
12	12.490	12.426	14.175	12.378	11.952	12.328	12.586	12.845	12.407	12.578
13	1.130	1.269	1.379	0.789	2.147	1.164	1.698	2.063	1.711	1.063
14	7.798	8.237	7.523	8.316	7.477	8.433	8.963	8.436	7.483	7.897
15	2.402	2.456	2.512	2.440	2.513	1.052	2.549	2.459	2.523	2.590
16	3 141.027	3 063.226	3 095.488	3 057.895	3 098.004	3 329.721	2 986.516	3 080.229	3 183.025	3 032.785
17	2.870	3.643	3.044	0.151	2.844	1.855	3.758	2.075	2.396	3.682
18	87.171	90.218	90.368	90.945	89.335	91.998	90.290	91.690	89.966	88.807
19	3 303.397	3 394.666	3 291.332	3 340.524	3 394.951	3 339.825	3 371.567	3 389.717	3 408.727	3 344.798
20	14.629	14.049	15.265	15.359	13.680	14.502	15.016	14.261	14.246	14.886
21	-0.626	1.165	1.828	2.730	2.299	-0.543	-0.627	1.650	1.689	2.235
22	5.487	5.006	5.395	9.763	5.171	-0.034	5.956	5.374	5.072	5.465
23	-0.737	-0.201	0.297	0.694	0.140	-0.693	0.247	-0.372	-0.245	-0.152
24	716.115	932.619	894.099	0.000	650.261	939.640	927.040	929.755	926.425	917.488
25	5.886	5.551	0.074	5.465	6.113	5.878	3.619	5.810	5.202	5.298
26	16.006	15.839	15.540	18.687	14.975	15.826	16.082	15.535	17.163	15.025
27	3 073.528	2 988.044	3 077.457	3 052.666	3 184.479	3 041.623	2 918.746	3 100.406	2 954.117	3 294.408
28	68.038	67.993	69.794	70.581	-0.057	68.973	67.799	67.080	69.027	68.401
29	5.634	5.203	-0.055	5.570	5.499	5.243	2.003	5.102	5.957	4.886
30	6.648	5.165	5.454	35.729	5.659	5.435	5.298	5.259	5.686	5.134
31	1.172	1.165	1.446	9.940	1.086	-0.046	0.012	1.223	1.336	1.009
32	3 337.035	3 448.145	3 645.171	-12.636	3 407.028	3 390.014	3 468.777	3 474.155	3 480.624	3 363.837

**Table E.7 – Cross Talk Data: Bank GH, EtherDAQ ID BEAC02**

Channel	Preamp ID									
	0100-0034	0110-0006	0110-0030	0110-0042	0110-0049	0400-0009	0400-0017	0400-0021	0400-0036	0400-0047
1	0.000	1.586	1.464	1.814	1.411	1.325	0.167	1.289	1.820	1.423
2	4.424	5.341	5.151	5.283	5.411	5.085	4.243	4.502	4.198	5.110
3	3.669	3.826	3.708	3.834	3.874	4.024	3.750	3.577	3.757	3.640
4	3 400.705	3 327.704	3 330.393	3 406.499	3 302.385	3 387.980	3 414.609	3 359.718	3 413.578	3 329.436
5	66.594	67.403	66.829	67.664	66.257	66.593	66.702	68.195	65.853	66.704
6	129.014	58.240	128.533	128.260	131.035	131.649	127.143	125.939	127.967	128.584
7	3 041.517	3 006.487	3 123.777	3 056.989	3 082.647	3 167.436	2 927.577	2 988.902	3 045.731	3 086.588
8	6.056	6.009	5.807	5.964	6.026	6.247	6.129	5.823	5.930	5.919
9	1.354	2.059	1.874	1.634	2.136	1.363	1.693	1.792	2.119	1.089
10	3.737	4.305	3.375	4.151	4.502	4.254	4.046	2.934	4.596	4.218
11	2.971	2.842	2.753	3.112	2.637	2.945	2.693	2.817	0.000	2.689
12	3 094.367	3 112.275	3 418.962	3 121.906	3 060.953	3 088.658	3 131.082	3 203.343	3 078.660	3 116.489
13	1.718	1.241	1.151	0.598	2.406	1.304	1.085	1.829	1.287	0.769
14	7.811	7.360	7.072	7.195	7.697	7.944	7.905	7.414	7.794	7.559
15	3 075.739	3 121.313	3 035.152	3 120.498	3 092.918	3 017.490	3 306.349	3 114.619	3 115.412	3 179.517
16	53.165	51.625	52.161	51.530	52.363	56.250	50.271	51.752	53.520	51.036
17	23.544	22.143	21.932	0.087	21.270	18.399	22.063	21.637	20.237	21.157
18	2.556	2.739	2.238	3.128	2.508	3.144	3.316	2.351	3.026	2.059
19	4.185	3.032	2.860	2.872	2.753	4.312	3.180	2.797	3.173	2.788
20	3 307.210	3 248.179	3 392.913	3 252.500	3 188.857	3 369.358	3 332.626	3 297.829	3 306.636	3 352.454
21	0.084	3.589	2.296	2.640	3.015	2.787	0.187	2.868	2.293	2.487
22	21.140	13.562	15.190	15.440	13.346	3.724	14.071	13.640	13.804	13.510
23	1 352.548	3 345.885	3 463.426	3 689.899	3 391.925	1 486.883	3 433.506	3 361.115	3 356.580	3 344.047
24	22.139	14.023	13.587	0.136	14.751	21.602	13.670	14.444	13.908	14.029
25	32.687	2.620	-0.129	2.447	3.341	31.647	3.365	3.243	2.191	3.498
26	2.755	2.323	2.648	2.769	5.939	3.397	3.509	2.648	2.452	2.484
27	3.035	0.764	1.417	0.893	0.728	7.826	7.437	1.261	0.839	0.850
28	3 234.303	3 228.420	3 296.862	3 205.800	-0.091	3 290.918	3 220.864	3 194.189	3 316.964	3 260.367
29	18.883	18.050	0.237	16.695	17.301	91.425	27.250	17.940	18.118	18.289
30	134.533	126.266	122.216	124.234	130.300	135.644	136.492	127.570	125.997	123.839
31	3 350.700	3 227.125	3 231.852	3 210.598	3 582.724	-1.175	-1.064	3 253.597	3 278.060	3 270.952
32	2.632	2.684	1.769	0.036	3.354	14.261	14.604	2.755	2.683	2.530

**Table E.8 – Cross Talk Data: Bank GH, EtherDAQ ID 1242LC82**

Channel	Preamp ID									
	0100-0034	0110-0006	0110-0030	0110-0042	0110-0049	0400-0009	0400-0017	0400-0021	0400-0036	0400-0047
1	0.000	1.613	1.706	1.415	1.582	0.832	0.293	1.685	1.754	1.452
2	4.218	5.515	5.017	5.569	5.725	4.978	4.163	5.012	4.497	5.113
3	3.573	3.660	3.941	3.831	4.311	3.695	3.796	3.859	3.688	3.473
4	3 405.654	3 333.088	3 334.350	3 412.983	3 307.260	3 393.255	3 419.795	3 364.517	3 418.093	3 333.304
5	67.057	67.273	67.250	67.330	66.675	66.496	66.994	67.984	65.729	66.662
6	129.338	59.278	128.541	128.226	131.744	132.016	127.612	126.001	127.916	128.720
7	3 046.007	3 011.798	3 128.276	3 062.925	3 087.768	3 172.524	2 929.195	2 993.393	3 050.591	3 090.844
8	5.995	6.038	5.809	5.988	6.228	5.994	6.073	6.124	5.979	5.665
9	1.467	2.073	1.870	1.828	2.231	1.564	1.839	1.738	1.905	1.194
10	3.600	3.947	3.028	4.101	4.510	4.484	3.804	2.876	4.551	4.140
11	3.105	2.770	2.620	2.919	2.924	3.147	2.646	2.730	0.000	2.723
12	3 071.256	3 090.223	3 393.973	3 100.040	3 038.871	3 066.206	3 108.119	3 180.302	3 054.795	3 091.982
13	2.017	1.151	1.262	0.982	2.400	1.342	0.963	1.868	1.084	0.722
14	7.780	7.307	7.018	7.081	7.626	8.203	7.816	7.020	7.486	7.658
15	3 057.189	3 103.699	3 016.915	3 102.801	3 074.725	3 006.548	3 286.888	3 096.484	3 096.088	3 159.296
16	52.711	51.127	51.667	50.909	52.036	55.604	49.945	51.389	53.088	50.501
17	23.800	22.064	22.350	0.045	21.168	19.681	23.015	22.061	20.679	21.667
18	2.661	2.530	2.256	2.919	2.587	3.874	3.665	2.607	3.125	2.618
19	4.441	2.914	2.935	2.839	2.591	4.665	3.626	2.762	2.911	3.054
20	3 333.649	3 274.698	3 419.838	3 278.892	3 214.172	3 395.932	3 360.197	3 324.267	3 331.898	3 377.891
21	0.025	3.187	2.066	2.919	2.696	2.645	0.153	3.018	2.404	2.334
22	21.216	13.614	14.468	14.471	13.411	4.094	14.891	13.903	13.873	14.021
23	1 464.651	3 377.717	3 492.956	3 721.758	3 422.436	1 577.323	3 466.196	3 392.559	3 386.430	3 373.558
24	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000	0.000
25	31.250	2.444	0.002	2.365	3.149	30.672	3.179	2.634	2.411	3.235
26	2.560	2.411	2.564	2.824	6.231	3.114	3.151	2.224	2.449	2.522
27	2.878	0.851	1.151	0.877	0.857	7.710	6.938	0.839	0.801	0.986
28	3 226.153	3 221.532	3 288.515	3 198.706	0.070	3 282.325	3 213.398	3 187.117	3 308.305	3 251.509
29	18.616	17.826	0.264	16.824	17.584	91.416	28.069	17.621	18.347	18.200
30	134.620	126.141	123.501	125.040	130.592	135.476	136.247	127.338	125.716	123.241
31	3 344.929	3 222.880	3 226.365	3 206.577	3 575.997	-1.076	-1.200	3 249.211	3 272.002	3 264.636
32	2.906	2.693	2.886	0.091	3.617	14.607	14.499	3.023	3.152	2.642

**Table E.9 – Cross Talk Data: Aggregate Statistics**

Channel	Bank AB			Bank CD			Bank EF			Bank GH		
	Mean	Std. Dev.	Relative									
1	3 325.550	153.250	5.000%	184.300	8.700	5.000%	59.530	2.890	5.000%	1.510	0.250	16.000%
2	10.140	0.550	5.000%	3 153.920	79.500	3.000%	99.110	2.510	3.000%	4.930	0.500	10.000%
3	8.020	0.560	7.000%	15.020	0.790	5.000%	3 240.700	113.330	3.000%	3.770	0.180	5.000%
4	101.920	1.610	2.000%	6.100	0.310	5.000%	12.210	0.220	2.000%	3 369.770	41.400	1.000%
5	164.680	2.170	1.000%	3 141.110	36.590	1.000%	2.030	0.360	18.000%	66.910	0.630	1.000%
6	3 190.370	44.560	1.000%	4.520	0.150	3.000%	11.140	0.450	4.000%	128.790	1.800	1.000%
7	10.130	0.490	5.000%	13.510	0.390	3.000%	4.430	0.120	3.000%	3 055.050	67.100	2.000%
8	12.280	0.600	5.000%	66.910	1.400	2.000%	3 046.850	57.650	2.000%	5.990	0.140	2.000%
9	3 165.970	84.330	3.000%	87.890	2.380	3.000%	31.610	1.000	3.000%	1.740	0.320	18.000%
10	10.210	0.410	4.000%	3 200.570	103.000	3.000%	86.690	2.920	3.000%	3.960	0.540	14.000%
11	12.240	0.640	5.000%	11.150	0.630	6.000%	3 304.740	100.080	3.000%	2.840	0.170	6.000%
12	44.470	1.520	3.000%	5.720	0.490	9.000%	12.650	0.500	4.000%	3 131.120	102.060	3.000%
13	106.720	5.720	5.000%	3 254.220	133.400	4.000%	1.460	0.440	30.000%	1.360	0.520	38.000%
14	3 289.430	139.940	4.000%	3.260	0.230	7.000%	8.170	0.440	5.000%	7.540	0.340	5.000%
15	16.020	1.360	9.000%	10.350	0.510	5.000%	2.540	0.100	4.000%	3 108.980	78.430	3.000%
16	9.170	0.620	7.000%	4.060	0.500	12.000%	3 120.260	94.300	3.000%	52.130	1.610	3.000%
17	3 218.740	77.850	2.000%	118.930	3.260	3.000%	3.260	0.750	23.000%	21.600	1.310	6.000%
18	7.030	0.300	4.000%	3 273.180	50.800	2.000%	90.160	1.350	1.000%	2.800	0.470	17.000%
19	2.820	1.250	44.000%	16.740	2.650	16.000%	3 341.390	42.490	1.000%	3.230	0.640	20.000%
20	8.960	1.610	18.000%	22.130	2.320	10.000%	14.900	0.560	4.000%	3 318.000	61.820	2.000%
21	3.440	0.910	26.000%	3 288.860	140.840	4.000%	2.260	0.580	26.000%	2.700	0.390	15.000%
22	3 243.060	94.980	3.000%	81.580	3.480	4.000%	6.130	1.380	22.000%	14.870	2.370	16.000%
23	41.130	1.630	4.000%	10.780	0.780	7.000%	0.530	0.290	56.000%	3 438.750	113.480	3.000%
24	—	—	—	—	0.360	4.000%	3 023.210	59.640	2.000%	15.790	3.470	22.000%
25	3 173.850	82.060	3.000%	18.460	0.730	4.000%	5.450	0.700	13.000%	2.870	0.460	16.000%
26	9.520	0.360	4.000%	3 421.180	98.930	3.000%	16.090	1.030	6.000%	2.710	0.360	13.000%
27	9.230	0.310	3.000%	199.070	23.650	12.000%	3 071.960	107.160	3.000%	1.190	0.720	60.000%
28	136.520	2.020	1.000%	4.990	0.320	6.000%	68.840	1.140	2.000%	3 245.900	42.020	1.000%
29	38.950	0.770	2.000%	2 984.920	160.330	5.000%	5.380	0.360	7.000%	19.100	3.400	18.000%
30	2 953.770	80.420	3.000%	3.000	0.220	7.000%	5.550	0.470	8.000%	128.750	5.000	4.000%
31	3.280	0.560	17.000%	6.590	0.510	8.000%	1.170	0.140	12.000%	3 298.010	117.410	4.000%
32	8.620	0.330	4.000%	1.850	0.280	15.000%	3 445.960	87.000	3.000%	2.810	0.430	15.000%

**Table E.10 – Cross Talk Data: Modified Board Results**

Channel	Bank AB	Bank CD	Bank EF	Bank GH
1	3 241.826	40.201	7.845	1.000
2	9.625	3 214.404	18.705	3.552
3	5.331	19.042	3 493.259	2.090
4	13.185	7.540	24.160	3 310.190
5	15.777	3 134.993	8.294	6.556
6	3 280.738	3.159	10.955	15.331
7	14.676	7.768	1.517	3 095.440
8	15.941	6.096	3 065.624	21.328
9	3 202.793	17.761	5.619	9.554
10	9.847	3 265.013	18.734	5.331
11	4.446	20.237	3 203.013	1.174
12	16.568	7.984	32.645	3 063.196
13	49.316	3 516.598	6.722	4.744
14	3 161.708	2.520	8.872	14.219
15	10.796	7.715	2.010	3 104.320
16	9.734	1.348	3 136.324	16.591
17	3 179.260	17.079	4.164	8.314
18	7.795	3 256.037	13.742	3.150
19	1.738	23.824	3 352.600	0.841
20	9.596	7.447	21.840	3 188.090
21	9.415	3 476.768	4.522	5.369
22	3 072.912	2.370	7.403	22.507
23	10.765	7.010	0.935	3 370.507
24	15.379	7.999	3 052.505	17.382
25	3 360.186	25.524	6.969	4.670
26	8.142	3 342.201	18.971	6.531
27	5.215	27.440	3 212.986	0.804
28	0.083	1.740	-0.363	-0.119
29	26.099	3 295.390	6.568	9.184
30	2 968.426	2.725	7.283	29.576
31	5.334	5.782	0.883	3 589.614
32	10.674	2.009	3 414.933	7.278

# **Appendix F**

## **Cross Talk Deconvolution**

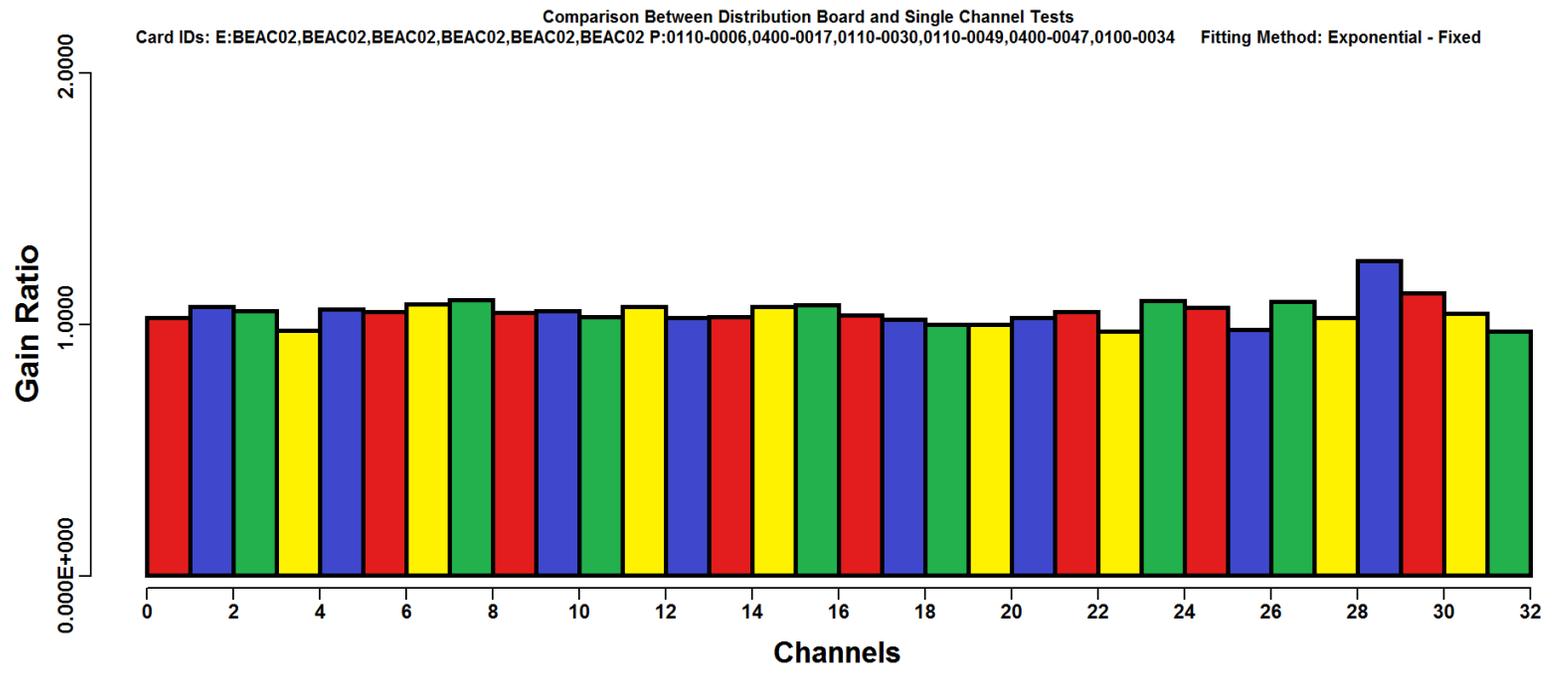


Figure F.1 – Generated Deconvolution Matrix

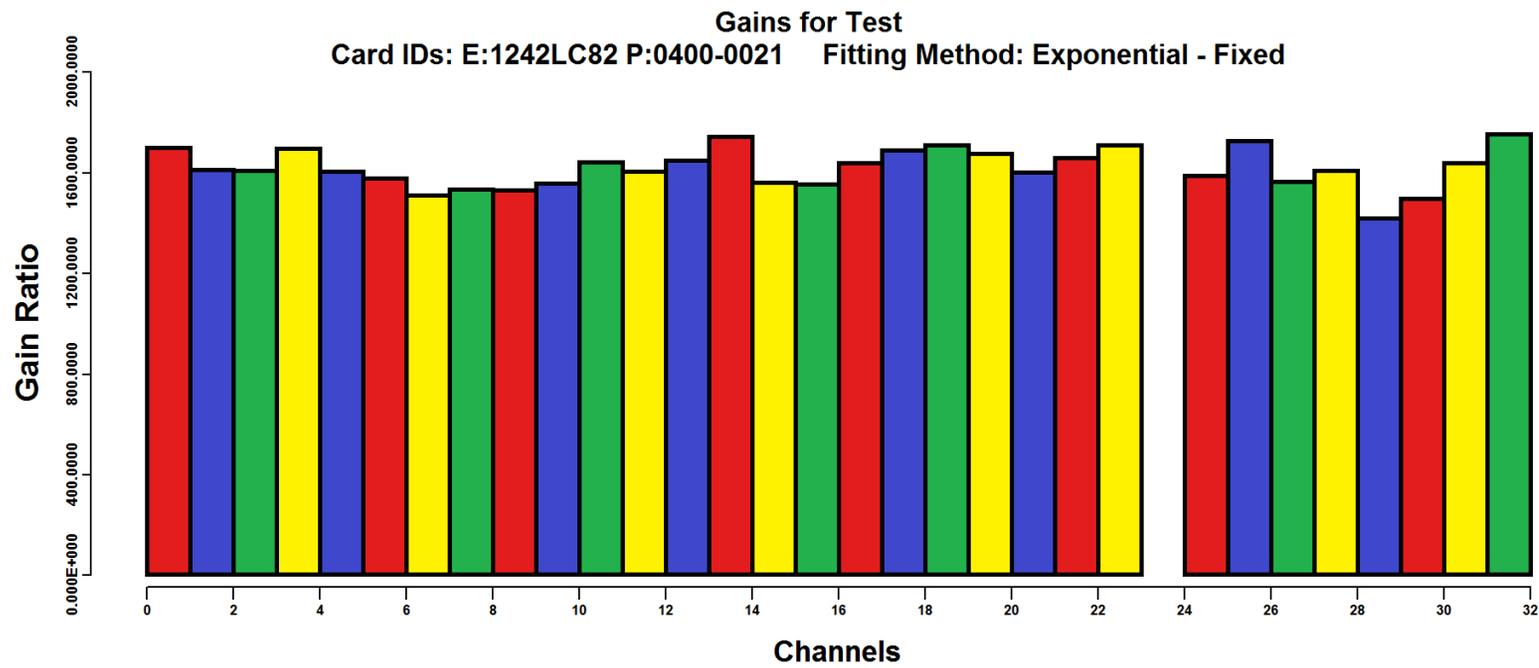


Figure F.2 – Distribution Test Results

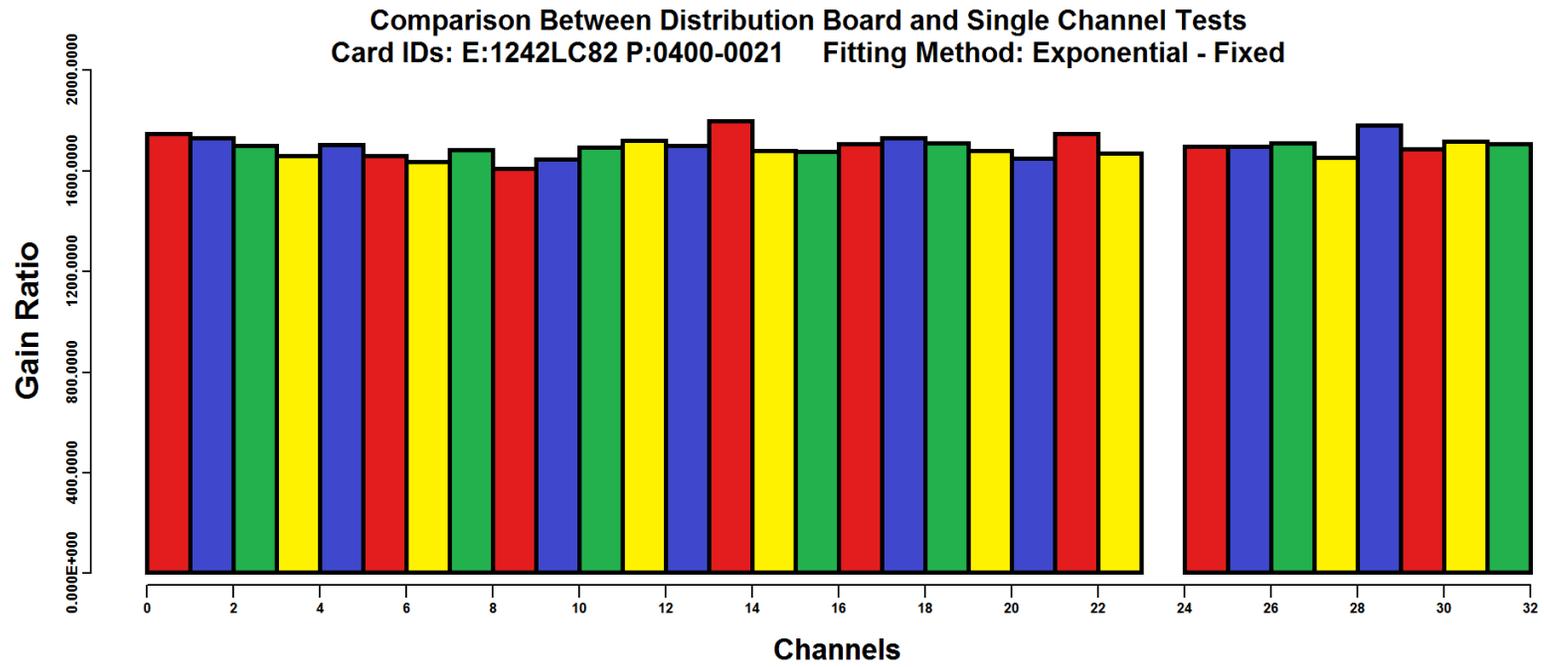


Figure E.3 – Predicted Single Channel Test Results

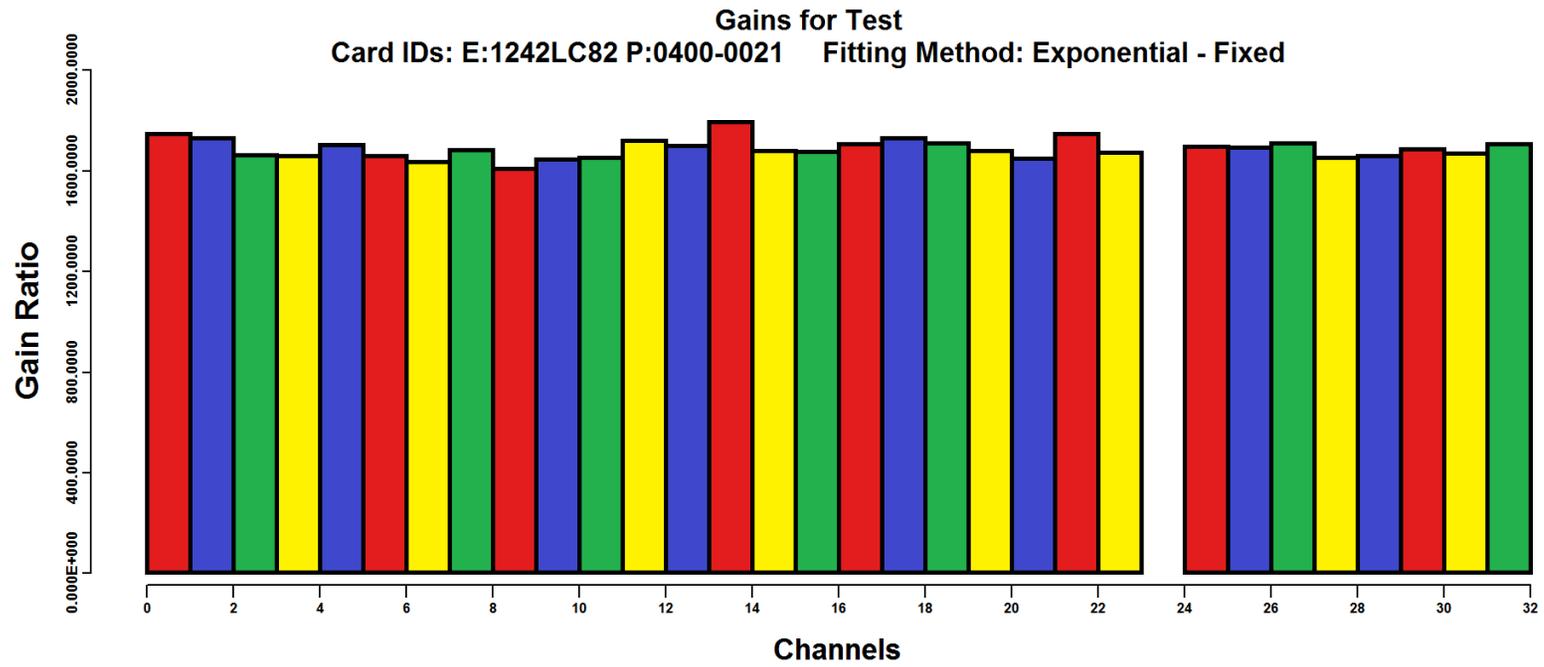


Figure F.4 – Actual Single Channel Test Results



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